

Excalibur Low-Noise High-Speed Precision Operational Amplifiers

1 Features

- Low noise
 - 10Hz . . . $15\text{nV}/\sqrt{\text{Hz}}$
 - 1kHz . . . $10.5\text{nV}/\sqrt{\text{Hz}}$
- Load capability: 10000pF
- Short-circuit output current: 20mA (minimum)
- Slew rate: 27V/ μs (minimum)
- High gain-bandwidth product: 5.9MHz
- Low V_{IO} : 500 μV maximum at 25°C
- Single or split supply: 4V to 44V
- Fast settling time:
 - 340ns to 0.1%
 - 400ns to 0.01%
- Saturation recovery: 150ns
- Large output swing:
 - $V_{\text{CC-}} + 0.1\text{V}$ to $V_{\text{CC+}} - 1\text{V}$

2 Applications

- EV charging infrastructure
- Industrial AC-DC
- Fire alarm control panel (FACP)
- String inverter

3 Description

The TLE214x and TLE214xA devices are high-performance, internally compensated operational amplifiers built using Texas Instruments complementary bipolar Excalibur process. The TLE214xA is a tighter offset voltage grade of the TLE214x. Both are pin-compatible upgrades to standard industry products.

The design incorporates an input stage that simultaneously achieves low audio-band noise of $10.5\text{nV}/\sqrt{\text{Hz}}$ with a 10Hz 1/f corner and symmetrical 40V/ μs slew rate typically with loads up to 800pF. The resulting low distortion and high power bandwidth are important in high-fidelity audio applications. A fast settling time of 430ns to 0.1% of a 10V step with a 2k Ω /100pF load is useful in fast actuator/positioning drivers. Under similar test conditions, settling time to 0.01% is 640ns.

Both versions can also be used as comparators. Differential inputs of $V_{\text{CC}\pm}$ can be maintained without damage to the device. Open-loop propagation delay with TTL supply levels is typically 200ns. This gives a good indication as to output stage saturation recovery when the device is driven beyond the limits of recommended output swing.

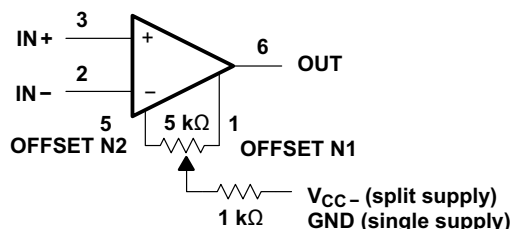
Both the TLE214x and TLE214xA are available in a wide variety of packages, including both the industry-standard 8-pin small-outline version and chip form for high-density system applications. The C-suffix devices are characterized for operation from 0°C to 70°C, I-suffix devices from -40°C to 105°C, and M-suffix devices over the full military temperature range of -55°C to 125°C.

Package Information

PART NUMBER	PACKAGE ⁽¹⁾	PACKAGE SIZE ⁽²⁾
TLE2141, TLE2141A	P (PDIP, 8)	9.81mm × 9.43mm
	D (SOIC, 8)	4.9mm × 6mm
TLE2142	P (PDIP, 8)	9.81mm × 9.43mm
	D (SOIC, 8)	4.9mm × 6mm
	PW (TSSOP, 16)	5mm × 6.4mm
TLE2142A	D (SOIC, 8)	4.9mm × 6mm
TLE2142AM	JG (CDIP, 8)	9.6mm × 6.67mm
	U (CFP, 10)	21.44mm × 6.5mm
	FK (LCCC, 20)	8.89mm × 8.89mm
TLE2142AM-D	D (SOIC, 8)	4.9mm × 6mm
TLE2142M	JG (CDIP, 8)	9.6mm × 6.67mm
	U (CFP, 10)	21.44mm × 6.5mm
	FK (LCCC, 20)	8.89mm × 8.89mm
TLE2142M-D	D (SOIC, 8)	4.9mm × 6mm
TLE2144	N (PDIP, 14)	19.3mm × 9.4mm
	DW (SOIC, 16)	10.3mm × 10.3mm
TLE2144A	N (PDIP, 14)	19.3mm × 9.4mm
TLE2144AM, TLE2144M	J (CDIP, 14)	19.56mm × 6.67mm
	FK (LCCC, 20)	8.89mm × 8.89mm
TLE2144M-D	DW (SOIC, 16)	10.3mm × 10.3mm

(1) For all available packages, see [Section 9](#).

(2) The package size (length × width) is a nominal value and includes pins, where applicable.



Input Offset Voltage Null Circuit

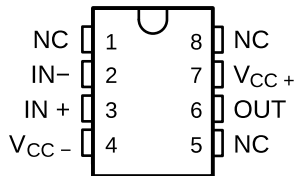


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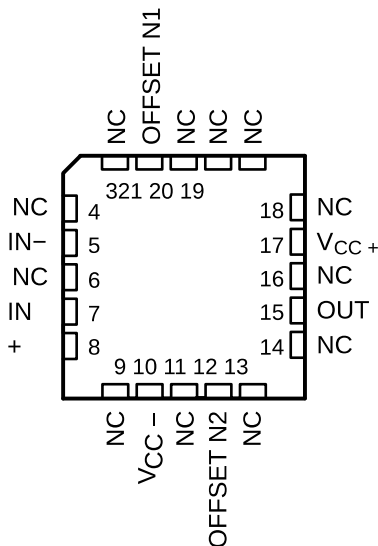
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4 Pin Configuration and Functions

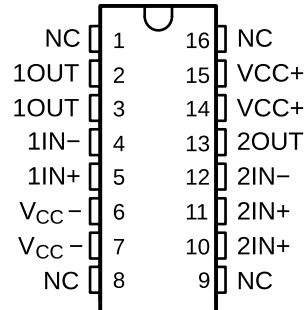
TLE2141
D, JG, OR P PACKAGE
(TOP VIEW)



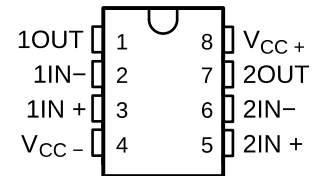
TLE2141
FK PACKAGE
(TOP VIEW)



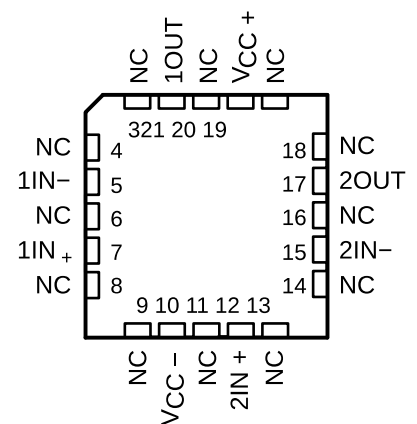
TLE2142
PW PACKAGE
(TOP VIEW)



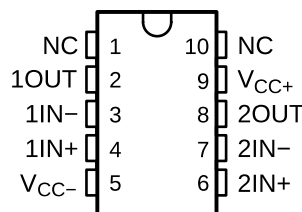
TLE2142
D, JG, OR P PACKAGE
(TOP VIEW)



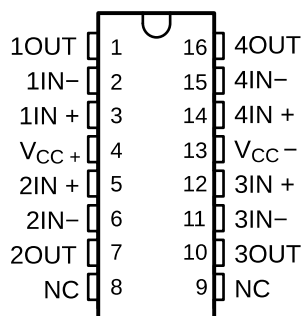
TLE2142
FK PACKAGE
(TOP VIEW)



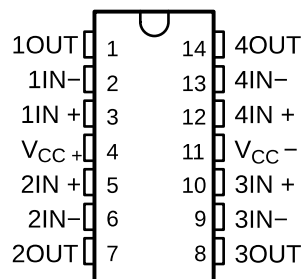
TLE2142
U PACKAGE
(TOP VIEW)



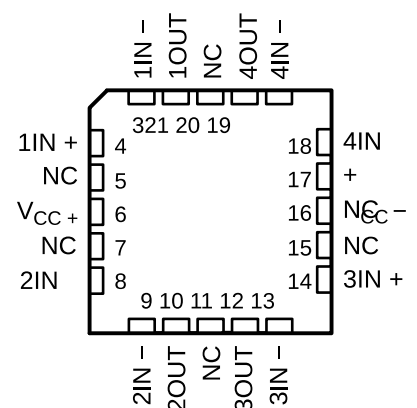
TLE2144
DW PACKAGE
(TOP VIEW)



TLE2144
J OR N PACKAGE
(TOP VIEW)



TLE2144
FK PACKAGE
(TOP VIEW)



NC – No internal connection

5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		VALUE	UNIT
V _{CC+}	Supply voltage ⁽²⁾	22	V
V _{CC-}	Supply voltage	–22	V
V _{ID}	Differential input voltage ⁽³⁾	±44	V
V _I	Input voltage range, (any input)	V _{CC+} to V _{CC-} –0.3	V
I _I	Input current (each input)	± 1	mA
I _O	Output current	± 80	mA
	Total current into V _{CC+}	80	mA
	Total current out of V _{CC-}	80	mA
Duration of short-circuit current at (or below) 25°C ⁽⁴⁾		Unlimited	
θ _{JA}	Package thermal impedance ^{(5) (6)}	D package	97.1
		DW package	57.3
		N package	79.7
		P package	84.6
		PW package	108.4
θ _{JC}	Package thermal impedance ^{(5) (6)}	FK package	5.6
		J package	15.1
		JG package	14.5
		U package	14.7
T _A	Operating free-air temperature range	C suffix	0 to 70
		I suffix	–40 TO 105
		M suffix	–55 TO 125
Storage temperature range		–65 TO 150	°C
Case temperature for 60 seconds: FK package		260	°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds: D, DW, N, P, or PW package		260	°C
Lead temperature 1,6 mm (1/16 inch) from case for 60 seconds: J or JG package		300	°C

- (1) Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values, except differential voltages, are with respect to the midpoint between V_{CC+} and V_{CC-}.
- (3) Differential voltages are at IN+ with respect to IN–. Excessive current flows, if input, are brought below V_{CC-} –0.3V.
- (4) The output may be shorted to either supply. Temperature and /or supply voltages must be limited to make sure that the maximum dissipation rating is not exceeded.
- (5) Maximum power dissipation is a function of T_{J(max)}, θ_{JA}, and T_A. The maximum allowable power dissipation at any allowable ambient temperature is P_D = (T_{J(max)} – T_A)/θ_{JA}. Operating at the absolute maximum T_J of 150°C can affect reliability.
- (6) The package thermal impedance is calculated in accordance with JESD 51-7 (plastic) or MIL-STD-883 Method 1012 (ceramic).

5.2 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

			C SUFFIX		I SUFFIX		M SUFFIX		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	
V _{CC±}	Supply voltage		±2	±22	±2	±22	±2	±22	V
V _{IC}	Common-mode input voltage	V _{CC} = 5V	0	2.9	0	2.7	0	2.7	V
		V _{CC±} = ± 15V	–15	12.9	–15	12.7	–15	12.7	
T _A	Operating free-air temperature		0	70	–40	105	–55	125	°C

5.3 TLE2141C Electrical Characteristics

at specified free-air temperature, $V_{CC} = 5V$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T _A ⁽¹⁾	TLE2141C			TLE2141AC			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
V _{IO}	Input offset voltage	V _O = 2.5V , R _S = 50Ω, V _{IC} = 2.5V	25°C	225	1400	200	1000	μV		
			Full range	1700			1300			
α _{VIO}	Temperature coefficient of input offset voltage		Full range	1.7			1.7	μV/°C		
I _{IO}	Input offset current		25°C	8	100	8	100	nA		
			Full range	150			150			
I _{IB}	Input bias current		25°C	−0.8	−2	−0.8	−2	μA		
		Full range	−2.1			−2.1				
V _{ICR}	Common-mode input voltage range	R _S = 50Ω	25°C	0 to 3	−0.3 to 3.2	0 to 3	−0.3 to 3.2	V		
			Full range	0 to 2.9		0 to 2.9		V		
V _{OH}	High-level output voltage	I _{OH} = −150μA	25°C	3.9	4.1	3.9	4.1	V		
			Full range	3.8			3.8			
		I _{OH} = −1.5mA	25°C	3.8	4	3.8	4	V		
			Full range	3.7			3.7			
		I _{OH} = −15mA	25°C	3.2	3.7	3.2	3.7	V		
			Full range	3.2			3.2			
V _{OL}	Low-level output voltage	I _{OL} = 150μA	25°C	75	125	75	125	mV		
			Full range	150			150			
		I _{OL} = 1.5mA	25°C	150	225	150	225			
			Full range	250			250			
		I _{OL} = 15mA	25°C	1.2	1.5	1.2	1.5	V		
			Full range	1.7			1.7			
A _{VD}	Large-signal differential voltage amplification	V _{CC} = ±2.5V , R _L = 2kΩ, V _O = 1V to −1.5V	25°C	50	220	50	220	V/mV		
			Full range	25			25			
r _i	Input resistance		25°C	70			70	MΩ		
c _i	Input capacitance		25°C	2.5			2.5	pF		
Z _O	Open-loop output impedance	f = 1MHz	25°C	30			30	Ω		
CMRR	Common-mode rejection ratio	V _{IC} = V _{ICRmin} , R _S = 50Ω	25°C	85	118	85	118	dB		
			Full range	80			80			
k _{SVR}	Supply-voltage rejection ratio (ΔV _{CC±} /ΔV _{IO})	V _{CC±} = ±2.5V to ±15V , R _S = 50Ω	25°C	90	106	90	106	dB		
			Full range	85			85			
I _{CC}	Supply current	V _O = 2.5V , No load, V _{IC} = 2.5V	25°C	3.4	4.4	3.4	4.4	mA		
			Full range	4.6			4.6			

(1) Full range is 0°C to 70°C.

5.4 TLE2141C Operating Characteristics, $V_{CC} = 5V$, $T_A = 25^\circ C$

PARAMETER		TEST CONDITIONS		TLE2141C			TLE2141AC			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
SR+	Positive slew rate	$A_{VD} = -1$, $R_L = 2k\Omega$, ⁽¹⁾ $C_L = 500pF$ ⁽¹⁾		45			45			V/ μs
SR–	Negative slew rate			42			42			
t_s	Settling time	$A_{VD} = -1$, 2.5V step	To 0.1%	0.66			0.66			μs
			To 0.01%	0.99			0.99			
V_n	Equivalent input noise voltage	$R_S = 20\Omega$, $f = 10Hz$		15			15			nV/ $\sqrt{Hz}$
		$R_S = 20\Omega$, $f = 1kHz$		10.5			10.5			
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	$f = 0.1Hz$ to 1Hz		0.48			0.48			μV
		$f = 0.1Hz$ to 10Hz		0.51			0.51			
I_n	Equivalent input noise current	$f = 10Hz$		1.92			1.92			pA/ $\sqrt{Hz}$
		$f = 1kHz$		0.5			0.5			
THD + N	Total harmonic distortion plus noise	$V_O = 1V$ to 3V , $R_L = 2k\Omega$, ⁽¹⁾ $A_{VD} = 2$, $f = 10kHz$		0.0052%			0.0052%			
B_1	Unity-gain bandwidth	$R_L = 2k\Omega$ ⁽¹⁾ , $C_L = 100pF$ ⁽¹⁾		5.9			5.9			MHz
	Gain-bandwidth product	$R_L = 2k\Omega$ ⁽¹⁾ , $C_L = 100pF$, ⁽¹⁾ $f = 100kHz$		5.8			5.8			MHz
B_{OM}	Maximum output-swing bandwidth ⁽²⁾	$V_{O(PP)} = 2V$, $R_L = 2k\Omega$, ⁽¹⁾ $A_{VD} = 1$, $C_L = 100pF$ ⁽¹⁾		380			380			kHz
ϕ_m	Phase margin at unity gain	$R_L = 2k\Omega$ ⁽¹⁾ , $C_L = 100pF$ ⁽¹⁾		57°			57°			

(1) R_L and C_L terminated to 2.5V.

(2) Measured at -0.1dB.

5.5 TLE2141C Electrical Characteristics

at specified free-air temperature, $V_{CC\pm} = \pm 15V$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T _A ⁽¹⁾	TLE2141C			TLE2141AC			UNIT
					MIN	TYP	MAX	MIN	TYP	MAX	
V _{IO}	Input offset voltage	V _{IC} = 0V, R _S = 50Ω, V _O = 0V		25°C	200	900	175	500	μV		
	Full range			1300			800				
α _{VIO}	Temperature coefficient of input offset voltage			Full range	1.7			1.7		μV/°C	
I _{IO}	Input offset current			25°C	7	100	7	100	nA		
				Full range	150			150			
I _{IB}	Input bias current			25°C	−0.7	−1.5	−0.7	−1.5	μA		
		Full range	−1.6			−1.6					
V _{ICR}	Common-mode input voltage range	R _S = 50Ω	25°C	−15 to 13	−15.3 to 13.2	−15 to 13	−15.3 to 13.2	V			
			Full range	−15 to 12.9	15.3 to 13.1	−15 to 12.9	−15.3 to 13.1	V			
V _{OM+}	Maximum positive peak output voltage swing	I _O = −150μA	25°C	13.8	14.1	13.8	14.1	V			
			Full range	13.7		13.7					
		I _O = −1.5mA	25°C	13.7	14	13.7	14				
			Full range	13.6		13.6					
		I _O = −15mA	25°C	13.1	13.7	13.1	13.7				
			Full range	13		13					
V _{OM−}	Maximum negative peak output voltage swing	I _O = 150μA	25°C	−14.7	−14.9	−14.7	−14.9	V			
			Full range	−14.6		−14.6					
		I _O = 1.5mA	25°C	−14.5	−14.8	−14.5	−14.8				
			Full range	−14.4		−14.4					
		I _O = 15mA	25°C	−13.4	−13.8	−13.4	−13.8	V			
			Full range	−13.3		−13.3					
A _{VD}	Large-signal differential voltage amplification	V _O = ±10V	25°C	100	450	100	450	V/mV			
			Full range	75		75					
r _i	Input resistance	R _L = 2kΩ		25°C	65		65		MΩ		
c _i	Input capacitance			25°C	2.5		2.5		pF		
z _o	Open-loop output impedance	f = 1MHz		25°C	30		30		Ω		
CMRR	Common-mode rejection ratio	V _{IC} = V _{ICRmin} , R _S = 50Ω		25°C	85	108	85	108	dB		
				Full range	80		80				
k _{SVR}	Supply-voltage rejection ratio (ΔV _{CC±} /ΔV _{IO})	V _{CC±} = ±2.5V to ±15V , R _S = 50Ω		25°C	90	106	90	106	dB		
				Full range	85		85				
I _{OS}	Short circuit output current	V _O = 0	V _{ID} = 1V	25°C	−25	−50	−25	−50	mA		
					V _{ID} = −1V	20	31	20			31
I _{CC}	Supply current	V _O = 0V, No load		25°C	3.5	4.5	3.5	4.5	mA		
				Full range	4.7		4.7				

(1) Full range is 0°C to 70°C.

5.6 TLE2141C Operating Characteristics, $V_{CC\pm} = \pm 15V$, $T_A = 25^\circ C$

PARAMETER		TEST CONDITIONS		TLE2141C			TLE2141AC			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
SR+	Positive slew rate	A _{VD} = - 1, R _L = 2kΩ, C _L = 500pF		27 ⁽²⁾	45		27 ⁽²⁾	45		V/μs
SR-	Negative slew rate			27 ⁽²⁾	42		27 ⁽²⁾	42		
t _s	Settling time	A _{VD} = -1, 10V step	To 0.1%	0.43			0.43			μs
			To 0.01%	0.64			0.64			
V _n	Equivalent input noise voltage	R _S = 20Ω, f = 10Hz		15			15			nV/√ Hz
		R _S = 20Ω, f = 1kHz		10.5			10.5			
V _{N(PP)}	Peak-to-peak equivalent input noise voltage	f = 0.1Hz to 1Hz		0.48			0.48			μV
		f = 0.1Hz to 10Hz		0.51			0.51			
I _n	Equivalent input noise current	f = 10Hz		1.89			1.89			pA/√ Hz
		f = 1kHz		0.47			0.47			
THD + N	Total harmonic distortion plus noise	V _{O(PP)} = 20V, R _L = 2kΩ, ⁽¹⁾ A _{VD} = 10, f = 10 kHz		0.06%			0.06%			
B ₁	Unity-gain bandwidth	R _L = 2kΩ, C _L = 100pF ⁽¹⁾		6			6			MHz
	Gain-bandwidth product	R _L = 2kΩ, C _L = 100pF, ⁽¹⁾ f = 100kHz		5.9			5.9			MHz
B _{OM}	Maximum output-swing bandwidth ⁽³⁾	V _{O(PP)} = 2V , R _L = 2kΩ, A _{VD} = 1, C _L = 100pF ⁽¹⁾		668			668			kHz
φ _m	Phase margin at unity gain	R _L = 2kΩ, C _L = 100pF ⁽¹⁾		58°			58°			

(1) R_L and C_L terminated to 2.5V .

(2) Specified by characterization.

(3) Measured at -0.1dB.

5.7 TLE2142C Electrical Characteristics

at specified free-air temperature, $V_{CC} = 5V$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T _A ⁽¹⁾	TLE2142C			TLE2142AC			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
V _{IO}	Input offset voltage	V _O = 2.5V , R _S = 50Ω, V _{IC} = 2.5V	25°C	220	1900	200	1500	μV		
			Full range	2200			1800			
α _{VIO}	Temperature coefficient of input offset voltage		Full range	1.7			1.7	μV/°C		
I _{IO}	Input offset current		25°C	8	100	8	100	nA		
			Full range	150			150			
I _{IB}	Input bias current		25°C	-0.8	-2	-0.8	-2	μA		
			Full range	-2.1			-2.1			
V _{ICR}	Common-mode input voltage range	R _S = 50Ω	25°C	0 to 3	-0.3 to 3.2	0 to 3	-0.3 to 3.2	V		
			Full range	0 to 2.9		0 to 2.9		V		
V _{OH}	High-level output voltage	I _{OH} = -150μA	25°C	3.9	4.1	3.9	4.1	V		
			Full range	3.8			3.8			
		I _{OH} = -1.5mA	25°C	3.8	4	3.8	4	V		
			Full range	3.7			3.7			
		I _{OH} = -15mA	25°C	3.4	3.7	3.4	3.7	V		
			Full range	3.4			3.4			
V _{OL}	Low-level output voltage	I _{OL} = 150μA	25°C	75	125	75	125	mV		
			Full range	150			150			
		I _{OL} = 1.5mA	25°C	150	225	150	225			
			Full range	250			250			
		I _{OL} = 15mA	25°C	1.2	1.4	1.2	1.4	V		
			Full range	1.5			1.5			
A _{VD}	Large-signal differential voltage amplification	V _{CC} = ±2.5V , R _L = 2kΩ, V _O = 1V to -1.5V	25°C	50	220	50	220	V/mV		
			Full range	25			25			
r _i	Input resistance		25°C	70			70	MΩ		
c _i	Input capacitance		25°C	2.5			2.5	pF		
Z _O	Open-loop output impedance	f = 1MHz	25°C	30			30	Ω		
CMRR	Common-mode rejection ratio	V _{IC} = V _{ICRmin} , R _S = 50Ω	25°C	85	118	85	118	dB		
			Full range	80			80			
k _{SVR}	Supply-voltage rejection ratio (ΔV _{CC±} /ΔV _{IO})	V _{CC±} = ±2.5V to ±15V , R _S = 50Ω	25°C	90	106	90	106	dB		
			Full range	85			85			
I _{CC}	Supply current	V _O = 2.5V , No load, V _{IC} = 2.5V	25°C	6.6	8.8	6.6	8.8	mA		
			Full range	9.2			9.2			

(1) Full range is 0°C to 70°C.

5.8 TLE2142C Operating Characteristics, $V_{CC} = 5V$, $T_A = 25^\circ C$

PARAMETER		TEST CONDITIONS		TLE2142C			TLE2142AC			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
SR+	Positive slew rate	$A_{VD} = -1$, $R_L = 2k\Omega$, ⁽¹⁾ $C_L = 500pF$		45			45			V/ μs
SR-	Negative slew rate			42			42			
t_s	Settling time	$A_{VD} = -1$, 2.5V step	To 0.1%	0.66			0.66			μs
			To 0.01%	0.99			0.99			
V_n	Equivalent input noise voltage	$R_S = 20\Omega$, $f = 10Hz$		15			15			nV/ $\sqrt{Hz}$
		$R_S = 20\Omega$, $f = 1kHz$		10.5			10.5			
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	$f = 0.1Hz$ to 1Hz		0.48			0.48			μV
		$f = 0.1Hz$ to 10Hz		0.51			0.51			
I_n	Equivalent input noise current	$f = 10Hz$		1.92			1.92			pA/ $\sqrt{Hz}$
		$f = 1kHz$		0.5			0.5			
THD + N	Total harmonic distortion plus noise	$V_O = 1V$ to 3V , $R_L = 2k\Omega$, ⁽¹⁾ $A_{VD} = 2$, $f = 10kHz$		0.0052%			0.0052%			
B_1	Unity-gain bandwidth	$R_L = 2k\Omega$ ⁽¹⁾ , $C_L = 100pF$		5.9			5.9			MHz
	Gain-bandwidth product	$R_L = 2k\Omega$ ⁽¹⁾ , $C_L = 100pF$, $f = 100kHz$		5.8			5.8			MHz
B_{OM}	Maximum output-swing bandwidth ⁽²⁾	$V_{O(PP)} = 2V$, $R_L = 2k\Omega$, ⁽¹⁾ $A_{VD} = 1$, $C_L = 100pF$		380			380			kHz
ϕ_m	Phase margin at unity gain	$R_L = 2k\Omega$ ⁽¹⁾ , $C_L = 100pF$		57°			57°			

(1) R_L terminated to 2.5V.

(2) Measured at -0.1dB.

5.9 TLE2142C Electrical Characteristics

at specified free-air temperature, $V_{CC\pm} = \pm 15V$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T _A ⁽¹⁾	TLE2142C			TLE2142AC			UNIT
					MIN	TYP	MAX	MIN	TYP	MAX	
V _{IO}	Input offset voltage	V _{IC} = 0V, R _S = 50Ω, V _O = 0V		25°C	290	1200	275	750	μV		
	Full range			1600			1200				
α _{VIO}	Temperature coefficient of input offset voltage			Full range	1.7			1.7		μV/°C	
I _{IO}	Input offset current			25°C	7	100	7	100	nA		
				Full range	150			150			
I _{IB}	Input bias current			25°C	−0.7	−1.5	−0.7	−1.5	μA		
		Full range	−1.6			−1.6					
V _{ICR}	Common-mode input voltage range	R _S = 50Ω	25°C	−15 to 13	−15.3 to 13.2	−15 to 13	−15.3 to 13.2	V			
			Full range	−15 to 12.9	15.3 to 13.1	−15 to 12.9	−15.3 to 13.1	V			
V _{OM+}	Maximum positive peak output voltage swing	I _O = −150μA	25°C	13.8	14.1	13.8	14.1	V			
			Full range	13.7			13.7				
		I _O = −1.5mA	25°C	13.7	14	13.7	14				
			Full range	13.6			13.6				
		I _O = −15mA	25°C	13.3	13.7	13.2	13.7				
			Full range	13.2			13.2				
V _{OM−}	Maximum negative peak output voltage swing	I _O = 150μA	25°C	−14.7	−14.9	−14.7	−14.9	V			
			Full range	−14.6			−14.6				
		I _O = 1.5mA	25°C	−14.5	−14.8	−14.5	−14.8				
			Full range	−14.4			−14.4				
		I _O = 15mA	25°C	−13.4	−13.8	−13.4	−13.8	V			
			Full range	−13.3			−13.3				
A _{VD}	Large-signal differential voltage amplification	V _O = ±10V	25°C	100	450	100	450	V/mV			
			Full range	75			75				
r _i	Input resistance	R _L = 2kΩ		25°C	65			65		MΩ	
c _i	Input capacitance			25°C	2.5			2.5		pF	
Z _O	Open-loop output impedance	f = 1MHz		25°C	30			30		Ω	
CMRR	Common-mode rejection ratio	V _{IC} = V _{ICRmin} , R _S = 50Ω		25°C	85	108	85	108	dB		
				Full range	80			80			
k _{SVR}	Supply-voltage rejection ratio (ΔV _{CC±} /ΔV _{IO})	V _{CC±} = ±2.5V to ±15V , R _S = 50Ω		25°C	90	106	90	106	dB		
				Full range	85			85			
I _{OS}	Short circuit output current	V _O = 0	V _{ID} = 1V V _{ID} = −1V	25°C	−25	−50	−25	−50	mA		
					20	31	20	31			
I _{CC}	Supply current	V _O = 0V, No load		25°C	6.9		9	6.9		9	mA
				Full range	9.4			9.4			

(1) Full range is 0°C to 70°C.

5.10 TLE2142C Operating Characteristics, $V_{CC\pm} = \pm 15V$, $T_A = 25^\circ C$

PARAMETER	TEST CONDITIONS	TLE2142C			TLE2142AC			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	
SR+	Positive slew rate	$A_{VD} = -1$, $R_L = 2k\Omega$, $C_L = 500pF$			27 ⁽²⁾	45		V/ μs
SR-	Negative slew rate				27 ⁽²⁾	42		
t_s	Settling time	$A_{VD} = -1$, 10V step	To 0.1%	0.43		0.43		μs
			To 0.01%	0.64		0.64		
V_n	Equivalent input noise voltage	$R_S = 20\Omega$, $f = 10Hz$				15		nV/ $\sqrt{Hz}$
		$R_S = 20\Omega$, $f = 1kHz$				10.5		
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	$f = 0.1Hz$ to 1Hz				0.48		μV
		$f = 0.1Hz$ to 10Hz				0.51		
I_n	Equivalent input noise current	$f = 10Hz$				1.89		pA/ $\sqrt{Hz}$
		$f = 1kHz$				0.47		
THD + N	Total harmonic distortion plus noise	$V_{O(PP)} = 20V$, $R_L = 2k\Omega$, ⁽¹⁾ $A_{VD} = 10$, $f = 10kHz$				0.06%		
B_1	Unity-gain bandwidth	$R_L = 2k\Omega$, $C_L = 100pF$, ⁽¹⁾				6		MHz
	Gain-bandwidth product	$R_L = 2k\Omega$, $C_L = 100pF$, ⁽¹⁾ $f = 100kHz$				5.9		MHz
B_{OM}	Maximum output-swing bandwidth ⁽¹⁾	$V_{O(PP)} = 2V$, $R_L = 2k\Omega$, $A_{VD} = 1$, $C_L = 100pF$, ⁽¹⁾				668		kHz
ϕ_m	Phase margin at unity gain	$R_L = 2k\Omega$, $C_L = 100pF$, ⁽¹⁾				58°		

(1) Measured at -0.1dB.

5.11 TLE2144C Electrical Characteristics

at specified free-air temperature, $V_{CC} = 5V$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T _A ⁽¹⁾	TLE2144C			TLE2144AC			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
V _{IO}	Input offset voltage	V _O = 2.5V , R _S = 50Ω, V _{IC} = 2.5V	25°C	0.5 3.8		0.5 3		mV		
			Full range	4.4		3.6				
α _{VIO}	Temperature coefficient of input offset voltage		Full range	1.7		1.7		μV/°C		
I _{IO}	Input offset current		25°C	8 100		8 100		nA		
			Full range	150		150				
I _{IB}	Input bias current		25°C	−0.8 −2		−0.8 −2		μA		
		Full range	−2.1		−2.1					
V _{ICR}	Common-mode input voltage range	R _S = 50Ω	25°C	0 to 3	−0.3 to 3.2	0 to 3	−0.3 to 3.2	V		
			Full range	0 to 2.9		0 to 2.9		V		
V _{OH}	High-level output voltage	I _{OH} = −150μA	25°C	3.9	4.1	3.9	4.1	V		
			Full range	3.8		3.8				
		I _{OH} = −1.5mA	25°C	3.8	4	3.8	4	V		
			Full range	3.7		3.7				
		I _{OH} = −15mA	25°C	3.4	3.7	3.4	3.7	V		
			Full range	3.4		3.4				
V _{OL}	Low-level output voltage	I _{OL} = 150μA	25°C	75	125	75	125	mV		
			Full range	150		150				
		I _{OL} = 1.5mA	25°C	150	225	150	225	mV		
			Full range	250		250				
		I _{OL} = 15mA	25°C	1.2	1.6	1.2	1.6	V		
			Full range	1.7		1.7				
A _{VD}	Large-signal differential voltage amplification	V _{CC} = ±2.5V , R _L = 2kΩ, V _O = 1V to −1.5V	25°C	50	95	50	95	V/mV		
			Full range	25		25				
r _i	Input resistance		25°C	70		70		MΩ		
c _i	Input capacitance		25°C	2.5		2.5		pF		
Z _O	Open-loop output impedance	f = 1MHz	25°C	30		30		Ω		
CMRR	Common-mode rejection ratio	V _{IC} = V _{ICRmin} , R _S = 50Ω	25°C	85	118	85	118	dB		
			Full range	80		80				
k _{SVR}	Supply-voltage rejection ratio (ΔV _{CC±} /ΔV _{IO})	V _{CC±} = ±2.5V to ±15V , R _S = 50Ω	25°C	90	106	90	106	dB		
			Full range	85		85				
I _{CC}	Supply current	V _O = 2.5V , No load, V _{IC} = 2.5V	25°C	13.2	17.6	13.2	17.6	mA		
			Full range	18.5		18.5				

(1) Full range is 0°C to 70°C.

5.12 TLE2144C Operating Characteristics, $V_{CC} = 5V$, $T_A = 25^\circ C$

PARAMETER		TEST CONDITIONS		TLE2144C			TLE2144AC			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
SR+	Positive slew rate	$A_{VD} = -1$, $R_L = 2k\Omega^{(1)}$, $C_L = 500pF$		45			45			V/ μs
SR–	Negative slew rate			42			42			
t_s	Settling time	$A_{VD} = -1$, 2.5V step	To 0.1%	0.66			0.66			μs
			To 0.01%	0.99			0.99			
V_n	Equivalent input noise voltage	$R_S = 20\Omega$, $f = 10Hz$		15			15			nV/ $\sqrt{Hz}$
		$R_S = 20\Omega$, $f = 1kHz$		10.5			10.5			
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	$f = 0.1Hz$ to 1Hz		0.48			0.48			μV
		$f = 0.1Hz$ to 10Hz		0.51			0.51			
I_n	Equivalent input noise current	$f = 10Hz$		1.92			1.92			pA/ $\sqrt{Hz}$
		$f = 1kHz$		0.5			0.5			
THD + N	Total harmonic distortion plus noise	$V_O = 1V$ to 3V , $R_L = 2k\Omega$, ⁽¹⁾ $A_{VD} = 2$, $f = 10kHz$		0.0052%			0.0052%			
B_1	Unity-gain bandwidth	$R_L = 2k\Omega^{(1)}$, $C_L = 100pF$		5.9			5.9			MHz
	Gain-bandwidth product	$R_L = 2k\Omega^{(1)}$, $C_L = 100pF$, $f = 100kHz$		5.8			5.8			MHz
B_{OM}	Maximum output-swing bandwidth ⁽²⁾	$V_{O(PP)} = 2V$, $R_L = 2k\Omega$, ⁽¹⁾ $A_{VD} = 1$, $C_L = 100pF$		380			380			kHz
ϕ_m	Phase margin at unity gain	$R_L = 2k\Omega^{(1)}$, $C_L = 100pF$		57°			57°			

(1) R_L terminated to 2.5V.

(2) Measured at -0.1dB.

5.13 TLE2144C Electrical Characteristics

at specified free-air temperature, $V_{CC\pm} = \pm 15V$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T _A ⁽¹⁾	TLE2144C			TLE2144AC			UNIT
					MIN	TYP	MAX	MIN	TYP	MAX	
V _{IO}	Input offset voltage	V _{IC} = 0, R _S = 50Ω, V _O = 0		25°C	0.6 2.4			0.5 1.5			μV
	Full range			3.2			2.4				
α _{VIO}	Temperature coefficient of input offset voltage			Full range	1.7			1.7			μV/°C
I _{IO}	Input offset current			25°C	7 100			7 100			nA
				Full range	150			150			
I _{IB}	Input bias current			25°C	−0.7 −1.5			−0.7 −1.5			μA
		Full range	−1.6			−1.6					
V _{ICR}	Common-mode input voltage range	R _S = 50Ω	25°C	−15 to 13	−15.3 to 13.2	−15 to 13		−15.3 to 13.2	V		
			Full range	−15 to 12.9	15.3 to 13.1	−15 to 12.9		−15.3 to 13.1	V		
V _{OM+}	Maximum positive peak output voltage swing	I _O = −150μA	25°C	13.8 14.1		13.8 14.1		V			
			Full range	13.7		13.7					
		I _O = −1.5mA	25°C	13.7 14		13.7 14					
			Full range	13.6		13.6					
		I _O = −15mA	25°C	13.1 13.7		13.1 13.7					
			Full range	13		13					
V _{OM−}	Maximum negative peak output voltage swing	I _O = 150μA	25°C	−14.7	−14.9	−14.7 −14.9		V			
			Full range	−14.6		−14.6					
		I _O = 1.5mA	25°C	−14.5	−14.8	−14.5 −14.8					
			Full range	−14.4		−14.4					
		I _O = 15mA	25°C	−13.4	−13.8	−13.4 −13.8		V			
			Full range	−13.3		−13.3					
A _{VD}	Large-signal differential voltage amplification	V _O = ±10V, R _L = 2kΩ		25°C	100	170	100 170		V/mV		
	Full range			75		75					
r _i	Input resistance			25°C	65			65		MΩ	
c _i	Input capacitance			25°C	2.5			2.5		pF	
Z _O	Open-loop output impedance	f = 1MHz		25°C	30			30		Ω	
CMRR	Common-mode rejection ratio	V _{IC} = V _{ICRmin} , R _S = 50Ω		25°C	85	108	85 108		dB		
				Full range	80		80				
k _{SVR}	Supply-voltage rejection ratio (ΔV _{CC±} /ΔV _{IO})	V _{CC±} = ±2.5V to ±15V , R _S = 50Ω		25°C	90	106	90 106		dB		
				Full range	85		85				
I _{OS}	Short circuit output current	V _O = 0	V _{ID} = 1V	25°C	−25	−50	−25 −50		mA		
					V _{ID} = −1V	20	31	20 31			
I _{CC}	Supply current	V _O = 0V, No load		25°C	13.8 18		13.8 18		mA		
				Full range	18.8		18.8				

(1) Full range is 0°C to 70°C.

5.14 TLE2144C Operating Characteristics, $V_{CC\pm} = \pm 15V$, $T_A = 25^\circ C$

PARAMETER	TEST CONDITIONS	TLE2144C			TLE2144AC			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	
SR+	Positive slew rate	$A_{VD} = -1$, $R_L = 2k\Omega$, $C_L = 500pF$			27 ¹	45		V/ μs
SR-	Negative slew rate				27 ¹	42		
t_s	Settling time	$A_{VD} = -1$, 10V step	To 0.1%	0.43		0.43		μs
			To 0.01%	0.64		0.64		
V_n	Equivalent input noise voltage	$R_S = 20\Omega$, $f = 10Hz$				15		nV/ $\sqrt{Hz}$
		$R_S = 20\Omega$, $f = 1kHz$				10.5		
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	$f = 0.1Hz$ to $1Hz$				0.48		μV
		$f = 0.1Hz$ to $10Hz$				0.51		
I_n	Equivalent input noise current	$f = 10Hz$				1.89		pA/ $\sqrt{Hz}$
		$f = 1kHz$				0.47		
THD + N	Total harmonic distortion plus noise	$V_{O(PP)} = 20V$, $R_L = 2k\Omega$, $A_{VD} = 10$, $f = 10kHz$				0.06%		
B_1	Unity-gain bandwidth	$R_L = 2k\Omega$, $C_L = 100pF$				6		MHz
	Gain-bandwidth product	$R_L = 2k\Omega$, $C_L = 100pF$, $f = 100kHz$				5.9		MHz
B_{OM}	Maximum output-swing bandwidth ⁽²⁾	$V_{O(PP)} = 2V$, $R_L = 2k\Omega$, $A_{VD} = 1$, $C_L = 100pF$				668		kHz
ϕ_m	Phase margin at unity gain	$R_L = 2k\Omega$, $C_L = 100pF$				58°		

(1) Specified by characterization.

(2) Measured at -0.1dB.

5.15 TLE2141I Electrical Characteristics

at specified free-air temperature, $V_{CC} = 5V$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A ⁽¹⁾	TLE2141I			TLE2141AI			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_O = 2.5V$, $R_S = 50\Omega$, $V_{IC} = 2.5V$	25°C		225	1400		200	1000	mV
		Full range			1900			1500	
α_{VIO} Temperature coefficient of input offset voltage		Full range		1.7			1.7		$\mu V/^\circ C$
I_{IO} Input offset current		25°C		8	100		8	100	nA
		Full range			200			200	
I_{IB} Input bias current		25°C		–0.8	–2		–0.8	–2	μA
		Full range			–2.2			–2.2	
V_{ICR} Common-mode input voltage range	$R_S = 50\Omega$	25°C	0 to 3	–0.3 to 3.2		0 to 3	–0.3 to 3.2		V
		Full range	0 to 2.7	–0.3 to 2.9		0 to 2.7	–0.3 to 2.9		V
V_{OH} High-level output voltage	$I_{OH} = -150\mu A$	25°C	3.9	4.1		3.9	4.1		V
	$I_{OH} = -1.5mA$		3.8	4		3.8	4		
	$I_{OH} = -15mA$		3.2	3.7		3.2	3.7		
	$I_{OH} = -100\mu A$	Full range	3.8			3.8			V
	$I_{OH} = -1mA$		3.7			3.7			
	$I_{OH} = -10mA$		3.3			3.3			
V_{OL} Low-level output voltage	$I_{OL} = 150\mu A$	25°C		75	125		75	125	mV
	$I_{OL} = 1.5mA$			150	225		150	225	
	$I_{OL} = 15mA$			1.2	1.6		1.2	1.6	V
	$I_{OL} = 100\mu A$	Full range			175			175	mV
	$I_{OL} = 1mA$				225			225	
	$I_{OL} = 10mA$				1.4			1.4	V
A_{VD} Large-signal differential voltage amplification	$V_{CC} = \pm 2.5V$, $R_L = 2k\Omega$, $V_O = 1V$ to $-1.5V$	25°C	50	220		50	220		V/mV
		Full range	10			10			
r_i Input resistance		25°C		70			70		M Ω
c_i Input capacitance		25°C		2.5			2.5		pF
z_o Open-loop output impedance	$f = 1MHz$	25°C		30			30		Ω
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICRmin}$, $R_S = 50\Omega$	25°C	85	118		85	118		dB
		Full range	80			80			
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{CC\pm} / \Delta V_{IO}$)	$V_{CC\pm} = \pm 2.5V$ to $\pm 15V$, $R_S = 50\Omega$	25°C	90	106		90	106		dB
		Full range	85			85			
I_{CC} Supply current	$V_O = 2.5V$, No load, $V_{IC} = 2.5V$	25°C		3.4	4.4		3.4	4.4	mA
		Full range			4.6			4.6	

(1) Full range is $-40^\circ C$ to $105^\circ C$.

5.16 TLE2141I Operating Characteristics, $V_{CC} = 5V$, $T_A = 25^\circ C$

PARAMETER		TEST CONDITIONS		TLE2141I			TLE2141AI			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
SR+	Positive slew rate	$A_{VD} = -1$, $R_L = 2k\Omega^{(1)}$, $C_L = 500pF$		45			45			V/ μs
SR–	Negative slew rate			42			42			
t_s	Settling time	$A_{VD} = -1$, 2.5V step	To 0.1%	0.66			0.66			μs
			To 0.01%	0.99			0.99			
V_n	Equivalent input noise voltage	$R_S = 20\Omega$, $f = 10Hz$		15			15			nV/ $\sqrt{Hz}$
		$R_S = 20\Omega$, $f = 1kHz$		10.5			10.5			
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	$f = 0.1Hz$ to 1Hz		0.48			0.48			μV
		$f = 0.1Hz$ to 10Hz		0.51			0.51			
I_n	Equivalent input noise current	$f = 10Hz$		1.92			1.92			pA/ $\sqrt{Hz}$
		$f = 1kHz$		0.5			0.5			
THD + N	Total harmonic distortion plus noise	$V_O = 1V$ to 3V , $R_L = 2k\Omega$, ⁽¹⁾ $A_{VD} = 2$, $f = 10kHz$		0.0052%			0.0052%			
B_1	Unity-gain bandwidth	$R_L = 2k\Omega^{(1)}$, $C_L = 100pF^{(1)}$		5.9			5.9			MHz
	Gain-bandwidth product	$R_L = 2k\Omega^{(1)}$, $C_L = 100pF$, ⁽¹⁾ $f = 100kHz$		5.8			5.8			MHz
B_{OM}	Maximum output-swing bandwidth ⁽²⁾	$V_{O(PP)} = 2V$, $R_L = 2k\Omega$, ⁽¹⁾ $A_{VD} = 1$, $C_L = 100pF$		380			380			kHz
ϕ_m	Phase margin at unity gain	$R_L = 2k\Omega^{(1)}$, $C_L = 100pF^{(1)}$		57°			57°			

(1) R_L and C_L terminated to 2.5V.

(2) Measured at -0.1dB.

5.17 TLE2141I Electrical Characteristics

at specified free-air temperature, $V_{CC\pm} = \pm 15V$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T _A ⁽¹⁾	TLE2141I			TLE2141AI			UNIT
					MIN	TYP	MAX	MIN	TYP	MAX	
V _{IO}	Input offset voltage	V _{IC} = 0, R _S = 50Ω, V _O = 0		25°C	200	900	175	500	μV		
	Full range			1500			1000				
α _{VIO}	Temperature coefficient of input offset voltage			Full range	1.7			1.7		μV/°C	
I _{IO}	Input offset current			25°C	7	100	7	100	nA		
				Full range	200			200			
I _{IB}	Input bias current			25°C	−0.7	−1.5	−0.7	−1.5	μA		
		Full range	−1.7			−1.7					
V _{ICR}	Common-mode input voltage range	R _S = 50Ω	25°C	−15 to 13	−15.3 to 13.2	−15 to 13	−15.3 to 13.2	V			
			Full range	−15 to 12.7	15.3 to 12.9	−15 to 12.7	−15.3 to 12.9			V	
V _{OM+}	Maximum positive peak output voltage swing	I _O = −150μA	25°C	13.8	14.1	13.8	14.1	V			
		I _O = −1.5mA		13.7	14	13.7	14				
		I _O = −15mA		13.1	13.7	13.1	13.7				
		I _O = 100μA	Full range	13.7	13.7						
		I _O = 1mA		13.6	13.6						
		I _O = 10mA		13.1	13.1						
V _{OM−}	Maximum negative peak output voltage swing	I _O = 150μA	25°C	−14.7	−14.9	−14.7	−14.9	V			
		I _O = 1.5mA	−14.5	−14.8	−14.5	−14.8					
		I _O = 15mA	−13.4	−13.8	−13.4	−13.8					
		I _O = 100μA	Full range	−14.6	−14.6						
		I _O = 1mA	−14.5	−14.5							
		I _O = 10mA	−13.4	−13.4							
A _{VD}	Large-signal differential voltage amplification	V _O = ±10V, R _L = 2kΩ		25°C	100	450	100	450	V/mV		
				Full range	40	40					
r _i	Input resistance			25°C	65		65		MΩ		
c _i	Input capacitance			25°C	2.5		2.5		pF		
Z _o	Open-loop output impedance	f = 1MHz		25°C	30		30		Ω		
CMRR	Common-mode rejection ratio	V _{IC} = V _{ICRmin} , R _S = 50Ω		25°C	85	108	85	108	dB		
				Full range	80	80					
k _{SVR}	Supply-voltage rejection ratio (ΔV _{CC±} /ΔV _{IO})	V _{CC±} = ±2.5V to ±15V , R _S = 50Ω		25°C	90	106	90	106	dB		
				Full range	85	85					
I _{OS}	Short circuit output current	V _O = 0	V _{ID} = 1V V _{ID} = −1V	25°C	−25	−50	−25	−50	mA		
					20	31	20	31			
I _{CC}	Supply current	V _O = 0V, No load		25°C	3.5	4.5	3.5	4.5	mA		
				Full range	4.7			4.7			

(1) Full range is $-40^\circ C$ to $105^\circ C$.

5.18 TLE2141I Operating Characteristics, $V_{CC\pm} = \pm 15V$, $T_A = 25^\circ C$

PARAMETER	TEST CONDITIONS	TLE2141I			TLE2141AI			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	
SR+	Positive slew rate	$A_{VD} = -1$, $R_L = 2k\Omega$, $C_L = 500pF$	27 ⁽¹⁾	45	27 ⁽¹⁾	45		V/ μs
SR-	Negative slew rate		27 ⁽¹⁾	42	27 ⁽¹⁾	42		
t_s	Settling time	$A_{VD} = -1$, 10V step	To 0.1%		0.43			μs
			To 0.01%		0.64			
V_n	Equivalent input noise voltage	$R_S = 20\Omega$, $f = 10Hz$		15	15			nV/ $\sqrt{Hz}$
		$R_S = 20\Omega$, $f = 1kHz$		10.5	10.5			
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	$f = 0.1Hz$ to $1Hz$		0.48	0.48			μV
		$f = 0.1Hz$ to $10Hz$		0.51	0.51			
I_n	Equivalent input noise current	$f = 10Hz$		1.89	1.89			pA/ $\sqrt{Hz}$
		$f = 1kHz$		0.47	0.47			
THD + N	Total harmonic distortion plus noise	$V_{O(PP)} = 20V$, $R_L = 2k\Omega$, $A_{VD} = 10$, $f = 10kHz$		0.06%	0.06%			
B_1	Unity-gain bandwidth	$R_L = 2k\Omega$, $C_L = 100pF$		6	6			MHz
	Gain-bandwidth product	$R_L = 2k\Omega$, $C_L = 100pF$, $f = 100kHz$		5.9	5.9			MHz
B_{OM}	Maximum output-swing bandwidth ⁽²⁾	$V_{O(PP)} = 2V$, $R_L = 2k\Omega$, $A_{VD} = 1$, $C_L = 100pF$		668	668			kHz
ϕ_m	Phase margin at unity gain	$R_L = 2k\Omega$, $C_L = 100pF$		58°	58°			

(1) Specified by characterization.

(2) Measured at -0.1dB.

5.19 TLE2142I Electrical Characteristics

at specified free-air temperature, $V_{CC} = 5V$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T _A ⁽¹⁾	TLE2142I			TLE2142AI			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
V _{IO}	Input offset voltage	V _O = 2.5V , R _S = 50Ω, V _{IC} = 2.5V	25°C	220	1900	220	1500	μV		
			Full range	2400			2000			
α _{VIO}	Temperature coefficient of input offset voltage		Full range	1.7			1.7	μV/°C		
I _{IO}	Input offset current		25°C	8	100	8	100	nA		
			Full range	200			200			
I _{IB}	Input bias current		25°C	−0.8	−2	−0.8	−2	μA		
			Full range	−2.2			−2.2			
V _{ICR}	Common-mode input voltage range	R _S = 50Ω	25°C	0 to 3	−0.3 to 3.2	0 to 3	−0.3 to 3.2	V		
			Full range	0 to 2.7	−0.3 to 2.9	0 to 2.7	−0.3 to 2.9	V		
V _{OH}	High-level output voltage	I _{OH} = −150μA	25°C	13.8	14.1	13.8	14.1	V		
		I _{OH} = −1.5mA		13.7	14	13.7	14			
		I _{OH} = −15mA		13.1	13.7	13.1	13.7			
		I _{OH} = 100μA	Full range	13.7	13.7					
		I _{OH} = 1mA		13.6	13.6					
		I _{OH} = 10mA		13.1	13.1					
V _{OI}	Low-level output voltage	I _{OL} = 150μA	25°C	3.9	4.1	3.9	4.1	mV		
		I _{OL} = 1.5mA		3.8	4	3.8	4			
		I _{OL} = 15mA		3.4	3.7	3.4	3.7	V		
		I _{OL} = 100μA	Full range	3.8	3.8			mV		
		I _{OL} = 1mA		3.7	3.7					
		I _{OL} = 10mA		3.5	3.5			V		
A _{VD}	Large-signal differential voltage amplification	V _{IC} = ±2.5V , R _L = 2kΩ, V _O = 1V to −1.5V	25°C	50	220	50	220	V/mV		
			Full range	10	10					
r _i	Input resistance		25°C	70			70	MΩ		
c _i	Input capacitance		25°C	2.5			2.5	pF		
Z _O	Open-loop output impedance	f = 1MHz	25°C	30			30	Ω		
CMRR	Common-mode rejection ratio	V _{IC} = V _{ICRmin} , R _S = 50Ω	25°C	85	118	85	118	dB		
			Full range	80	80					
k _{SVR}	Supply-voltage rejection ratio (ΔV _{CC±} /ΔV _{IO})	V _{CC±} = ±2.5V to ±15V , R _S = 50Ω	25°C	90	106	90	106	dB		
			Full range	85	85					
I _{CC}	Supply current	V _O = 2.5V , V _{IC} = 2.5V , No load	25°C	6.6	8.8	6.6	8.8	mA		
			Full range	9.2			9.2			

(1) Full range is $-40^\circ C$ to $105^\circ C$.

5.20 TLE2142I Operating Characteristics, $V_{CC} = 5V$, $T_A = 25^\circ C$

PARAMETER		TEST CONDITIONS		TLE2142I			TLE2142AI			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
SR+	Positive slew rate	$A_{VD} = -1$, $R_L = 2k\Omega^{(1)}$, $C_L = 500pF$		45			45			V/ μs
SR-	Negative slew rate			42			42			
t_s	Settling time	$A_{VD} = -1, 2.5V$ step	To 0.1%	0.66			0.66			μs
			To 0.01%	0.99			0.99			
V_n	Equivalent input noise voltage	$R_S = 20\Omega$, $f = 10Hz$		15			15			nV/ $\sqrt{Hz}$
		$R_S = 20\Omega$, $f = 1kHz$		10.5			10.5			
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	$f = 0.1Hz$ to $1Hz$		0.48			0.48			μV
		$f = 0.1Hz$ to $10Hz$		0.51			0.51			
I_n	Equivalent input noise current	$f = 10Hz$		1.92			1.92			pA/ $\sqrt{Hz}$
		$f = 1kHz$		0.5			0.5			
THD + N	Total harmonic distortion plus noise	$V_O = 1V$ to $3V$, $R_L = 2k\Omega^{(1)}$, $A_{VD} = 2$, $f = 10kHz$		0.0052%			0.0052%			
B_1	Unity-gain bandwidth	$R_L = 2k\Omega^{(1)}$, $C_L = 100pF$		5.9			5.9			MHz
	Gain-bandwidth product	$R_L = 2k\Omega^{(1)}$, $C_L = 100pF$, $f = 100kHz$		5.8			5.8			MHz
B_{OM}	Maximum output-swing bandwidth ⁽²⁾	$V_{O(PP)} = 2V$, $R_L = 2k\Omega^{(1)}$, $A_{VD} = 1$, $C_L = 100pF$		380			380			kHz
ϕ_m	Phase margin at unity gain	$R_L = 2k\Omega^{(1)}$, $C_L = 100pF$		57°			57°			

(1) R_L terminates at 2.5V .

(2) Measured at -0.1dB.

5.21 TLE2142I Electrical Characteristics

at specified free-air temperature, $V_{CC\pm} = \pm 15V$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T _A ⁽¹⁾	TLE2142I			TLE2142I			UNIT
					MIN	TYP	MAX	MIN	TYP	MAX	
V _{IO}	Input offset voltage	V _{IC} = 0, R _S = 50Ω, V _O = 0		25°C	290	1200	275	750	μV		
	Full range			1800			1400				
α _{VIO}	Temperature coefficient of input offset voltage			Full range	1.7			1.7		μV/°C	
I _{IO}	Input offset current			25°C	7	100	7	100	nA		
				Full range	200			200			
I _{IB}	Input bias current			25°C	−0.7	−1.5	−0.7	−1.5	μA		
				Full range	−1.7			−1.7			
V _{ICR}	Common-mode input voltage range	R _S = 50Ω	25°C	−15 to 13	−15.3 to 13.2	−15 to 13	−15.3 to 13.2	V			
			Full range	−15 to 12.7	15.3 to 12.9	−15 to 12.7	−15.3 to 12.9			V	
V _{OM+}	Maximum positive peak output voltage swing	I _O = −150μA	25°C	13.8	14.1	13.8	14.1	V			
		I _O = −1.5mA		13.7	14	13.7	14				
		I _O = −15mA		13.3	13.7	13.3	13.7				
		I _O = −100μA	Full range	13.7	13.7	13.7	13.7	V			
		I _O = −1mA		13.6	13.6						
		I _O = −10mA		13.3	13.3						
V _{OM−}	Maximum negative peak output voltage swing	I _O = 150μA	25°C	−14.7	−14.9	−14.7	−14.9	V			
		I _O = 1.5mA		−14.5	−14.8	−14.5	−14.8				
		I _O = 15mA		−13.4	−13.8	−13.4	−13.8				
		I _O = 100μA	Full range	−14.6	−14.6	−14.6	−14.6	V			
		I _O = 1mA		−14.5	−14.5						
		I _O = 10mA		−13.4	−13.4						
A _{VD}	Large-signal differential voltage amplification	V _O = ±10V, R _L = 2kΩ	25°C	100	450	100	450	V/mV			
			Full range	40	40						
r _i	Input resistance		25°C	65	65	65	65	MΩ			
c _i	Input capacitance		25°C	2.5	2.5	2.5	2.5	pF			
Z _o	Open-loop output impedance	f = 1MHz	25°C	30	30	30	30	Ω			
CMRR	Common-mode rejection ratio	V _{IC} = V _{ICR} min	25°C	85	108	85	108	dB			
		R _S = 50Ω	Full range	80	80						
k _{SVR}	Supply-voltage rejection ratio (ΔV _{CC±} /ΔV _{IO})	V _{CC±} = ±2.5V to ±15V , R _S = 50Ω	25°C	90	106	90	106	dB			
			Full range	85	85						
I _{OS}	Short circuit output current	V _O = 0	25°C	−25	−50	−25	−50	mA			
				20	31	20	31				
I _{CC}	Supply current	V _O = 0V, No load	25°C	6.9	9	6.9	9	mA			
			Full range	9.4	9.4						

(1) Full range is $-40^\circ C$ to $105^\circ C$.

5.22 TLE2142I Operating Characteristics, $V_{CC\pm} = \pm 15V$, $T_A = 25^\circ C$

PARAMETER	TEST CONDITIONS	TLE2142I			TLE2142AI			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	
SR+	Positive slew rate	$A_{VD} = -1$, $R_L = 2k\Omega$, $C_L = 500pF$	30 ⁽¹⁾	45	30 ⁽¹⁾	45		V/ μs
SR-	Negative slew rate		30 ⁵	42	30 ⁽¹⁾	42		
t_s	Settling time	$A_{VD} = -1$, 10V step	To 0.1%		0.43			μs
			To 0.01%		0.64			
V_n	Equivalent input noise voltage	$R_S = 20\Omega$, $f = 10Hz$		15	15			nV/ $\sqrt{Hz}$
		$R_S = 20\Omega$, $f = 1kHz$		10.5	10.5			
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	$f = 0.1Hz$ to $1Hz$		0.48	0.48			μV
		$f = 0.1Hz$ to $10Hz$		0.51	0.51			
I_n	Equivalent input noise current	$f = 10Hz$		1.89	1.89			pA/ $\sqrt{Hz}$
		$f = 1kHz$		0.47	0.47			
THD + N	Total harmonic distortion plus noise	$V_{O(PP)} = 20V$, $R_L = 2k\Omega$, $A_{VD} = 10$, $f = 10kHz$		0.06%	0.06%			
B_1	Unity-gain bandwidth	$R_L = 2k\Omega$, $C_L = 100pF$		6	6			MHz
	Gain-bandwidth product	$R_L = 2k\Omega$, $C_L = 100pF$, $f = 100kHz$		5.9	5.9			MHz
B_{OM}	Maximum output-swing bandwidth ⁽²⁾	$V_{O(PP)} = 2V$, $R_L = 2k\Omega$, $A_{VD} = 1$, $C_L = 100pF$		668	668			kHz
ϕ_m	Phase margin at unity gain	$R_L = 2k\Omega$, $C_L = 100pF$		58°	58°			

(1) Specified by characterization.

(2) Measured at -0.1dB.

5.23 TLE2144I Electrical Characteristics

at specified free-air temperature, $V_{CC} = 5V$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A ⁽¹⁾	TLE2144I			TLE2144AI			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_O = 0$, $R_S = 50\Omega$, $V_O = 0$	25°C		0.5	3.8		0.5	3	mV
		Full range			4.8			4	
α_{VIO} Temperature coefficient of input offset voltage		Full range		1.7			1.7		$\mu V/^\circ C$
I_{IO} Input offset current		25°C		8	100		8	100	nA
		Full range			200			200	
I_{IB} Input bias current		25°C		–0.8	–2		–0.8	–2	μA
		Full range			–2.2			–2.2	
V_{ICR} Common-mode input voltage range	$R_S = 50\Omega$	25°C	0 to 3	–0.3 to 3.2		0 to 3	–0.3 to 3.2		V
		Full range	0 to 2.7	–0.3 to 2.9		0 to 2.7	–0.3 to 2.9		V
V_{OH} High-level output voltage	$I_{OH} = -150\mu A$	25°C	3.9	4.1		3.9	4.1		V
	$I_{OH} = -1.5mA$		3.8	4		3.8	4		
	$I_{OH} = -15mA$		3.4	3.7		3.4	3.7		
	$I_{OH} = 100\mu A$	Full range	3.8			3.8			V
	$I_{OH} = 1mA$		3.7			3.7			
	$I_{OH} = 10mA$		3.5			3.5			
V_{OL} Low-level output voltage	$I_{OL} = 150\mu A$	25°C		75	125		75	125	mV
	$I_{OL} = 1.5mA$			150	225		150	225	
	$I_{OL} = 15mA$			1.2	1.6		1.2	1.6	V
	$I_{OL} = 100\mu A$	Full range			175			175	mV
	$I_{OL} = 1mA$				225			225	
	$I_{OL} = 10mA$				1.4			1.4	V
A_{VD} Large-signal differential voltage amplification	$V_{CC} = \pm 2.5V$, $R_L = 2k\Omega$, $V_O = 1V$ to $-1.5V$	25°C	50	95		50	95		V/mV
		Full range	10			10			
r_i Input resistance		25°C		70			70		M Ω
c_i Input capacitance		25°C		2.5			2.5		pF
z_o Open-loop output impedance	$f = 1MHz$	25°C		30			30		Ω
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICRmin}$, $R_S = 50\Omega$	25°C	85	118		85	118		dB
		Full range	80			80			
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{CC\pm} / \Delta V_{IO}$)	$V_{CC\pm} = \pm 2.5V$ to $\pm 15V$, $R_S = 50\Omega$	25°C	90	106		90	106		dB
		Full range	85			85			
I_{CC} Supply current	$V_O = 2.5V$, No load, $V_{IC} = 2.5V$	25°C		13.2	17.6		13.2	17.6	mA
		Full range			18.4			18.4	

(1) Full range is $-40^\circ C$ to $105^\circ C$.

5.24 TLE2144C Operating Characteristics, $V_{CC} = 5V$, $T_A = 25^\circ C$

PARAMETER		TEST CONDITIONS		TLE2144C			TLE2144AC			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
SR+	Positive slew rate	$A_{VD} = -1$, $R_L = 2k\Omega^{(1)}$, $C_L = 500pF$		45			45			V/ μs
SR-	Negative slew rate			42			42			
t_s	Settling time	$A_{VD} = -1$, 2.5V step	To 0.1%	0.66			0.66			μs
			To 0.01%	0.99			0.99			
V_n	Equivalent input noise voltage	$R_S = 20\Omega$, $f = 10Hz$		15			15			nV/ $\sqrt{Hz}$
		$R_S = 20\Omega$, $f = 1kHz$		10.5			10.5			
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	$f = 0.1Hz$ to 1Hz		0.48			0.48			μV
		$f = 0.1Hz$ to 10Hz		0.51			0.51			
I_n	Equivalent input noise current	$f = 10Hz$		1.92			1.92			pA/ $\sqrt{Hz}$
		$f = 1kHz$		0.5			0.5			
THD + N	Total harmonic distortion plus noise	$V_O = 1V$ to 3V , $R_L = 2k\Omega$, ⁽¹⁾ $A_{VD} = 2$, $f = 10kHz$		0.0052%			0.0052%			
B_1	Unity-gain bandwidth	$R_L = 2k\Omega^{(1)}$, $C_L = 100pF$		5.9			5.9			MHz
	Gain-bandwidth product	$R_L = 2k\Omega^{(1)}$, $C_L = 100pF$, $f = 100kHz$		5.8			5.8			MHz
B_{OM}	Maximum output-swing bandwidth ⁽²⁾	$V_{O(PP)} = 2V$, $R_L = 2k\Omega$, ⁽¹⁾ $A_{VD} = 1$, $C_L = 100pF$		380			380			kHz
ϕ_m	Phase margin at unity gain	$R_L = 2k\Omega^{(1)}$, $C_L = 100pF$		57°			57°			

(1) R_L terminated to 2.5V.

(2) Measured at -0.1dB.

5.25 TLE2144I Electrical Characteristics

at specified free-air temperature, $V_{CC\pm} = \pm 15V$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A ⁽¹⁾	TLE2144I			TLE2144AI			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, R_S = 50\Omega, V_O = 0$	25°C	0.6	2.4		0.5	1.5		μV
		Full range			3.2			2.8	
α_{VIO} Temperature coefficient of input offset voltage		Full range	1.7			1.7			$\mu V/^\circ C$
I_{IO} Input offset current		25°C	7	100		7	100		nA
		Full range			200			200	
I_{IB} Input bias current		25°C	–0.7	–1.5		–0.7	–1.5		μA
		Full range			–1.7			–1.7	
V_{ICR} Common-mode input voltage range	$R_S = 50\Omega$	25°C	–15 to 13	–15.3 to 13.2		–15 to 13	–15.3 to 13.2		V
		Full range	–15 to 12.7	15.3 to 12.9		–15 to 12.7	15.3 to 12.9		V
V_{OM+} Maximum positive peak output voltage swing	$I_O = -150\mu A$	25°C	13.8	14.1		13.8	14.1		V
	$I_O = -1.5mA$		13.7	14		13.7	14		
	$I_O = -15mA$		13.1	13.7		13.1	13.7		
	$I_O = -100\mu A$	Full range	13.7			13.7			V
	$I_O = -1mA$		13.6			13.6			
	$I_O = -10mA$		13.1			13.1			
V_{OM-} Maximum negative peak output voltage swing	$I_O = 150\mu A$	25°C	–14.7	–14.9		–14.7	–14.9		V
	$I_O = 1.5mA$		–14.5	–14.8		–14.5	–14.8		
	$I_O = 15mA$		–13.4	–13.8		–13.4	–13.8		
	$I_O = 100\mu A$	Full range	–14.6			–14.6			V
	$I_O = 1mA$		–14.5			–14.5			
	$I_O = 10mA$		–13.4			–13.4			
A_{VD} Large-signal differential voltage amplification	$V_O = \pm 10V, R_L = 2k\Omega$	25°C	100	170		100	170		V/mV
		Full range	40			40			
r_i Input resistance		25°C		65			65		M Ω
c_i Input capacitance		25°C		2.5			2.5		pF
z_o Open-loop output impedance	$f = 1MHz$	25°C		30			30		Ω
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICRmin}$	25°C	85	108		85	108		dB
	$R_S = 50\Omega$	Full range	80			80			
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{CC\pm} / \Delta V_{IO}$)	$V_{CC\pm} = \pm 2.5V$ to $\pm 15V$, $R_S = 50\Omega$	25°C	90	106		90	106		dB
		Full range	85			85			
I_{OS} Short circuit output current	$V_O = 0$	25°C	–25	–50		–25	–50		mA
			20	31		20	31		
I_{CC} Supply current	$V_O = 0V$, No load	25°C		13.8	18		13.8	18	mA
		Full range			18.8			18.8	

(1) Full range is $-40^\circ C$ to $105^\circ C$.

5.26 TLE2144I Operating Characteristics, $V_{CC\pm} = \pm 15V$, $T_A = 25^\circ C$

PARAMETER	TEST CONDITIONS	TLE2144I			TLE2144AI			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	
SR+	Positive slew rate	$A_{VD} = -1$, $R_L = 2k\Omega$, $C_L = 500pF$			27 ⁽¹⁾	45		V/ μs
SR-	Negative slew rate				27 ⁽¹⁾	42		
t_s	Settling time	$A_{VD} = -1$, 10V step	To 0.1%	0.43		0.43		μs
			To 0.01%	0.64		0.64		
V_n	Equivalent input noise voltage	$R_S = 20\Omega$, $f = 10Hz$				15		nV/ $\sqrt{Hz}$
		$R_S = 20\Omega$, $f = 1kHz$				10.5		
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	$f = 0.1Hz$ to 1Hz				0.48		μV
		$f = 0.1Hz$ to 10Hz				0.51		
I_n	Equivalent input noise current	$f = 10Hz$				1.89		pA/ $\sqrt{Hz}$
		$f = 1kHz$				0.47		
THD + N	Total harmonic distortion plus noise	$V_{O(PP)} = 20V$, $R_L = 2k\Omega$, $A_{VD} = 10$, $f = 10kHz$				0.06%		
B_1	Unity-gain bandwidth	$R_L = 2k\Omega$, $C_L = 100pF$				6		MHz
	Gain-bandwidth product	$R_L = 2k\Omega$, $C_L = 100pF$, $f = 100kHz$				5.9		MHz
B_{OM}	Maximum output-swing bandwidth ⁽²⁾	$V_{O(PP)} = 20V$, $R_L = 2k\Omega$, $A_{VD} = 1$, $C_L = 100pF$				668		kHz
ϕ_m	Phase margin at unity gain	$R_L = 2k\Omega$, $C_L = 100pF$				58°		

(1) Specified by characterization.

(2) Measured at -0.1dB.

5.27 TLE2144I Electrical Characteristics

at specified free-air temperature, $V_{CC} = 5V$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A ⁽¹⁾	TLE2141M			TLE2141AM			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_O = 2.5V$, $R_S = 50\Omega$, $V_O = 2.5V$	25°C		225	1400		200	1000	μV
		Full range			2100			1700	
α_{VIO} Temperature coefficient of input offset voltage		Full range		1.7			1.7		$\mu V/^{\circ}C$
I_{IO} Input offset current		25°C		8	100		8	100	nA
		Full range			250			250	
I_{IB} Input bias current		25°C		–0.8	–2		–0.8	–2	μA
		Full range			–2.3			–2.3	
V_{ICR} Common-mode input voltage range	$R_S = 50\Omega$	25°C	0 to 3	–0.3 to 3.2		0 to 3	–0.3 to 3.2		V
		Full range	0 to 2.7	–0.3 to 2.9		0 to 2.7	–0.3 to 2.9		V
V_{OH} High-level output voltage	$I_{OH} = -150\mu A$	25°C	3.9	4.1		3.9	4.1		V
	$I_{OH} = -1.5mA$		3.8	4		3.8	4		
	$I_{OH} = -15mA$		3.2	3.7		3.2	3.7		
	$I_{OH} = -100\mu A$	Full range	3.75			3.75			V
	$I_{OH} = -1mA$		3.65			3.65			
	$I_{OH} = -10mA$		3.25			3.25			
V_{OL} Low-level output voltage	$I_{OL} = 150\mu A$	25°C		75	125		75	125	mV
	$I_{OL} = 1.5mA$			150	225		150	225	
	$I_{OL} = 15mA$			1.2	1.4		1.2	1.4	
	$I_{OL} = 100\mu A$	Full range			200			200	mV
	$I_{OL} = 1mA$				250			225	
	$I_{OL} = 10mA$				1.25			1.25	
A_{VD} Large-signal differential voltage amplification	$V_{CC} = \pm 2.5V$, $R_L = 2k\Omega$, $V_O = 1V$ to $-1.5V$	25°C	50	220		50	220		V/mV
		Full range	5			5			
r_i Input resistance		25°C		70			70		M Ω
c_i Input capacitance		25°C		2.5			2.5		pF
z_o Open-loop output impedance	$f = 1MHz$	25°C		30			30		Ω
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICRmin}$, $R_S = 50\Omega$	25°C	85	118		85	118		dB
		Full range	80			80			
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{CC\pm} / \Delta V_{IO}$)	$V_{CC\pm} = \pm 2.5V$ to $\pm 15V$, $R_S = 50\Omega$	25°C	90	106		90	106		dB
		Full range	85			85			
I_{CC} Supply current	$V_O = 2.5V$, No load, $V_{IC} = 2.5V$	25°C		3.4	4.4		3.4	4.4	mA
		Full range			4.6			4.6	

(1) Full range is $-55^{\circ}C$ to $125^{\circ}C$.

5.28 TLE2141M Operating Characteristics, $V_{CC} = 5V$, $T_A = 25^\circ C$

PARAMETER		TEST CONDITIONS		TLE2141M			TLE2141AM			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
SR+	Positive slew rate	$A_{VD} = -1$, $R_L = 2k\Omega$, ⁽¹⁾ $C_L = 500pF$ ⁽¹⁾		45			45			V/ μs
SR-	Negative slew rate			42			42			
t_s	Settling time	$A_{VD} = -1$, 2.5V step	To 0.1%	0.66			0.66			μs
			To 0.01%	0.99			0.99			
V_n	Equivalent input noise voltage	$R_S = 20\Omega$, $f = 10Hz$		15			15			nV/ $\sqrt{Hz}$
		$R_S = 20\Omega$, $f = 1kHz$		10.5			10.5			
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	$f = 0.1Hz$ to 1Hz		0.48			0.48			μV
		$f = 0.1Hz$ to 10Hz		0.51			0.51			
I_n	Equivalent input noise current	$f = 10Hz$		1.92			1.92			pA/ $\sqrt{Hz}$
		$f = 1kHz$		0.5			0.5			
THD + N	Total harmonic distortion plus noise	$V_O = 1V$ to 3V , $R_L = 2k\Omega$, ⁽¹⁾ $A_{VD} = 2$, $f = 10kHz$		0.0052%			0.0052%			
B_1	Unity-gain bandwidth	$R_L = 2k\Omega$ ⁽¹⁾ , $C_L = 100pF$ ⁽¹⁾		5.9			5.9			MHz
	Gain-bandwidth product	$R_L = 2k\Omega$ ⁽¹⁾ , $C_L = 100pF$, ⁽¹⁾ $f = 100kHz$		5.8			5.8			MHz
B_{OM}	Maximum output-swing bandwidth ⁽²⁾	$V_{O(PP)} = 2V$, $R_L = 2k\Omega$, ⁽¹⁾ $A_{VD} = 1$, $C_L = 100pF$ ⁽¹⁾		380			380			kHz
ϕ_m	Phase margin at unity gain	$R_L = 2k\Omega$ ⁽¹⁾ , $C_L = 100pF$ ⁽¹⁾		57°			57°			

(1) R_L and C_L terminated to 2.5V.

(2) Measured at -0.1dB.

5.29 TLE2141M Electrical Characteristics

at specified free-air temperature, $V_{CC\pm} = \pm 15V$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T _A ⁽¹⁾	TLE2141M			TLE2141AM			UNIT
					MIN	TYP	MAX	MIN	TYP	MAX	
V _{IO}	Input offset voltage	V _{IC} = 0, R _S = 50Ω		25°C	200	900	175	500	μV		
	Full range			1700			1200				
α _{VIO}	Temperature coefficient of input offset voltage			Full range	1.7			1.7		μV/°C	
I _{IO}	Input offset current			25°C	7	100	7	100	nA		
				Full range	250			250			
I _{IB}	Input bias current			25°C	−0.7	−1.5	−0.7	−1.5	μA		
				Full range	−1.8			−1.8			
V _{ICR}	Common-mode input voltage range	R _S = 50Ω	25°C	−15 to 13	−15.3 to 13.2	−15 to 13	−15.3 to 13.2	V			
			Full range	−15 to 12.7	15.3 to 12.9	−15 to 12.7	−15.3 to 12.9	V			
V _{OM+}	Maximum positive peak output voltage swing	I _O = −150μA	25°C	13.8	14.1	13.8	14.1	V			
		I _O = −1.5mA		13.7	14	13.7	14				
		I _O = −15mA		13.1	13.7	13.1	13.7				
		I _O = −100μA	Full range	13.7		13.7		V			
		I _O = −1mA		13.6		13.6					
		I _O = −10mA		13.1		13.1					
V _{OM−}	Maximum negative peak output voltage swing	I _O = 150μA	25°C	−14.7	−14.9	−14.7	−14.9	V			
		I _O = 1.5mA		−14.5	−14.8	−14.5	−14.8				
		I _O = 15mA		−13.4	−13.8	−13.4	−13.8				
		I _O = 100μA	Full range	−14.6		−14.6		V			
		I _O = 1mA		−14.5		−14.5					
		I _O = 10mA		−13.4		−13.4					
A _{VD}	Large-signal differential voltage amplification	V _O = ±10V, R _L = 2kΩ	25°C	100	450	100	450	V/mV			
			Full range	20		20					
r _i	Input resistance			25°C	65		65		MΩ		
c _i	Input capacitance			25°C	2.5		2.5		pF		
Z _o	Open-loop output impedance	f = 1MHz		25°C	30		30		Ω		
CMRR	Common-mode rejection ratio	V _{IC} = V _{ICRmin} , R _S = 50Ω		25°C	85	108	85	108	dB		
				Full range	80		80				
k _{SVR}	Supply-voltage rejection ratio (ΔV _{CC±} /ΔV _{IO})	V _{CC±} = ±2.5V to ±15V , R _S = 50Ω		25°C	90	106	90	106	dB		
				Full range	85		85				
I _{OS}	Short circuit output current	V _O = 0	V _{ID} = 1V	25°C	−25	−50	−25	−50	mA		
					V _{ID} = −1V	20	31	20			31
I _{CC}	Supply current	V _O = 0V, V _{IC} = 2.5V , No load		25°C		3.5	4.5	3.5	4.5	mA	
				Full range	4.7		4.7				

(1) Full range is $-55^\circ C$ to $125^\circ C$.

5.30 TLE2141M Operating Characteristics, $V_{CC\pm} = \pm 15V$, $T_A = 25^\circ C$

PARAMETER		TEST CONDITIONS		TLE2141M			TLE2141AM			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
SR+	Positive slew rate	$A_{VD} = -1$, $R_L = 2k\Omega$, $C_L = 100pF$		27 ⁽¹⁾	45		27 ⁽¹⁾	45		V/ μs
SR–	Negative slew rate			27 ⁽¹⁾	42		27 ⁽¹⁾	42		
t_s	Settling time	$A_{VD} = -1$, 10V step	To 0.1%	0.43			0.43			μs
			To 0.01%	0.64			0.64			
V_n	Equivalent input noise voltage	$R_S = 20\Omega$, $f = 10Hz$		15			15			nV/ $\sqrt{Hz}$
		$R_S = 20\Omega$, $f = 1kHz$		10.5			10.5			
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	$f = 0.1Hz$ to 1Hz		0.48			0.48			μV
		$f = 0.1Hz$ to 10Hz		0.51			0.51			
I_n	Equivalent input noise current	$f = 10Hz$		1.89			1.89			pA/ $\sqrt{Hz}$
		$f = 1kHz$		0.47			0.47			
THD + N	Total harmonic distortion plus noise	$V_{O(PP)} = 20V$, $R_L = 2k\Omega$, $A_{VD} = 10$, $f = 10kHz$		0.06%			0.06%			
B_1	Unity-gain bandwidth	$R_L = 2k\Omega$, $C_L = 100pF$		6			6			MHz
	Gain-bandwidth product	$R_L = 2k\Omega$, $C_L = 100pF$, $f = 100kHz$		5.9			5.9			MHz
B_{OM}	Maximum output-swing bandwidth ⁽²⁾	$V_{O(PP)} = 20V$, $R_L = 2k\Omega$, $A_{VD} = 1$, $C_L = 100pF$		668			668			kHz
ϕ_m	Phase margin at unity gain	$R_L = 2k\Omega$, $C_L = 100pF$		58°			58°			

(1) Specified by characterization.

(2) Measured at -0.1dB.

5.31 TLE2142M Electrical Characteristics

at specified free-air temperature, $V_{CC} = 5V$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T _A ⁽¹⁾	TLE2142M			TLE2142AM			UNIT
					MIN	TYP	MAX	MIN	TYP	MAX	
V _{IO}	Input offset voltage	V _{IC} = 0, R _S = 50Ω		25°C	220	1900	200	1500	μV		
	Full range			2600			2200				
α _{VIO}	Temperature coefficient of input offset voltage			Full range	1.7			1.7		μV/°C	
I _{IO}	Input offset current			25°C	8	100	8	100	nA		
				Full range	200			200			
I _{IB}	Input bias current			25°C	−0.8	−2	−0.8	−2	μA		
				Full range	−2.3			−2.3			
V _{ICR}	Common-mode input voltage range	R _S = 50Ω	25°C	0 to 3	−0.3 to 3.2	0 to 3	−0.3 to 3.2	V			
			Full range	0 to 2.7	−0.3 to 2.9	0 to 2.7	−0.3 to 2.9	V			
V _{OM+}	Maximum positive peak output voltage swing	I _O = −150μA	25°C	3.9	4.1	3.9	4.1	V			
		I _O = −1.5mA		3.8	4	3.8	4				
		I _O = −15mA		3.4	3.7	3.4	3.7				
		I _O = 100μA	Full range	3.75		3.75		V			
		I _O = 1mA		3.65		3.65					
		I _O = 10mA		3.45		3.45					
V _{OM−}	Maximum negative peak output voltage swing	I _O = 150μA	25°C	75	125	75	125	mV			
		I _O = 1.5mA		150	225	150	225				
		I _O = 15mA		1.2	1.4	1.2	1.4				
		I _O = 100μA	Full range	200		200		mV			
		I _O = 1mA		250		250					
		I _O = 10mA		125		125					
A _{VD}	Large-signal differential voltage amplification	V _{IC} = ±2.5V , R _L = 2kΩ, V _O = 1V to −1.5V		25°C	50	220	50	220	V/mV		
				Full range	5		5				
r _i	Input resistance			25°C	70			70			MΩ
c _i	Input capacitance			25°C	2.5			2.5			pF
Z _o	Open-loop output impedance	f = 1MHz		25°C	30			30			Ω
CMRR	Common-mode rejection ratio	V _{IC} = V _{ICRmin} , R _S = 50Ω		25°C	85	118	85	118	dB		
				Full range	80		80				
k _{SVR}	Supply-voltage rejection ratio (ΔV _{CC±} / ΔV _{IO})	V _{CC±} = ±2.5V to ±15V , R _S = 50Ω		25°C	90	106	90	106	dB		
				Full range	85		85				
I _{OS}	Short circuit output current	V _O = 0	V _{ID} = 1V	25°C	−25	−50	−25	−50	mA		
					V _{ID} = −1V	20	31	20			31
I _{CC}	Supply current	V _O = 0V, V _{IC} = 2.5V , No load		25°C		6.6	8.8	6.6	8.8	mA	
				Full range	9.2			9.2			

(1) Full range is –55°C to 125°C.

5.32 TLE2142M Operating Characteristics, $V_{CC} = 5V$, $T_A = 25^\circ C$

PARAMETER		TEST CONDITIONS		TLE2142M			TLE2142AM			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
SR+	Positive slew rate	A _{VD} = - 1, R _L = 2kΩ ⁽¹⁾ , C _L = 500pF		45			45			V/μs
SR–	Negative slew rate			42			42			
t _s	Settling time	A _{VD} = -1, 10V step	To 0.1%	0.66			0.66			μs
			To 0.01%	0.99			0.99			
V _n	Equivalent input noise voltage	R _S = 20Ω, f = 10Hz		15			15			nV/√ Hz
		R _S = 20Ω, f = 1kHz		10.5			10.5			
V _{N(PP)}	Peak-to-peak equivalent input noise voltage	f = 0.1Hz to 1Hz		0.48			0.48			μV
		f = 0.1Hz to 10Hz		0.51			0.51			
I _n	Equivalent input noise current	f = 10Hz		1.92			1.92			pA/√ Hz
		f = 1kHz		0.5			0.5			
THD + N	Total harmonic distortion plus noise	V _O = 1V to 3V , R _L = 2kΩ ⁽¹⁾ , A _{VD} = 2, f = 10kHz		0.0052%			0.0052 %			
B ₁	Unity-gain bandwidth	R _L = 2kΩ ⁽¹⁾ , C _L = 100pF		5.9			5.9			MHz
	Gain-bandwidth product	R _L = 2kΩ ⁽¹⁾ , C _L = 100pF, f = 100kHz		5.8			5.8			MHz
B _{OM}	Maximum output-swing bandwidth ⁽²⁾	V _{O(PP)} = 2V , R _L = 2kΩ ⁽¹⁾ , A _{VD} = 1, C _L = 100pF		380			380			kHz
φ _m	Phase margin at unity gain	R _L = 2kΩ ⁽¹⁾ , C _L = 100pF		57°			57°			

(1) R_L terminates at 2.5V .

(2) Measured at -0.1dB.

5.33 TLE2142M Electrical Characteristics

at specified free-air temperature, $V_{CC\pm} = \pm 15V$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T _A ⁽¹⁾	TLE2142M			TLE2142AM			UNIT
					MIN	TYP	MAX	MIN	TYP	MAX	
V _{IO}	Input offset voltage	V _{IC} = 0, R _S = 50Ω		25°C	290	1200	275	750	μV		
	Full range			2000			1600				
α _{VIO}	Temperature coefficient of input offset voltage			Full range	1.7			1.7		μV/°C	
I _{IO}	Input offset current			25°C	7	100	7	100	nA		
				Full range	250			250			
I _{IB}	Input bias current			25°C	−0.7	−1.5	−0.7	−1.5	μA		
				Full range	−1.8			−1.8			
V _{ICR}	Common-mode input voltage range	R _S = 50Ω		25°C	−15 to 13	−15.3 to 13.2	−15 to 13	−15.3 to 13.2	V		
				Full range	−15 to 12.7	−15.3 to 12.9	−15 to 12.7	−15.3 to 12.9	V		
V _{OM+}	Maximum positive peak output voltage swing	I _O = −150μA	I _O = −1.5mA	25°C	13.8	14.1	13.8	14.1	V		
						13.7	14	13.7			14
						13.3	13.7	13.3			13.7
		I _O = −15mA	I _O = −100μA	Full range	13.7		13.7		V		
						13.6		13.6			
						13.3		13.3			
V _{OM−}	Maximum negative peak output voltage swing	I _O = 150μA	I _O = 1.5mA	25°C	−14.7	−14.9			V		
						−14.5	−14.8				
						−13.4	−13.8				
		I _O = 15mA	I _O = 100μA	Full range	−14.6		−14.6		V		
						−14.5		−14.5			
						−13.4		−13.4			
A _{VD}	Large-signal differential voltage amplification	V _O = ±10V, R _L = 2kΩ,		25°C	100	450	100	450	V/mV		
				Full range	20		20				
r _i	Input resistance			25°C	65			65		MΩ	
c _i	Input capacitance			25°C	2.5			2.5		pF	
Z _o	Open-loop output impedance	f = 1MHz		25°C	30			30		Ω	
CMRR	Common-mode rejection ratio	V _{IC} = V _{ICRmin} , R _S = 50Ω		25°C	85	108	85	108	dB		
				Full range	80		80				
k _{SVR}	Supply-voltage rejection ratio (ΔV _{CC±} / ΔV _{IO})	V _{CC±} = ±2.5V to ±15V , R _S = 50Ω		25°C	90	106	90	106	dB		
				Full range	85		85				
I _{OS}	Short circuit output current	V _O = 0	V _{ID} = 1V	25°C	−25	−50	−25	−50	mA		
					V _{ID} = −1V	20	31	20			31
I _{CC}	Supply current	V _O = 0V, V _{IC} = 2.5V , No load		25°C	6.9	9	6.9	9	mA		
				Full range	9.4			9.4			

(1) Full range is $-55^\circ C$ to $125^\circ C$.

5.34 TLE2142M Operating Characteristics, $V_{CC\pm} = \pm 15V$, $T_A = 25^\circ C$

PARAMETER		TEST CONDITIONS		TLE2142M			TLE2142AM			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
SR+	Positive slew rate	A _{VD} = - 1, R _L = 2kΩ, C _L = 100pF		27 ⁽¹⁾	45		27 ^s	45		V/μs
SR–	Negative slew rate			27 ⁽¹⁾	42		27 ^s	42		
t _s	Settling time	A _{VD} = -1, 10V step	To 0.1%	0.43			0.43			μs
			To 0.01%	0.64			0.64			
V _n	Equivalent input noise voltage	R _S = 20Ω, f = 10Hz		15			15			nV/√ Hz
		R _S = 20Ω, f = 1kHz		10.5			10.5			
V _{N(PP)}	Peak-to-peak equivalent input noise voltage	f = 0.1Hz to 1Hz		0.48			0.48			μV
		f = 0.1Hz to 10Hz		0.51			0.51			
I _n	Equivalent input noise current	f = 10Hz		1.89			1.89			pA/√ Hz
		f = 1kHz		0.47			0.47			
THD + N	Total harmonic distortion plus noise	V _{O(PP)} = 20V, R _L = 2kΩ, A _{VD} = 2, f = 10kHz		0.06%			0.06%			
B ₁	Unity-gain bandwidth	R _L = 2kΩ, C _L = 100pF		6			6			MHz
	Gain-bandwidth product	R _L = 2kΩ, C _L = 100pF, f = 100kHz		5.9			5.9			MHz
B _{OM}	Maximum output-swing bandwidth ⁽²⁾	V _{O(PP)} = 2V , R _L = 2kΩ, A _{VD} = 1, C _L = 100pF		668			668			kHz
φ _m	Phase margin at unity gain	R _L = 2kΩ, C _L = 100pF		58°			58°			

(1) Specified by characterization.

(2) Measured at -0.1dB.

5.35 TLE2144M Electrical Characteristics

at specified free-air temperature, $V_{CC} = 5V$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T _A ⁽¹⁾	TLE2144M			TLE2144AM			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
V _{IO}	Input offset voltage	V _O = 2.5V , R _S = 50Ω, V _{IC} = 2.5V	25°C	0.5 3.8		0.5 3			mV	
			Full range	5.2		4.4				
α _{VIO}	Temperature coefficient of input offset voltage		Full range	1.7		1.7			μV/°C	
			25°C	8 100		8 100				
I _{IO}	Input offset current		Full range	250		250			nA	
			25°C	8	−0.	−2	−0.8	−2		
I _{IB}	Input bias current		Full range	−2.3		−2.3			μA	
V _{ICR}	Common-mode input voltage range	R _S = 50Ω	25°C	0 to 3	−0.3 to 3.2	0 to 3	−0.3 to 3.2	V		
			Full range	0 to 2.7	−0.3 to 2.9	0 to 2.7	−0.3 to 2.9	V		
V _{OH}	High-level output voltage	I _{OH} = −150μA	25°C	3.9	4.1	3.9	4.1	V		
		I _{OH} = −1.5mA		3.8	4	3.8	4			
		I _{OH} = −15mA		3.4	3.7	3.4	3.7			
		I _{OH} = 100μA	Full range	3.75		3.75				
		I _{OH} = 1mA		3.65		3.65				
		I _{OH} = 10mA		3.45		3.45				
V _{OL}	Low level output voltage	I _{OL} = 150μA	25°C	75	125	75	125			
		I _{OL} = 1.5μA		150	225	150	225	mV		
		I _{OL} = 15mA		1.2	1.6	1.2	1.6	V		
		I _{OL} = 100μA	Full range	200		200		mV		
		I _{OL} = 1mA		250		250				
		I _{OL} = 10mA		1.45		1.45		V		
A _{VD}	Large-signal differential voltage amplification	V _{IC} = ±2.5V , R _L = 2kΩ, V _O = 1V to −1.5V	25°C	50	95	50	95	V/mV		
			Full range	5		5				
r _i	Input resistance		25°C	70		70		MΩ		
c _i	Input capacitance		25°C	2.5		2.5		pF		
Z _o	Open-loop output impedance	f = 1MHz	25°C	30		30		Ω		
CMR R	Common-mode rejection ratio	V _{IC} = V _{ICRmin} , R _S = 50Ω	25°C	85	118	85	118	dB		
			Full range	80		80				
k _{SVR}	Supply-voltage rejection ratio (ΔV _{CC} ± /ΔV _{IO})	V _{CC} ± = ± 2.5V to ± 15V , R _S = 50Ω	25°C	90	106	90	106	dB		
			Full range	85		85				
I _{CC}	Supply current	V _O = 2.5V , No load, V _{IC} = 2.5V	25°C	13.2	17.6	13.2	17.6	mA		
			Full range	18.4		18.4				

(1) Full range is $-55^\circ C$ to $125^\circ C$.

5.36 TLE2144M Operating Characteristics

$V_{CC} = 5V$, $T_A = 25^\circ C$

PARAMETER		TEST CONDITIONS		TLE2144M			TLE2144AM			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
SR+	Positive slew rate	$A_{VD} = -1$, $R_L = 2k\Omega^{(1)}$, $C_L = 500pF$		45			45			V/ μs
SR-	Negative slew rate			42			42			
t_s	Settling time	$A_{VD} = -1$, 2.5V step	To 0.1%	0.66			0.66			μs
			To 0.01%	0.99			0.99			
		$R_S = 20\Omega$, $f = 10Hz$		15			15			nV/ $\sqrt{Hz}$
V_n	Equivalent input noise voltage	$R_S = 20\Omega$, $f = 1kHz$		10.5			10.5			
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	$f = 0.1Hz$ to $1Hz$		0.48			0.48			μV
		$f = 0.1Hz$ to $10Hz$		0.51			0.51			
I_n	Equivalent input noise current	$f = 10Hz$		1.92			1.92			pA/ $\sqrt{Hz}$
		$f = 1kHz$		0.5			0.5			
THD + N	Total harmonic distortion plus noise	$V_O = 1V$ to $3V$, $R_L = 2k\Omega^{(1)}$, $A_{VD} = 2$, $f = 10kHz$		0.0052%			0.0052%			
B_1	Unity-gain bandwidth	$R_L = 2k\Omega^{(1)}$, $C_L = 100pF$		5.9			5.9			MHz
Gain-bandwidth product		$R_L = 2k\Omega^{(1)}$, $C_L = 100pF$, $f = 100kHz$		5.8			5.8			MHz
B_{OM}	Maximum output-swing bandwidth ⁽²⁾	$V_{O(PP)} = 2V$, $R_L = 2k\Omega^{(1)}$, $A_{VD} = 1$		380			380			kHz
φ_m	Phase margin	$R_L = 2k\Omega^{(1)}$ ⁽¹⁾ , $C_L = 100pF$		57°			57°			

(1) R_L terminates at 2.5V.

(2) Measured at -0.1dB.

5.37 TLE2144M Electrical Characteristics

at specified free-air temperature, $V_{CC\pm} = \pm 15V$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A ⁽¹⁾	TLE2144M			TLE2144AM			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_{IC} = 0, R_S = 50\Omega$	25°C		0.6	2.4		0.5	1.5	mV
		Full range			4			3.2	
α_{VIO} Temperature coefficient of input offset voltage		Full range		1.7			1.7		$\mu V/^\circ C$
		25°C		7	100		7	100	nA
I_{IO} Input offset current		Full range			250			250	
		25°C		-0.7	-1.5		-0.7	-1.5	
I_{IB} Input bias current		Full range			-1.8			-1.8	μA
V_{ICR} Common-mode input voltage range	$R_S = 50\Omega$	25°C	-15 to 13	-15.3 to 13.2		-15 to 13	-15.3 to 13.2		V
		Full range	-15 to 12.7	-15.3 to 12.9		-15 to 12.7	-15.3 to 12.9		
V_{OM+} Maximum positive peak output voltage swing	$I_O = -150\mu A$	25°C	13.8	14.1		13.8	14.1		V
	$I_O = -1.5mA$		13.7	14		13.7	14		
	$I_O = -15mA$		13.1	13.7		13.1	13.7		
	$I_O = -100\mu A$	Full range	13.7			13.7			
	$I_O = -1mA$		13.6			13.6			
	$I_O = -10mA$		13.1			13.1			
V_{OM-} Maximum negative peak output voltage swing	$I_O = 150\mu A$	25°C	-14.7	-14.9		-14.7	-14.9		V
	$I_O = 1.5mA$		-14.5	-14.8		-14.5	-14.8		
	$I_O = 15mA$		-13.4	-13.8		-13.4	-13.8		
	$I_O = 100\mu A$	Full range	-14.6			-14.6			
	$I_O = 1mA$		-14.5			-14.5			
	$I_O = 10mA$		-13.4			-13.4			
A_{VD} Large-signal differential voltage amplification	$V_O = \pm 10V, R_L = 2k\Omega$	25°C	100	170		100	170		V/mV
		Full range	20			20			
r_i Input resistance		25°C	65			65			M Ω
c_i Input capacitance		25°C	2.5			2.5			pF
z_o Open-loop output impedance	$f = 1MHz$	25°C	30			30			Ω
CMR R Common-mode rejection ratio	$V_{IC} = V_{ICRmin}, R_S = 50\Omega$	25°C	85	108		85	108		dB
		Full range	80			80			
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{CC} \pm / \Delta V_{IO}$)	$V_{CC\pm} = \pm 2.5V$ to $\pm 15V, R_S = 50\Omega$	25°C	90	106		90	106		dB
		Full range	85			85			
I_{OS} Short circuit output current	$V_O = 0$	25°C	-25	-50		-25	-50		mA
			20	31		20	31		
I_{CC} Supply current	$V_O = 0, \text{No load}, V_{IC} = 2.5V$	25°C	13.8	18		13.8	18		mA
		Full range	18.8			18.8			

(1) Full range is -55°C to 125°C

5.38 TLE2144M Operating Characteristics

$V_{CC\pm} = \pm 15V$, $T_A = 25^\circ C$

PARAMETER		TEST CONDITIONS		TLE2144M			TLE2144AM			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
SR+	Positive slew rate	$R_L = 2k\Omega$, $A_{VD} = -1$, $C_L = 100pF$		27 ⁽¹⁾	45		27 ⁽¹⁾	45		V/ μs
SR-	Negative slew rate			27 ⁽¹⁾	42		27 ⁽¹⁾	42		
t_s	Settling time	$A_{VD} = -1$, 10V step	To 0.1%	0.43		0.43		μs		
			To 0.01%	0.64		0.64				
V_n	Equivalent input noise voltage	$R_S = 20\Omega$, $f = 10Hz$		15		15		nV/ $\sqrt{Hz}$		
		$R_S = 20\Omega$, $f = 1kHz$		10.5		10.5				
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	$f = 0.1Hz$ to 1Hz		0.48		0.48		μV		
		$f = 0.1Hz$ to 10Hz		0.51		0.51				
I_n	Equivalent input noise current	$f = 10Hz$		1.89		1.89		pA/ $\sqrt{Hz}$		
		$f = 10kHz$		0.47		0.47				
THD+N	Total harmonic distortion plus noise	$V_{O(PP)} = 20V$, $R_L = 2k\Omega$, $A_{VD} = 10$, $f = 10kHz$		0.06%		0.06%				
B_1	Unity-gain bandwidth	$R_L = 2k\Omega$, $C_L = 100pF$		6		6		MHz		
	Gain-bandwidth product	$R_L = 2k\Omega$, $C_L = 100pF$, $f = 100kHz$		5.9		5.9		MHz		
B_{OM}	Maximum output-swing bandwidth ⁽²⁾	$V_{O(PP)} = 20V$, $R_L = 2k\Omega$, $A_{VD} = 1$, $C_L = 100pF$		668		668		kHz		
ϕ_m	Phase margin at unity gain	$R_L = 2k\Omega$, $C_L = 100pF$		58°		58°				

(1) Specified by characterization.

(2) Measured at -0.1dB.

5.39 TLE2141Y Electrical Characteristics

at specified free-air temperature, $V_{CC\pm} = \pm 15V$, $T_A = 25^\circ C$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	TLE2141Y			UNIT
		MIN	TYP	MAX	
V_{IO} Input offset voltage			200	1000	μV
I_{IO} Input offset current	$V_{IC} = 0$, $R_S = 50\Omega$, $V_O = 0$		7	100	nA
I_{IB} Input bias current			-0.7	-1.5	μA
V_{ICR} Common-mode input voltage range	$R_S = 50\Omega$	-15 to 13	-15.3 to 13.2		V
V_{OM+} Maximum positive peak output voltage swing	$I_O = -150\mu A$	13.8	14.1		V
	$I_O = -1.5mA$	13.7	14		
	$I_O = -15mA$	13.3	13.7		
V_{OM-} Maximum negative peak output voltage swing	$I_O = 150\mu A$	-14.7	-14.9		V
	$I_O = 1.5mA$	-14.5	-14.8		
	$I_O = 15mA$	-13.4	-13.8		
A_{VD} Large-signal differential voltage amplification	$V_O = \pm 10V$, $R_L = 2k\Omega$	100	450		V/mV
r_i Input resistance			65		M Ω
c_i Input capacitance			2.5		pF
z_o Open-loop output impedance	$f = 1MHz$		30		Ω
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICRmin}$, $R_S = 50\Omega$	80	108		dB
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{CC} \pm / \Delta V_{IO}$)	$V_{CC\pm} = \pm 2.5V$ to $\pm 15V$, $R_S = 50\Omega$	85	106		dB
I_{OS} Short-circuit output current	$V_O = 0$	$V_{ID} = 1V$		-25	mA
		$V_{ID} = -1V$		20	
I_{CC} Supply current	$V_O = 0$, No load	3.5	4.5		mA

5.40 TLE2142Y Electrical Characteristics

at specified free-air temperature, $V_{CC\pm} = \pm 15V$, $T_A = 25^\circ$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	TLE2142Y			UNIT	
			MIN	TYP	MAX		
V _{IO}	Input offset voltage		150		875	μV	
I _{IO}	Input offset current	V _{IC} = 0, R _S = 50Ω, V _O = 0	7		100	nA	
I _{IB}	Input bias current		-0.7		-1.5	μA	
V _{ICR}	Common-mode input voltage range	R _S = 50Ω	-15 to 13	-15.3 to 13.2		V	
V _{OM+}	Maximum positive peak output voltage swing	I _O = -150μA	13.8	14.1		V	
		I _O = -1.5mA	13.7	14			
		I _O = -15mA	13.3	13.7			
V _{OM-}	Maximum negative peak output voltage swing	I _O = 150μA	-14.7	-14.9		V	
		I _O = 1.5mA	-14.5	-14.8			
		I _O = 15mA	-13.4	-13.8			
A _{VD}	Large-signal differential voltage amplification	V _O = ±10V, R _L = 2kΩ	100	450		V/mV	
r _i	Input resistance		65			MΩ	
c _i	Input capacitance		2.5			pF	
z _o	Open-loop output impedance	f = 1MHz	30			Ω	
CMRR	Common-mode rejection ratio	V _{IC} = V _{ICRmin} , R _S = 50Ω	80	108		dB	
k _{SVR}	Supply-voltage rejection ratio (ΔV _{CC} ± /ΔV _{IO})	V _{CC±} = ±2.5V to ±15V , R _S = 50Ω	85	106		dB	
I _{OS}	Short-circuit output current	V _O = 0	V _{ID} = 1V		-25	-50	mA
			V _{ID} = -1V		20	31	
I _{CC}	Supply current	V _O = 0, No load	6.9		9	mA	

5.41 TLE2144Y Electrical Characteristics

at $V_{CC\pm} = \pm 15V$, $T_A = 25^\circ C$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS		TLE2144Y			UNIT
				MIN	TYP	MAX	
V _{IO}	Input offset voltage			0.3		1.8	μV
I _{IO}	Input offset current	V _{IC} = 0, R _S = 50Ω, V _O = 0		7		100	nA
I _{IB}	Input bias current			-0.7		-1.5	μA
V _{ICR}	Common-mode input voltage range	R _S = 50Ω		-15 to 13	-15.3 to 13.2		V
V _{OM+}	Maximum positive peak output voltage swing	I _O = -150μA		13.8	14.1		V
		I _O = -1.5mA		13.7	14		
		I _O = -15mA		13.3	13.7		
V _{OM-}	Maximum negative peak output voltage swing	I _O = 150μA		-14.7	-14.9		V
		I _O = 1.5mA		-14.5	-14.8		
		I _O = 15mA		-13.4	-13.8		
A _{VD}	Large-signal differential voltage amplification	V _O = ±10V, R _L = 2kΩ		100	450		V/mV
r _i	Input resistance			65			MΩ
c _i	Input capacitance			2.5			pF
z _o	Open-loop output impedance	f = 1MHz		30			Ω
CMRR	Common-mode rejection ratio	V _{IC} = V _{ICRmin} , R _S = 50Ω		80	108		dB
k _{SVR}	Supply-voltage rejection ratio (ΔV _{CC} ± /ΔV _{IO})	V _{CC±} = ±2.5V to ±15V , R _S = 50Ω		85	106		dB
I _{OS}	Short-circuit output current	V _O = 0	V _{ID} = 1V	-25	-50		mA
			V _{ID} = -1V	20	31		
I _{CC}	Supply current	V _O = 0, No load		13.8		18	mA

5.42 Typical Characteristics

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I_{IO}	Input offset current	vs Free-air temperature	4
I_{IB}	Input bias current	vs Common-mode input voltage	5
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V_{OM+}	Maximum positive peak output voltage	vs Supply voltage	7
		vs Free-air temperature	8
		vs Output current	9
		vs Settling time	11
V_{OM-}	Maximum negative peak output voltage	vs Supply voltage	7
		vs Free-air temperature	8
		vs Output current	10
		vs Settling time	11
$V_{O(PP)}$	Maximum peak-to-peak output voltage	vs Frequency	12
V_{OH}	High-level output voltage	vs Output current	13
V_{OL}	Low-level output voltage	vs Output current	14
A_{VD}	Large-signal differential voltage amplification	vs Frequency	15
		vs Free-air temperature	16
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z_o	Closed-loop output impedance	vs Frequency	17
I_{OS}	Short-circuit output current	vs Free-air temperature	18
$CMRR$	Common-mode rejection ratio	vs Frequency	19
		vs Free-air temperature	20
k_{SVR}	Supply-voltage rejection ratio	vs Frequency	21
		vs Free-air temperature	22
		vs Supply voltage	23
I_{CC}	Supply current	vs Free-air temperature	24
V_n	Equivalent input noise voltage	vs Frequency	25
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I_n	Noise current	vs Frequency	27
$THD + N$	Total harmonic distortion plus noise	vs Frequency	28
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5.42 Typical Characteristics (continued)

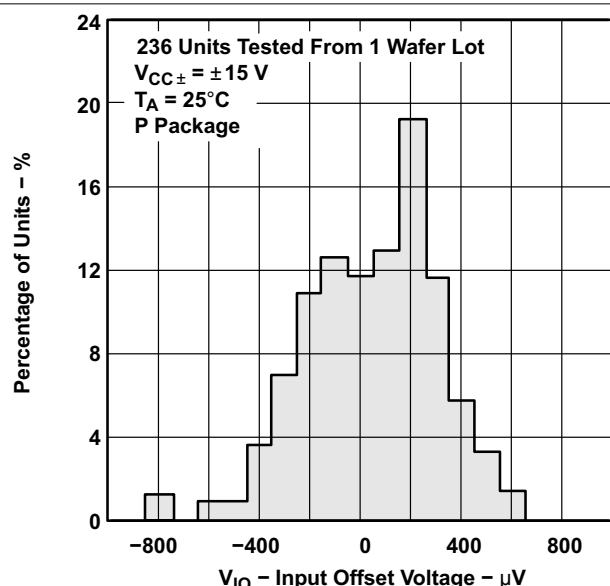


Figure 5-1. TLE2141 Distribution of Input Offset Voltage

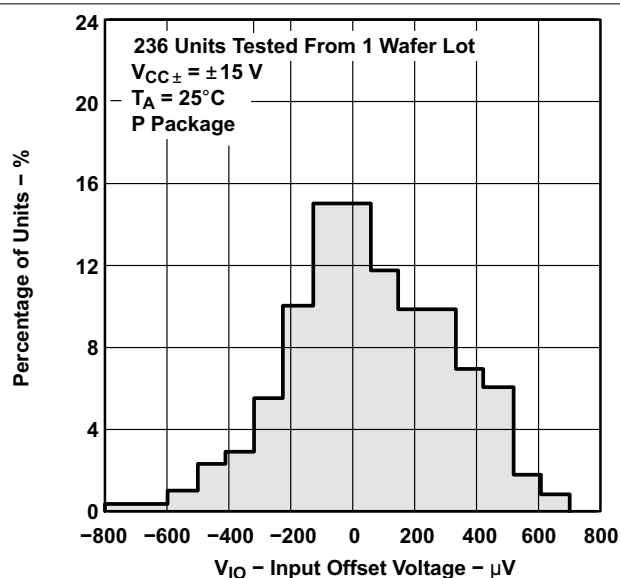
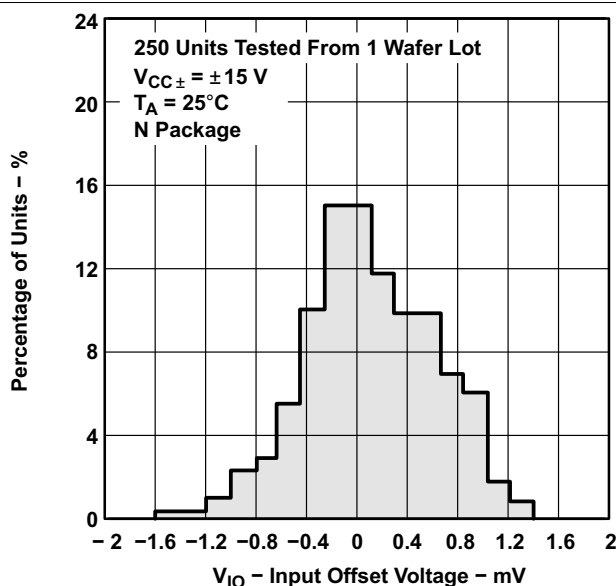
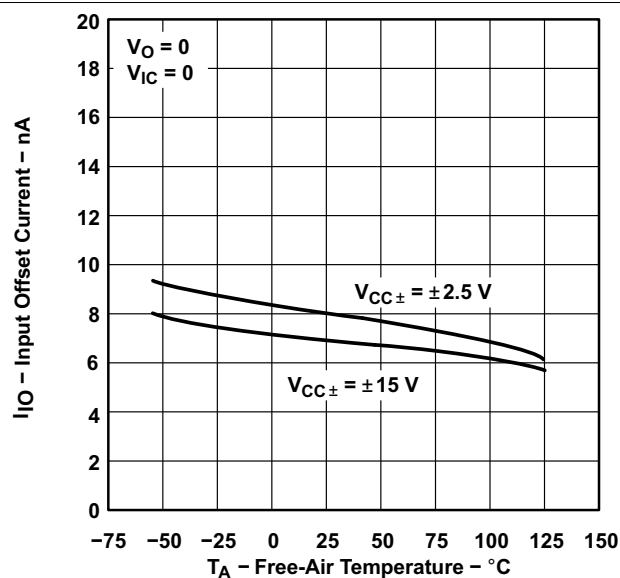


Figure 5-2. TLE2142 Distribution of Input Offset Voltage



TEST To remove kickback errors

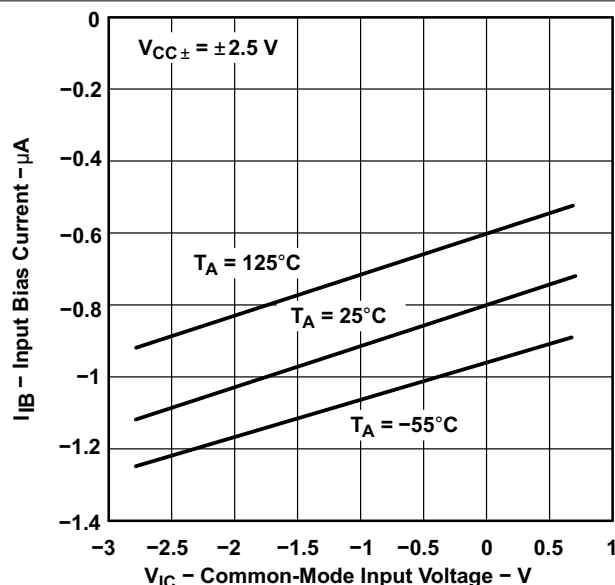
Figure 5-3. TLE2144 Distribution of Input Offset Voltage



1. Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

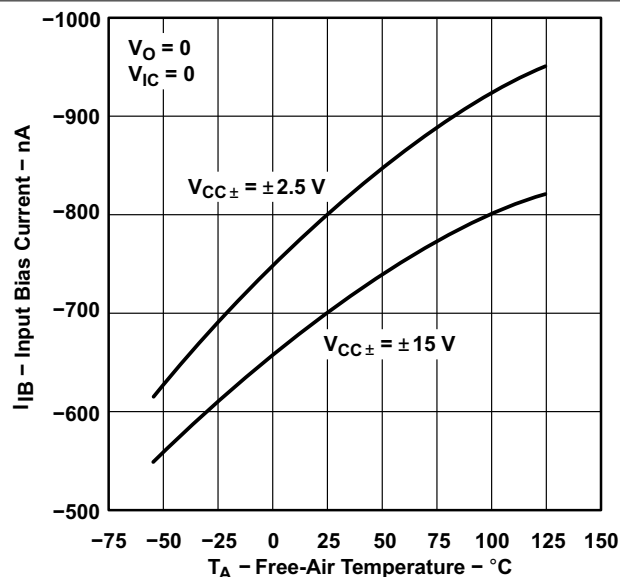
Figure 5-4. Input Offset Current⁽¹⁾ Offset Voltage

5.42 Typical Characteristics (continued)



1. Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

Figure 5-5. Input Bias Current⁽¹⁾ vs Common-Mode Input Voltage



1. Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

Figure 5-6. Input Bias Current⁽¹⁾ vs Free-Air Temperature

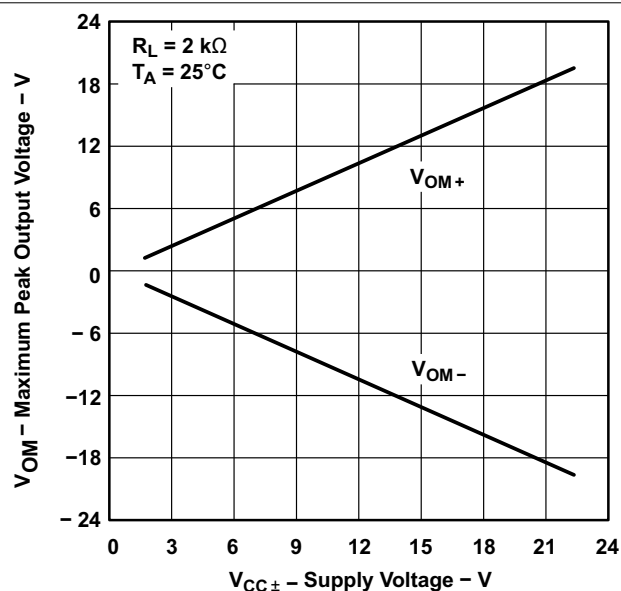


Figure 5-7. Maximum Peak Output Voltage vs Supply Voltage

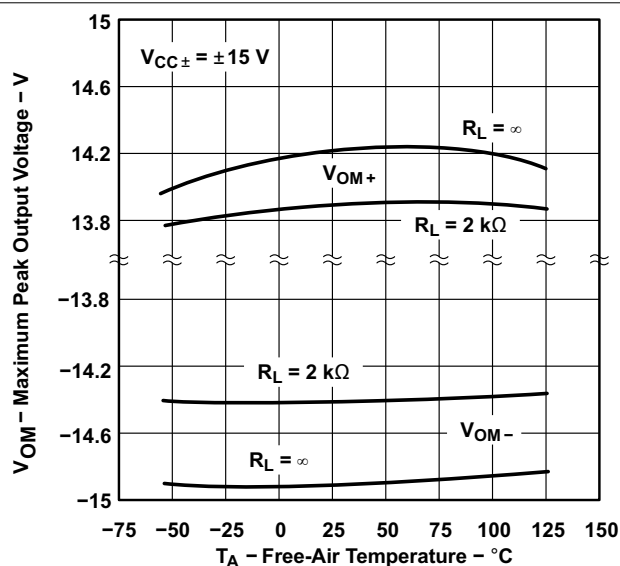
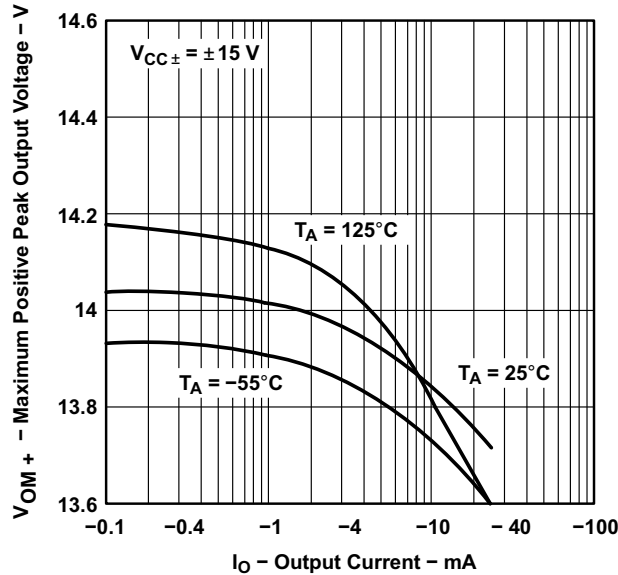


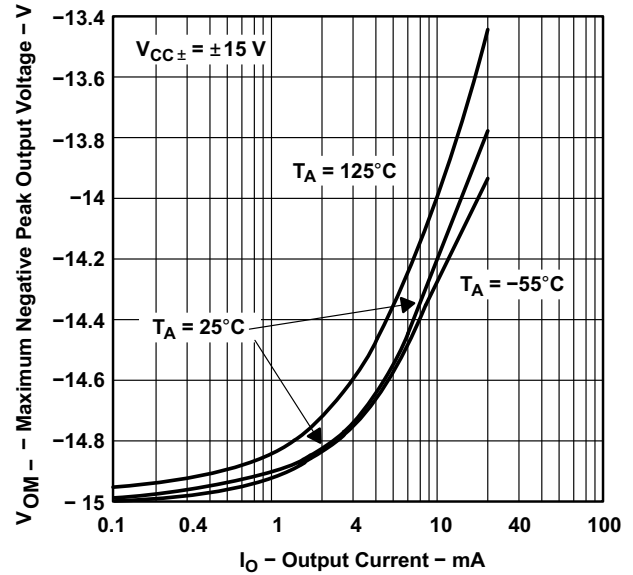
Figure 5-8. Maximum Peak Output Voltage vs Free-Air Temperature

5.42 Typical Characteristics (continued)



1. Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

Figure 5-9. Maximum Positive Peak Output Voltage⁽¹⁾ vs Output Current



1. Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

Figure 5-10. Maximum Negative Peak Output Voltage⁽¹⁾ vs Output Current

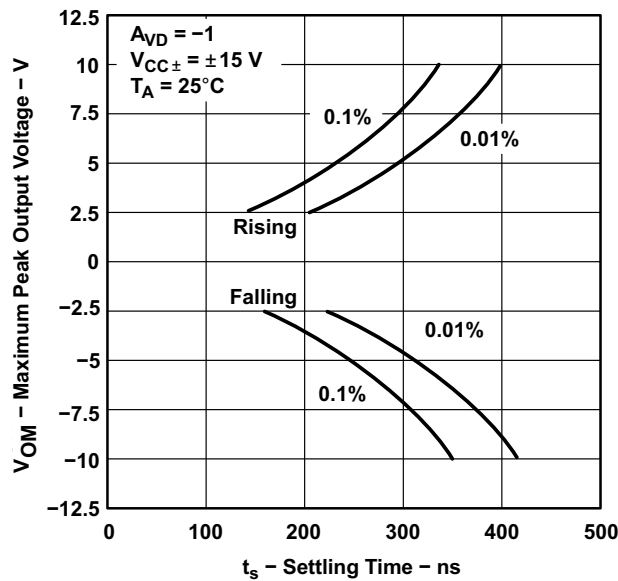
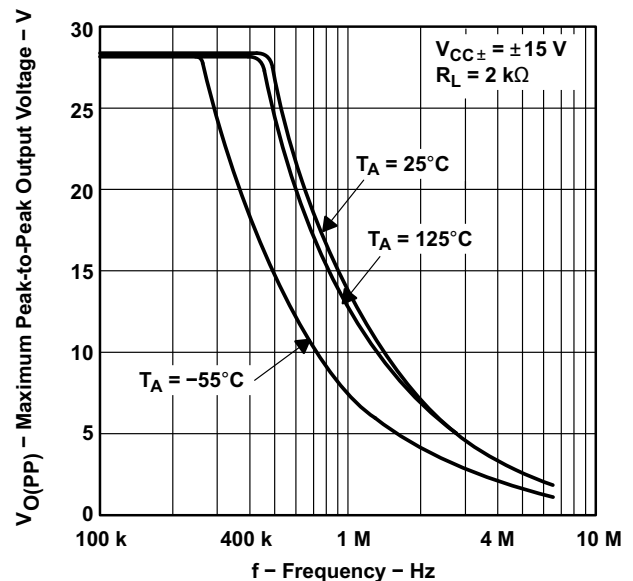


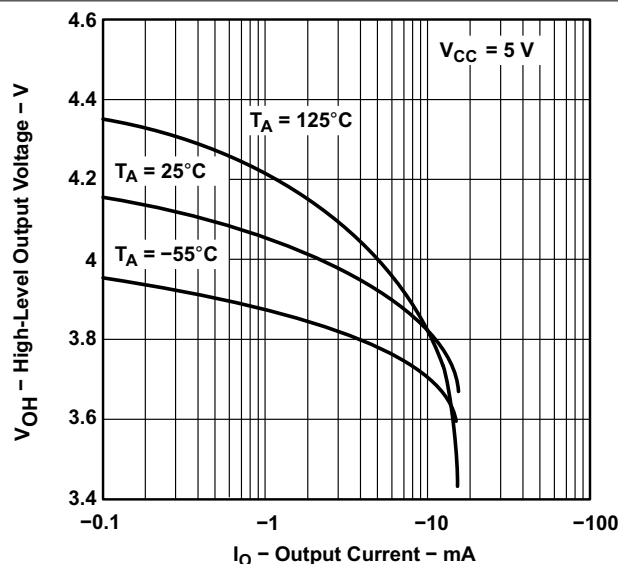
Figure 5-11. Maximum Peak Output Voltage vs Settling Time



1. Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

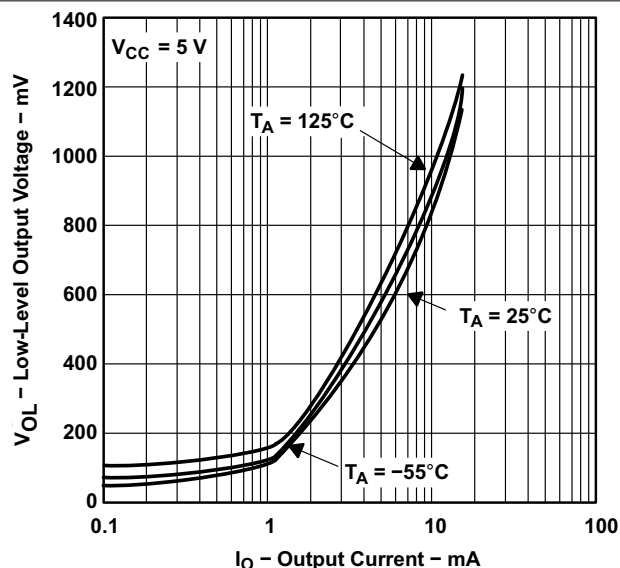
Figure 5-12. Maximum Peak-to-Peak Output Voltage⁽¹⁾ vs Frequency

5.42 Typical Characteristics (continued)



1. Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

Figure 5-13. High-Level Output Voltage⁽¹⁾ vs Output Current



1. Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

Figure 5-14. Low-Level Output Voltage⁽¹⁾ vs Output Current

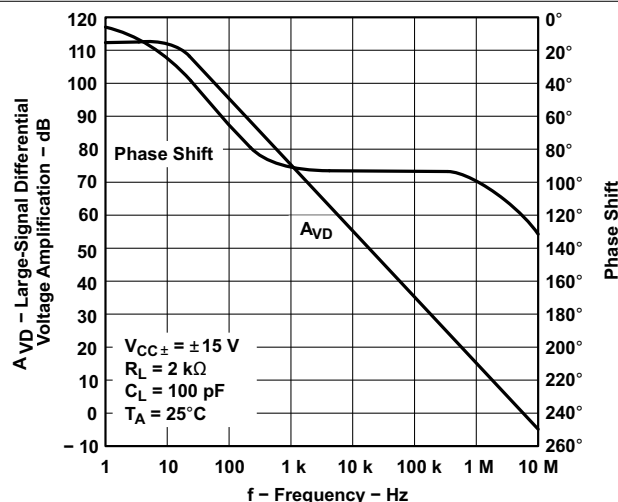
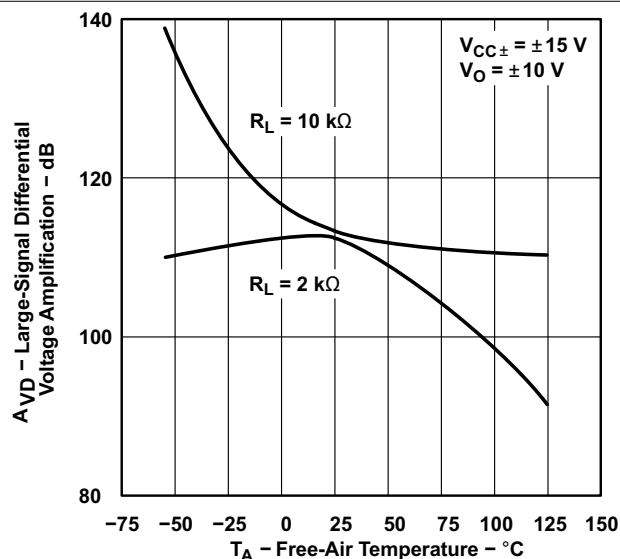


Figure 5-15. Large-Signal Differential Voltage Amplification and Phase Shift vs Frequency



1. Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

Figure 5-16. Large-Signal Differential Voltage Amplification⁽¹⁾ vs Free-Air Temperature

5.42 Typical Characteristics (continued)

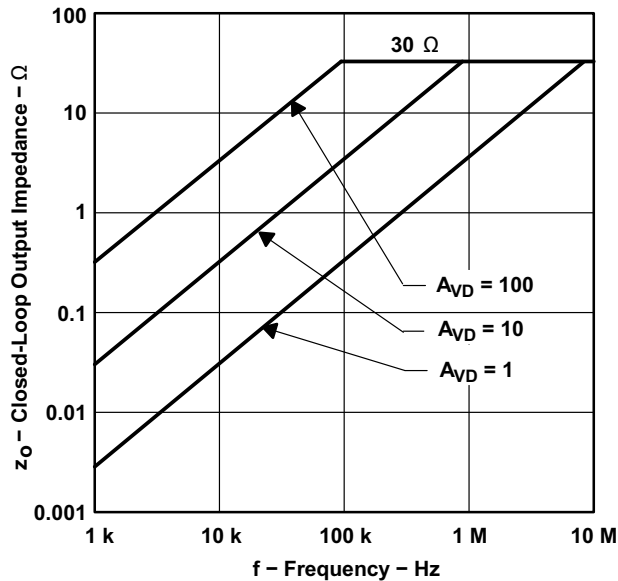
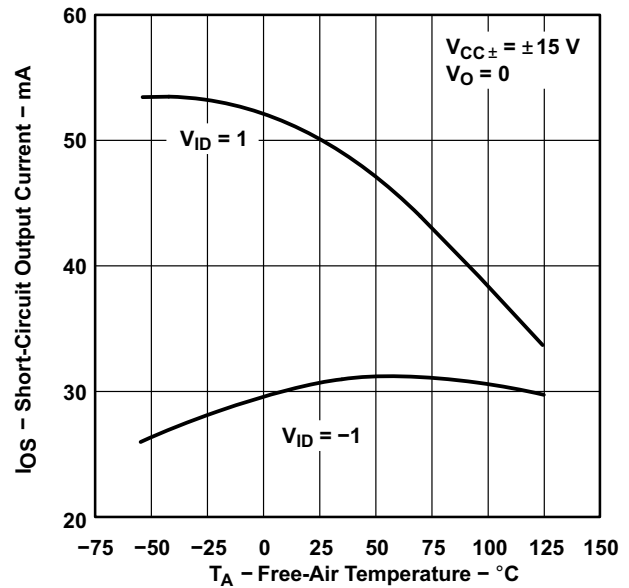


Figure 5-17. Closed-Loop Output Impedance vs Frequency



1. Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

Figure 5-18. Short-Circuit Output Current⁽¹⁾ vs Free-Air Temperature

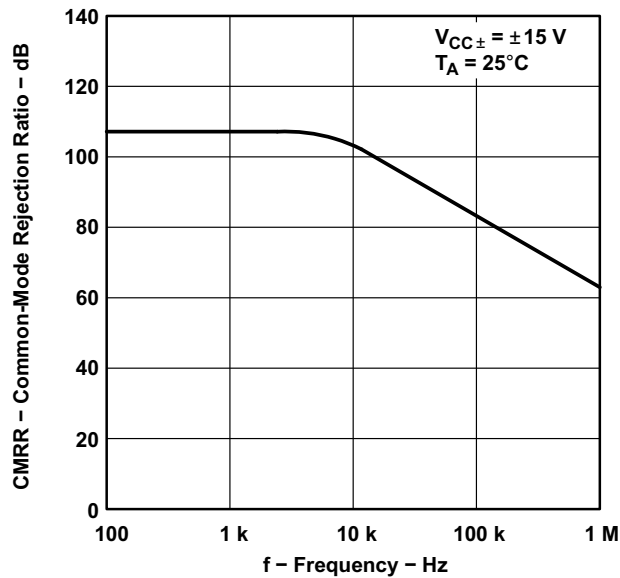
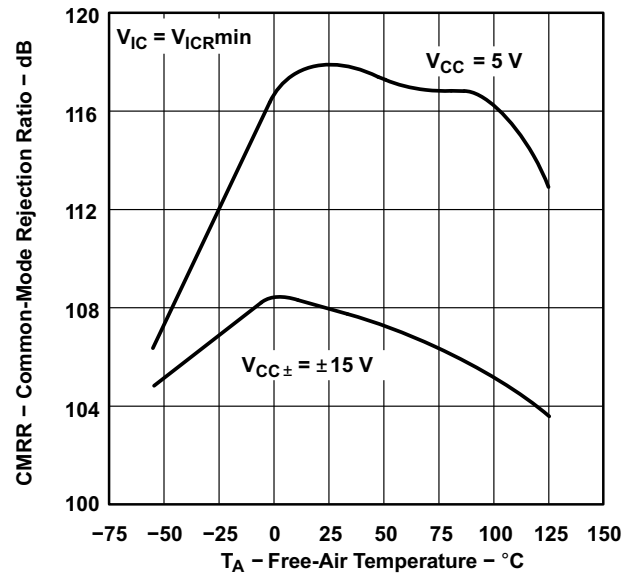


Figure 5-19. Common-Mode Rejection Ratio vs Frequency



1. Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

Figure 5-20. Common-Mode Rejection Ratio⁽¹⁾ vs Free-Air Temperature

5.42 Typical Characteristics (continued)

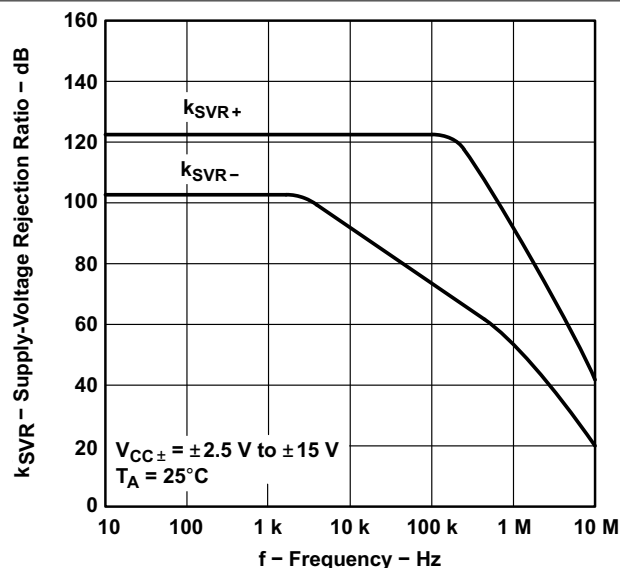
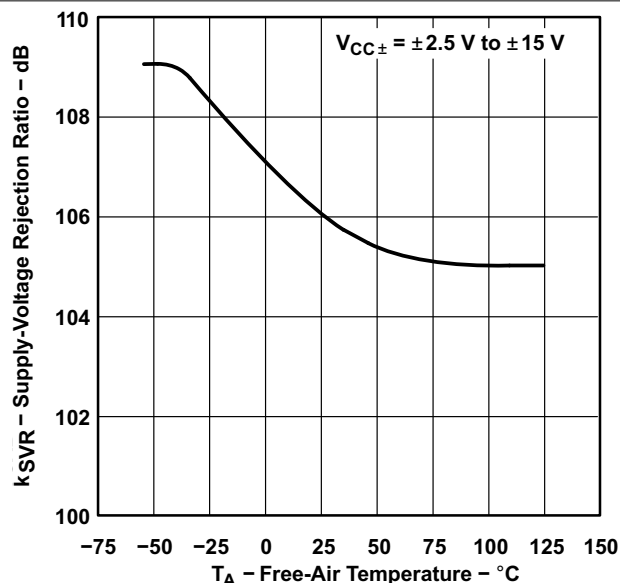
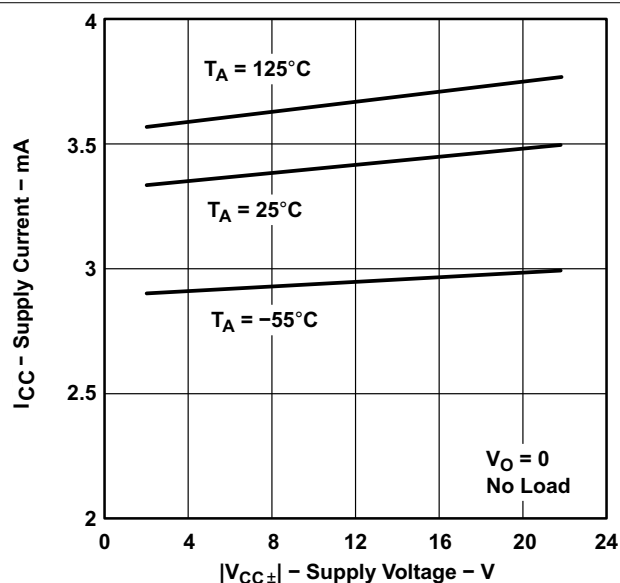


Figure 5-21. Supply-Voltage Rejection Ratio vs Frequency



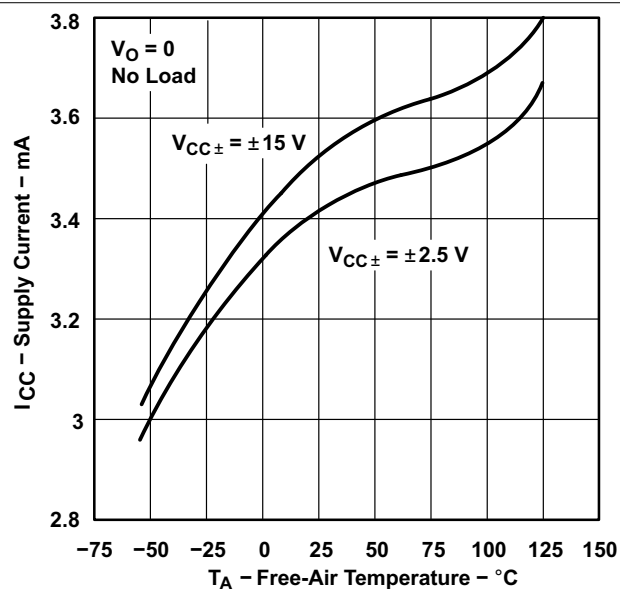
1. Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

Figure 5-22. Supply-Voltage Rejection Ratio⁽¹⁾ vs Free-Air Temperature



1. Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

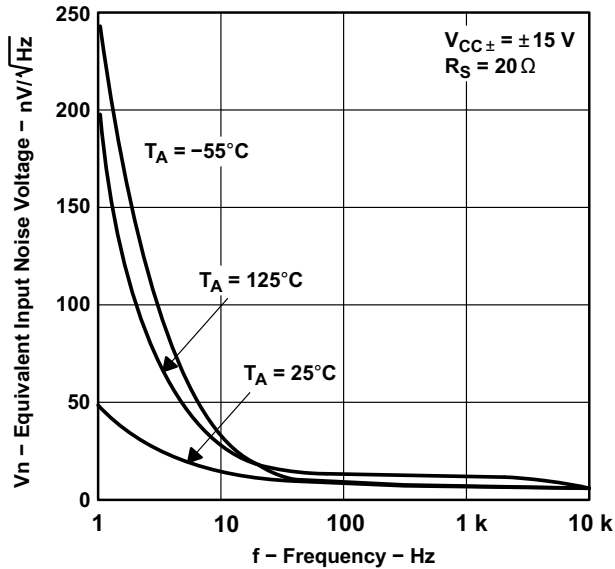
Figure 5-23. Supply Current⁽¹⁾ vs Supply Voltage



1. Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

Figure 5-24. Supply Current⁽¹⁾ vs Free-Air Temperature

5.42 Typical Characteristics (continued)



1. Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

Figure 5-25. Equivalent Input Noise Voltage⁽¹⁾ vs Frequency

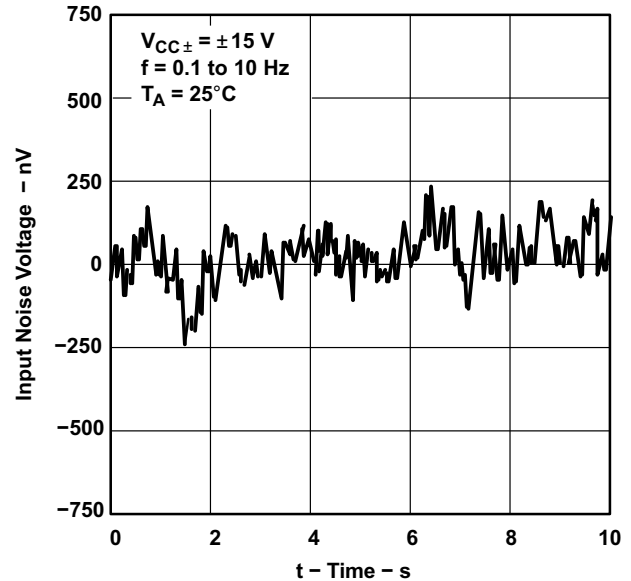
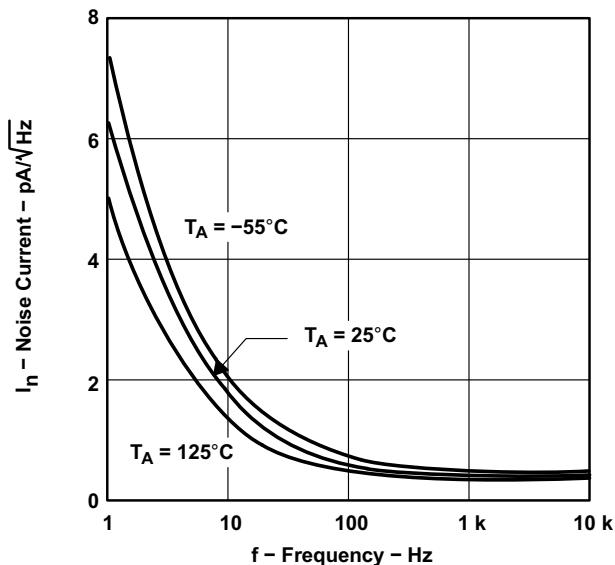


Figure 5-26. Input Noise Voltage Over a 10-Second Period



1. Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

Figure 5-27. Noise Current⁽¹⁾ vs Frequency

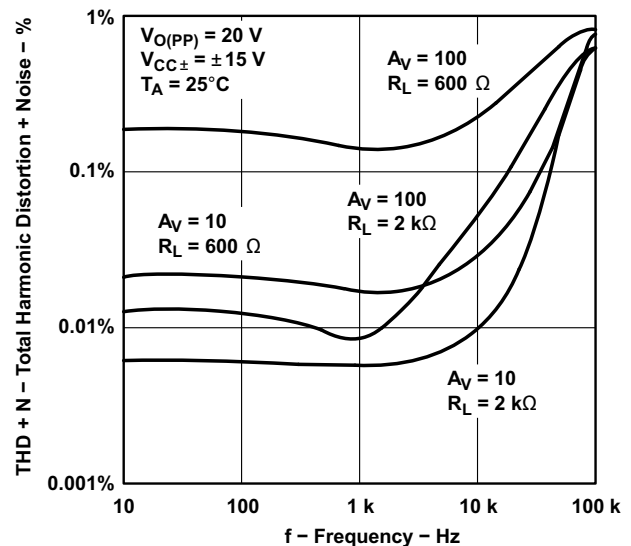
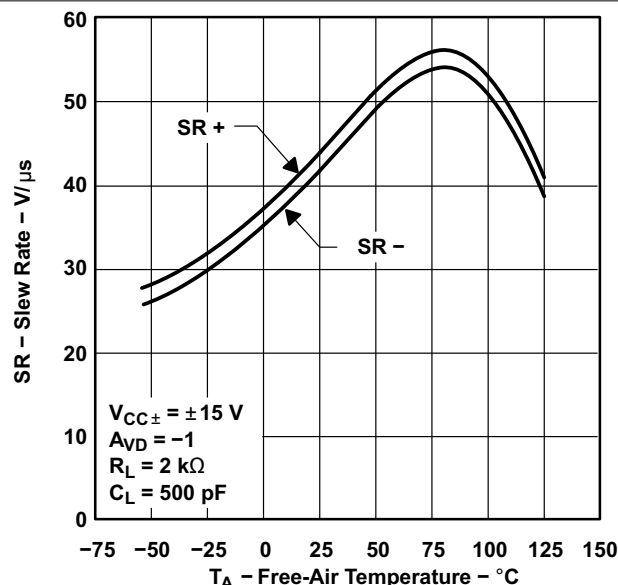


Figure 5-28. Total Harmonic Distortion Plus Noise vs Frequency

5.42 Typical Characteristics (continued)



1. Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

Figure 5-29. Slew Rate⁽¹⁾ vs Free-Air Temperature

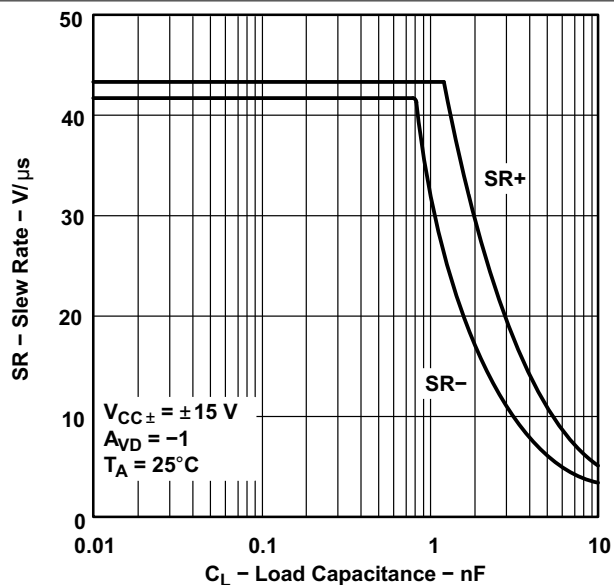
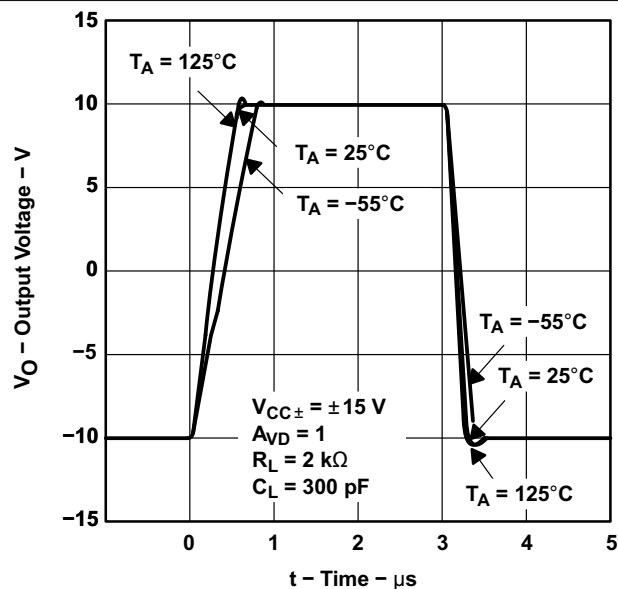
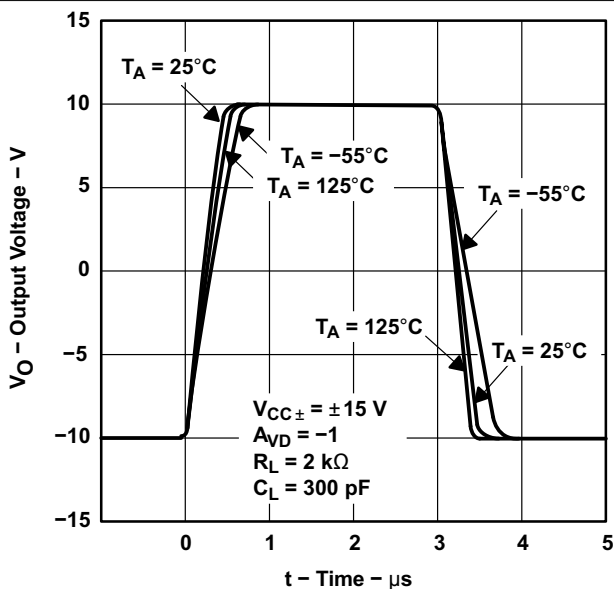


Figure 5-30. Slew Rate vs Load Capacitance



1. Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

Figure 5-31. Noninverting Large-Signal Pulse Response⁽¹⁾



1. Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

Figure 5-32. Inverting Large-Signal Pulse Response⁽¹⁾

5.42 Typical Characteristics (continued)

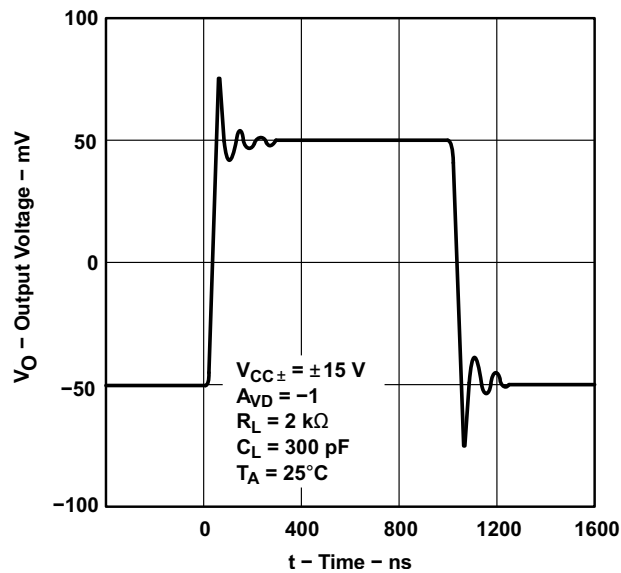
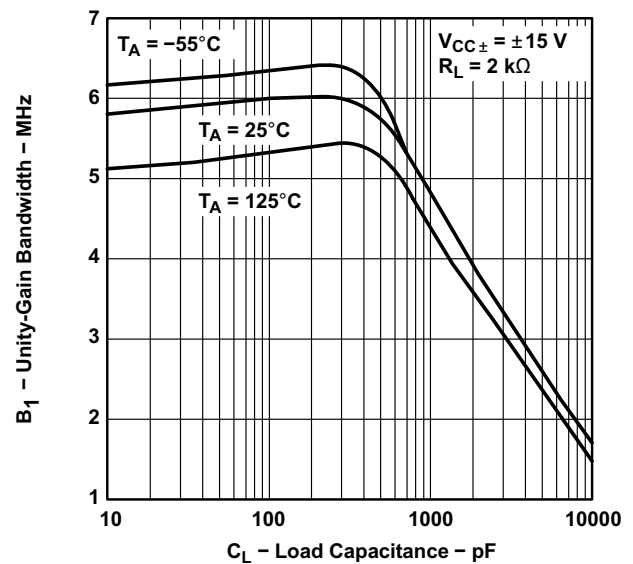


Figure 5-33. Small-Signal Pulse Response



1. Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

Figure 5-34. Unity-Gain Bandwidth⁽¹⁾ vs Load Capacitance

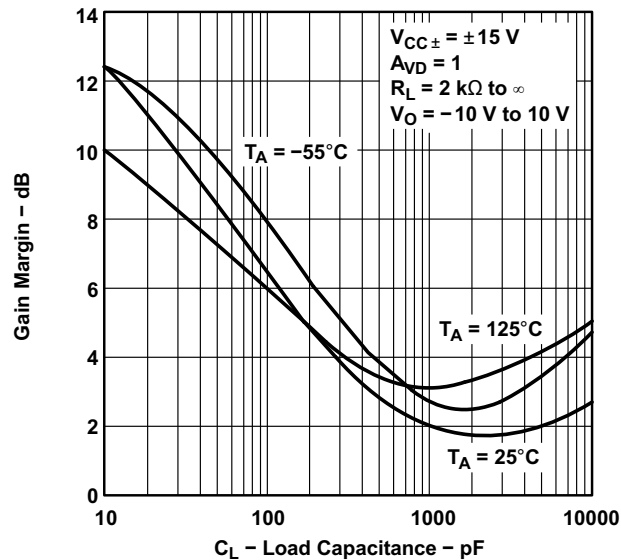
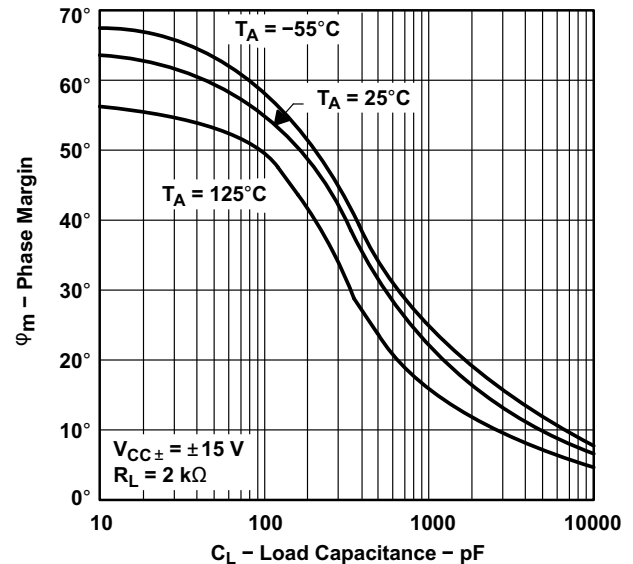


Figure 5-35. Gain Margin vs Load Capacitance



1. Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

Figure 5-36. Phase Margin⁽¹⁾ vs Load Capacitance

6 Detailed Description

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

6.1 Overview

The TLE214x amplifiers are stable with capacitive loads up to 10nF, although the 6MHz bandwidth decreases to 1.8MHz at this high loading level. As such, these devices are useful for low-droop sample-and-holds and direct buffering of long cables, including 4mA to 20mA current loops.

The special design also exhibits an improved insensitivity to inherent integrated circuit component mismatches as is evidenced by a 500 μ V maximum offset voltage and 1.7 μ V/ $^{\circ}$ C typical drift. Minimum common-mode rejection ratio and supply-voltage rejection ratio are 85dB and 90dB, respectively.

Device performance is relatively independent of supply voltage over the ± 2 V to ± 22 V range. Inputs can operate between $V_{CC-} - 0.3$ V to $V_{CC+} - 1.8$ V without inducing phase reversal, although excessive input current can flow out of each input exceeding the lower common-mode input range. The all-npn output stage provides a nearly rail-to-rail output swing of $V_{CC-} - 0.1$ V to $V_{CC+} - 1$ V under light current-loading conditions. The device can sustain shorts to either supply since output current is internally limited, but care must be taken to make sure that maximum package power dissipation is not exceeded.

7 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

7.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on [ti.com](https://www.ti.com). Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

7.2 Support Resources

[TI E2E™ support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

7.3 Trademarks

TI E2E™ is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

7.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

7.5 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

8 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision D (October 2012) to Revision E (July 2025)	Page
• Updated the numbering format for tables, figures, and cross-references throughout the document.....	1
• Changed pins 1 and 5 from OFFSET N1 to NC and OFFSET N2 to NC for TLE2141 D, JG, and P package pinouts.....	3
• Changed typical settling time specification across all devices from 0.34μs (0.1%, ±15V V _S) to 0.43μs, 0.4μs (0.01%, ±15V V _S) to 0.64μs, 0.16μs (0.1%, 5V V _S) to 0.66μs, and 0.22μs (0.01%, 5V V _S) to 0.99μs.....	4
• Changed typical THD+N specification at ±15V V _S across all devices from 0.01% to 0.06%.....	4
• Changed typical maximum output bandwidth specification at 5V V _S across all devices from 660kHz to 380kHz.....	4

9 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
5962-9321603Q2A	Active	Production	LCCC (FK) 20	55 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962- 9321603Q2A TLE2142MFKB
5962-9321603QHA	Active	Production	CFP (U) 10	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	9321603QHA TLE2142M
5962-9321603QPA	Active	Production	CDIP (JG) 8	50 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	9321603QPA TLE2142M
5962-9321604Q2A	Active	Production	LCCC (FK) 20	55 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962- 9321604Q2A TLE2142 AMFKB
5962-9321604QHA	Active	Production	CFP (U) 10	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	9321604QHA TLE2142AM
5962-9321604QPA	Active	Production	CDIP (JG) 8	50 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	9321604QPA TLE2142AM
5962-9321605Q2A	Active	Production	LCCC (FK) 20	55 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962- 9321605Q2A TLE2144MFKB
5962-9321605QCA	Active	Production	CDIP (J) 14	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9321605QC A TLE2144MJB
5962-9321606Q2A	Active	Production	LCCC (FK) 20	55 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962- 9321606Q2A TLE2144 AMFKB
5962-9321606QCA	Active	Production	CDIP (J) 14	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9321606QC A TLE2144AMJB
TLE2141ACD	Obsolete	Production	SOIC (D) 8	-	-	Call TI	Call TI	-	2141AC
TLE2141ACP	Active	Production	PDIP (P) 8	50 TUBE	Yes	NIPDAU	N/A for Pkg Type	-	TLE2141AC
TLE2141ACP.A	Active	Production	PDIP (P) 8	50 TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	TLE2141AC
TLE2141AID	Obsolete	Production	SOIC (D) 8	-	-	Call TI	Call TI	-	2141AI
TLE2141AIDR	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-	2141AI
TLE2141AIDR.A	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	2141AI

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TLE2141AIP	Active	Production	PDIP (P) 8	50 TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	TLE2141AI
TLE2141AIP.A	Active	Production	PDIP (P) 8	50 TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	TLE2141AI
TLE2141CD	Obsolete	Production	SOIC (D) 8	-	-	Call TI	Call TI	-	2141C
TLE2141CDR	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-	2141C
TLE2141CDR.A	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	2141C
TLE2141CDRG4	Active	Production	SOIC (D) 8	2500 LARGE T&R	-	Call TI	Call TI	See TLE2141CDR	
TLE2141CP	Active	Production	PDIP (P) 8	50 TUBE	Yes	NIPDAU	N/A for Pkg Type	-	TLE2141CP
TLE2141CP.A	Active	Production	PDIP (P) 8	50 TUBE	Yes	NIPDAU	N/A for Pkg Type	-55 to 125	TLE2141CP
TLE2141ID	Obsolete	Production	SOIC (D) 8	-	-	Call TI	Call TI	-	2141I
TLE2141IDR	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-	2141I
TLE2141IDR.A	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	2141I
TLE2141IP	Active	Production	PDIP (P) 8	50 TUBE	Yes	NIPDAU	N/A for Pkg Type	-	TLE2141IP
TLE2141IP.A	Active	Production	PDIP (P) 8	50 TUBE	Yes	NIPDAU	N/A for Pkg Type	-55 to 125	TLE2141IP
TLE2141MD	Active	Production	SOIC (D) 8	75 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	2141M
TLE2141MD.A	Active	Production	SOIC (D) 8	75 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	2141M
TLE2141MDR	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	2141M
TLE2141MDR.A	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	2141M
TLE2142ACD	Obsolete	Production	SOIC (D) 8	-	-	Call TI	Call TI	0 to 70	2142AC
TLE2142ACDR	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-	2142AC
TLE2142ACDR.A	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	2142AC
TLE2142AID	Obsolete	Production	SOIC (D) 8	-	-	Call TI	Call TI	-40 to 85	2142AI
TLE2142AIDR	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-	2142AI
TLE2142AIDR.A	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	2142AI
TLE2142AMD	Obsolete	Production	SOIC (D) 8	-	-	Call TI	Call TI	-55 to 125	E2142A
TLE2142AMDR	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	E2142A
TLE2142AMDR.A	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	E2142A
TLE2142AMDRG4	Obsolete	Production	SOIC (D) 8	-	-	Call TI	Call TI	-	E2142A
TLE2142AMFKB	Active	Production	LCCC (FK) 20	55 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962- 9321604Q2A TLE2142 AMFKB

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TLE2142AMFKB.A	Active	Production	LCCC (FK) 20	55 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962- 9321604Q2A TLE2142 AMFKB
TLE2142AMJG	Active	Production	CDIP (JG) 8	50 TUBE	No	SNPB	N/A for Pkg Type	-	TLE2142AMJG
TLE2142AMJG.A	Active	Production	CDIP (JG) 8	50 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	TLE2142AMJG
TLE2142AMJGB	Active	Production	CDIP (JG) 8	50 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	9321604QPA TLE2142AM
TLE2142AMJGB.A	Active	Production	CDIP (JG) 8	50 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	9321604QPA TLE2142AM
TLE2142AMUB	Active	Production	CFP (U) 10	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	9321604QHA TLE2142AM
TLE2142AMUB.A	Active	Production	CFP (U) 10	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	9321604QHA TLE2142AM
TLE2142CD	Obsolete	Production	SOIC (D) 8	-	-	Call TI	Call TI	0 to 70	2142C
TLE2142CDR	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	2142C
TLE2142CDR.A	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	2142C
TLE2142CDRG4	Active	Production	SOIC (D) 8	2500 LARGE T&R	-	Call TI	Call TI	0 to 70	
TLE2142CP	Active	Production	PDIP (P) 8	50 TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	TLE2142CP
TLE2142CP.A	Active	Production	PDIP (P) 8	50 TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	TLE2142CP
TLE2142CPWR	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	Q2142
TLE2142CPWR.A	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	Q2142
TLE2142ID	Obsolete	Production	SOIC (D) 8	-	-	Call TI	Call TI	-40 to 105	2142I
TLE2142IDR	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	2142I
TLE2142IDR.A	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	2142I
TLE2142IP	Active	Production	PDIP (P) 8	50 TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 105	TLE2142IP
TLE2142IP.A	Active	Production	PDIP (P) 8	50 TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 105	TLE2142IP
TLE2142MD	Obsolete	Production	SOIC (D) 8	-	-	Call TI	Call TI	-55 to 125	2142M
TLE2142MDG4	Obsolete	Production	SOIC (D) 8	-	-	Call TI	Call TI	-	2142M
TLE2142MDR	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	2142M
TLE2142MDR.A	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	2142M

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TLE2142MFKB	Active	Production	LCCC (FK) 20	55 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962- 9321603Q2A TLE2142MFKB
TLE2142MFKB.A	Active	Production	LCCC (FK) 20	55 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962- 9321603Q2A TLE2142MFKB
TLE2142MJGB	Active	Production	CDIP (JG) 8	50 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	9321603QPA TLE2142M
TLE2142MJGB.A	Active	Production	CDIP (JG) 8	50 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	9321603QPA TLE2142M
TLE2142MUB	Active	Production	CFP (U) 10	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	9321603QHA TLE2142M
TLE2142MUB.A	Active	Production	CFP (U) 10	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	9321603QHA TLE2142M
TLE2144ACN	Active	Production	PDIP (N) 14	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	TLE2144ACN
TLE2144ACN.A	Active	Production	PDIP (N) 14	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	TLE2144ACN
TLE2144AIN	Active	Production	PDIP (N) 14	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	TLE2144AIN
TLE2144AIN.A	Active	Production	PDIP (N) 14	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	TLE2144AIN
TLE2144AMFKB	Active	Production	LCCC (FK) 20	55 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962- 9321606Q2A TLE2144 AMFKB
TLE2144AMFKB.A	Active	Production	LCCC (FK) 20	55 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962- 9321606Q2A TLE2144 AMFKB
TLE2144AMJB	Active	Production	CDIP (J) 14	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9321606QC A TLE2144AMJB
TLE2144AMJB.A	Active	Production	CDIP (J) 14	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9321606QC A TLE2144AMJB
TLE2144CDW	Active	Production	SOIC (DW) 16	40 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TLE2144C
TLE2144CDW.A	Active	Production	SOIC (DW) 16	40 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TLE2144C
TLE2144CDWR	Active	Production	SOIC (DW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TLE2144C

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TLE2144CDWR.A	Active	Production	SOIC (DW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TLE2144C
TLE2144CN	Active	Production	PDIP (N) 14	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	TLE2144CN
TLE2144CN.A	Active	Production	PDIP (N) 14	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	TLE2144CN
TLE2144IDW	Active	Production	SOIC (DW) 16	40 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	TLE2144I
TLE2144IDW.A	Active	Production	SOIC (DW) 16	40 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	TLE2144I
TLE2144IDWR	Active	Production	SOIC (DW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	TLE2144I
TLE2144IDWR.A	Active	Production	SOIC (DW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	TLE2144I
TLE2144IN	Active	Production	PDIP (N) 14	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 105	TLE2144IN
TLE2144IN.A	Active	Production	PDIP (N) 14	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 105	TLE2144IN
TLE2144MDW	Active	Production	SOIC (DW) 16	40 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	TLE2144M
TLE2144MDW.A	Active	Production	SOIC (DW) 16	40 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	TLE2144M
TLE2144MDWG4	Active	Production	SOIC (DW) 16	40 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-	TLE2144M
TLE2144MDWG4.A	Active	Production	SOIC (DW) 16	40 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	TLE2144M
TLE2144MFKB	Active	Production	LCCC (FK) 20	55 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9321605Q2A TLE2144MFKB
TLE2144MFKB.A	Active	Production	LCCC (FK) 20	55 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9321605Q2A TLE2144MFKB
TLE2144MJB	Active	Production	CDIP (J) 14	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9321605QC A TLE2144MJB
TLE2144MJB.A	Active	Production	CDIP (J) 14	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9321605QC A TLE2144MJB

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

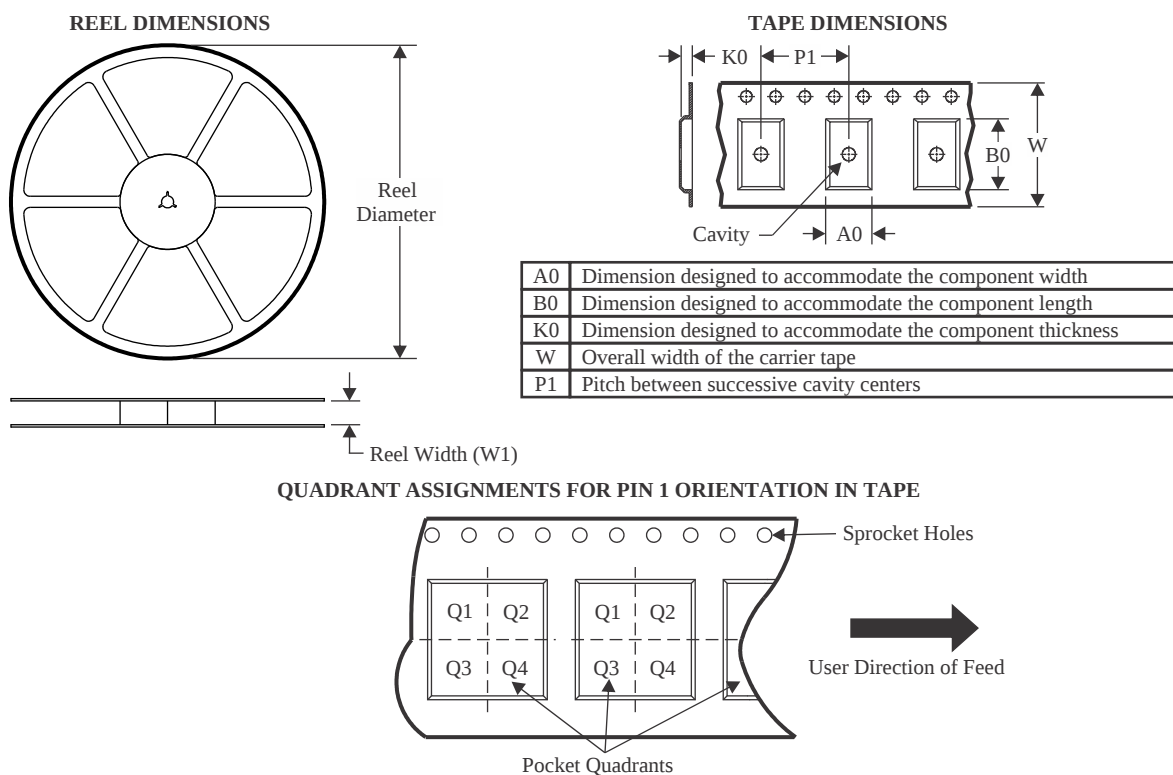
OTHER QUALIFIED VERSIONS OF TLE2141, TLE2141A, TLE2142, TLE2142A, TLE2142AM, TLE2142M, TLE2144, TLE2144A, TLE2144AM, TLE2144M :

- Catalog : [TLE2142A](#), [TLE2142](#), [TLE2144A](#), [TLE2144](#)
- Automotive : [TLE2141-Q1](#), [TLE2142-Q1](#), [TLE2142-Q1](#)
- Enhanced Product : [TLE2141-EP](#), [TLE2144-EP](#), [TLE2144-EP](#)
- Military : [TLE2141M](#), [TLE2141AM](#), [TLE2142M](#), [TLE2142AM](#), [TLE2144M](#), [TLE2144AM](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product
- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Enhanced Product - Supports Defense, Aerospace and Medical Applications
- Military - QML certified for Military and Defense Applications

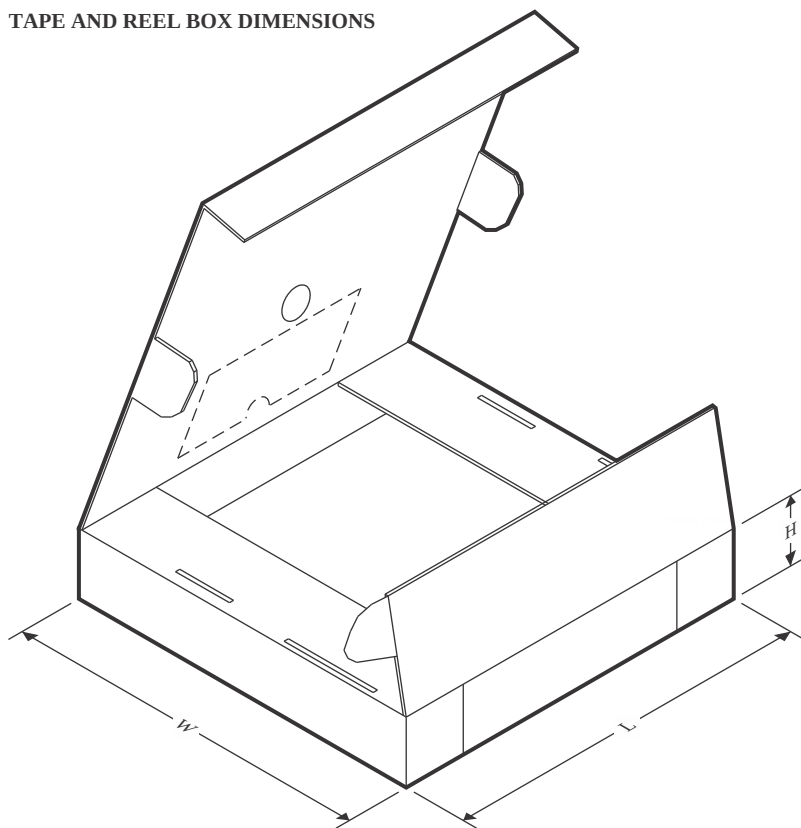
TAPE AND REEL INFORMATION



*All dimensions are nominal

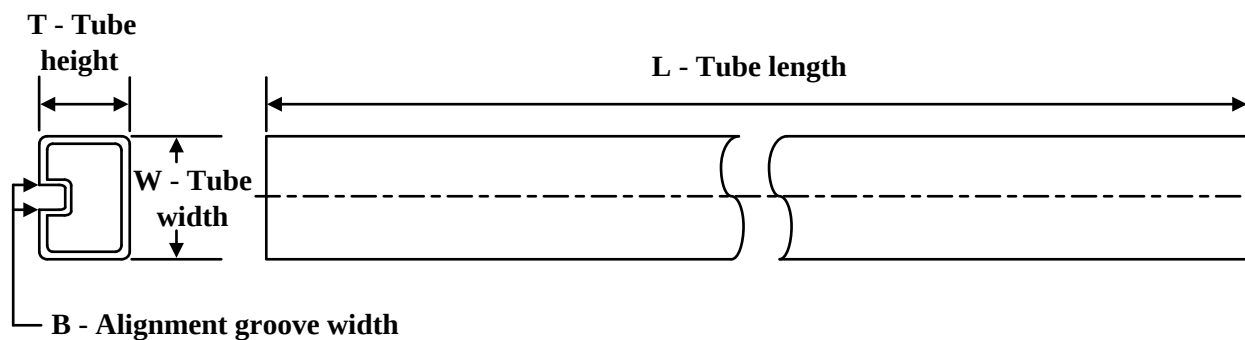
Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TLE2141AIDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLE2141CDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLE2141IDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLE2141MDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLE2142ACDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLE2142AIDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLE2142AMDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLE2142CDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLE2142CPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
TLE2142IDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLE2142MDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLE2144CDWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
TLE2144IDWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TLE2141AIDR	SOIC	D	8	2500	353.0	353.0	32.0
TLE2141CDR	SOIC	D	8	2500	340.5	338.1	20.6
TLE2141IDR	SOIC	D	8	2500	353.0	353.0	32.0
TLE2141MDR	SOIC	D	8	2500	350.0	350.0	43.0
TLE2142ACDR	SOIC	D	8	2500	353.0	353.0	32.0
TLE2142AIDR	SOIC	D	8	2500	353.0	353.0	32.0
TLE2142AMDR	SOIC	D	8	2500	350.0	350.0	43.0
TLE2142CDR	SOIC	D	8	2500	353.0	353.0	32.0
TLE2142CPWR	TSSOP	PW	16	2000	353.0	353.0	32.0
TLE2142IDR	SOIC	D	8	2500	353.0	353.0	32.0
TLE2142MDR	SOIC	D	8	2500	350.0	350.0	43.0
TLE2144CDWR	SOIC	DW	16	2000	350.0	350.0	43.0
TLE2144IDWR	SOIC	DW	16	2000	350.0	350.0	43.0

TUBE


*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
5962-9321603Q2A	FK	LCCC	20	55	506.98	12.06	2030	NA
5962-9321603QHA	U	CFP	10	25	506.98	26.16	6220	NA
5962-9321604Q2A	FK	LCCC	20	55	506.98	12.06	2030	NA
5962-9321604QHA	U	CFP	10	25	506.98	26.16	6220	NA
5962-9321605Q2A	FK	LCCC	20	55	506.98	12.06	2030	NA
5962-9321606Q2A	FK	LCCC	20	55	506.98	12.06	2030	NA
TLE2141ACP	P	PDIP	8	50	506	13.97	11230	4.32
TLE2141ACP.A	P	PDIP	8	50	506	13.97	11230	4.32
TLE2141AIP	P	PDIP	8	50	506	13.97	11230	4.32
TLE2141AIP.A	P	PDIP	8	50	506	13.97	11230	4.32
TLE2141CP	P	PDIP	8	50	506	13.97	11230	4.32
TLE2141CP.A	P	PDIP	8	50	506	13.97	11230	4.32
TLE2141IP	P	PDIP	8	50	506	13.97	11230	4.32
TLE2141IP.A	P	PDIP	8	50	506	13.97	11230	4.32
TLE2141MD	D	SOIC	8	75	505.46	6.76	3810	4
TLE2141MD.A	D	SOIC	8	75	505.46	6.76	3810	4
TLE2142AMFKB	FK	LCCC	20	55	506.98	12.06	2030	NA
TLE2142AMFKB.A	FK	LCCC	20	55	506.98	12.06	2030	NA
TLE2142AMUB	U	CFP	10	25	506.98	26.16	6220	NA
TLE2142AMUB.A	U	CFP	10	25	506.98	26.16	6220	NA
TLE2142CP	P	PDIP	8	50	506	13.97	11230	4.32
TLE2142CP.A	P	PDIP	8	50	506	13.97	11230	4.32
TLE2142IP	P	PDIP	8	50	506	13.97	11230	4.32
TLE2142IP.A	P	PDIP	8	50	506	13.97	11230	4.32
TLE2142MFKB	FK	LCCC	20	55	506.98	12.06	2030	NA
TLE2142MFKB.A	FK	LCCC	20	55	506.98	12.06	2030	NA
TLE2142MUB	U	CFP	10	25	506.98	26.16	6220	NA
TLE2142MUB.A	U	CFP	10	25	506.98	26.16	6220	NA
TLE2144ACN	N	PDIP	14	25	506	13.97	11230	4.32

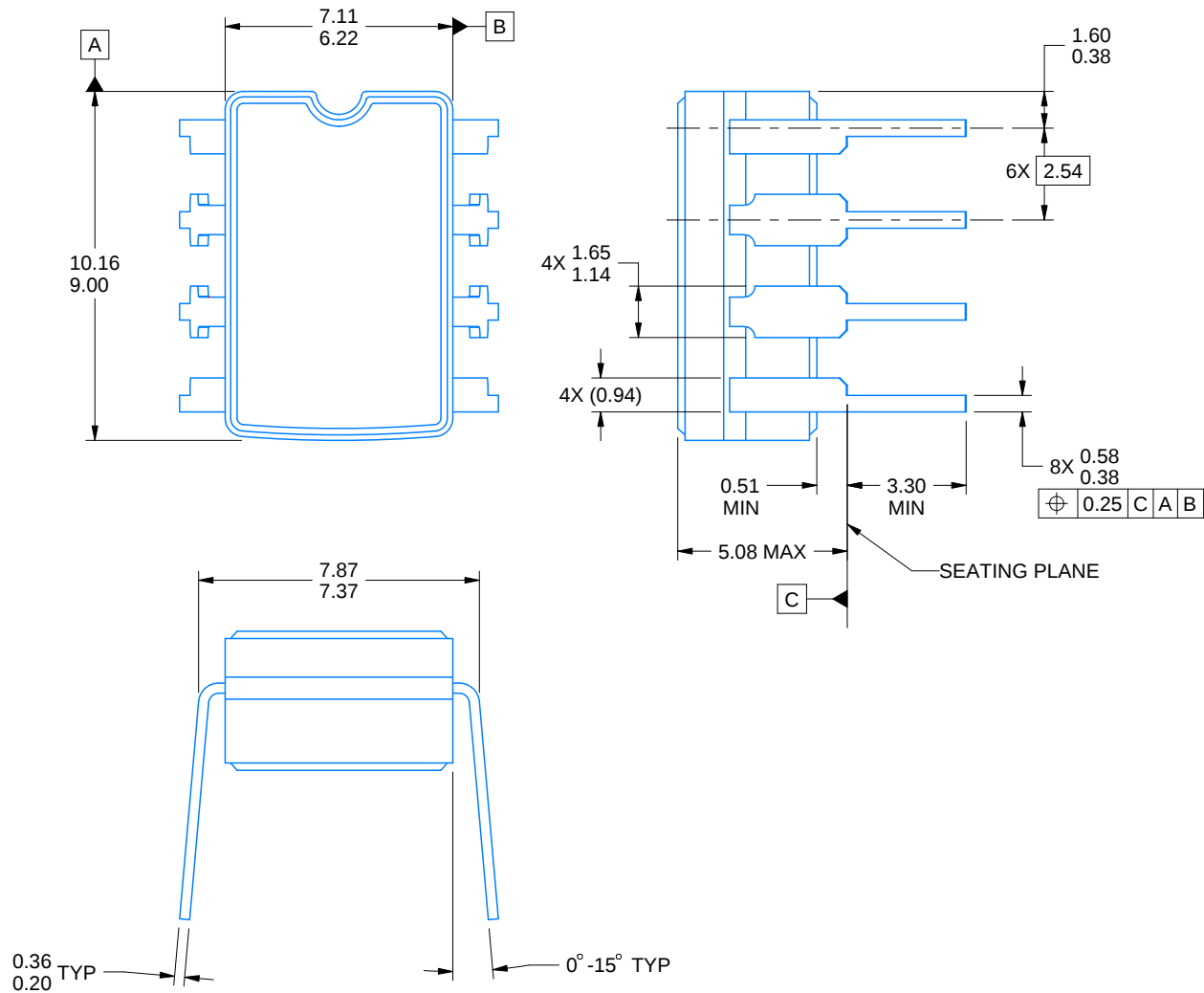
Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
TLE2144ACN.A	N	PDIP	14	25	506	13.97	11230	4.32
TLE2144AIN	N	PDIP	14	25	506	13.97	11230	4.32
TLE2144AIN.A	N	PDIP	14	25	506	13.97	11230	4.32
TLE2144AMFKB	FK	LCCC	20	55	506.98	12.06	2030	NA
TLE2144AMFKB.A	FK	LCCC	20	55	506.98	12.06	2030	NA
TLE2144CDW	DW	SOIC	16	40	506.98	12.7	4826	6.6
TLE2144CDW.A	DW	SOIC	16	40	506.98	12.7	4826	6.6
TLE2144CN	N	PDIP	14	25	506	13.97	11230	4.32
TLE2144CN.A	N	PDIP	14	25	506	13.97	11230	4.32
TLE2144IDW	DW	SOIC	16	40	506.98	12.7	4826	6.6
TLE2144IDW.A	DW	SOIC	16	40	506.98	12.7	4826	6.6
TLE2144IN	N	PDIP	14	25	506	13.97	11230	4.32
TLE2144IN.A	N	PDIP	14	25	506	13.97	11230	4.32
TLE2144MDW	DW	SOIC	16	40	506.98	12.7	4826	6.6
TLE2144MDW.A	DW	SOIC	16	40	506.98	12.7	4826	6.6
TLE2144MDWG4	DW	SOIC	16	40	506.98	12.7	4826	6.6
TLE2144MDWG4.A	DW	SOIC	16	40	506.98	12.7	4826	6.6
TLE2144MFKB	FK	LCCC	20	55	506.98	12.06	2030	NA
TLE2144MFKB.A	FK	LCCC	20	55	506.98	12.06	2030	NA

JG0008A

PACKAGE OUTLINE

CDIP - 5.08 mm max height

CERAMIC DUAL IN-LINE PACKAGE



4230036/A 09/2023

NOTES:

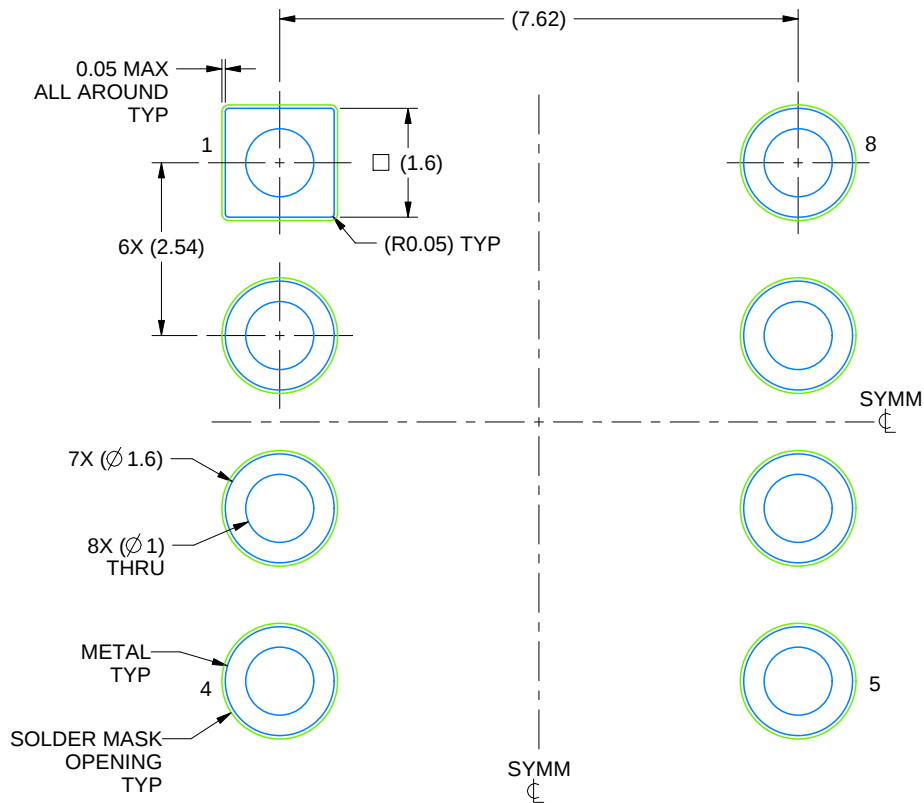
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This package can be hermetically sealed with a ceramic lid using glass frit.
4. Index point is provided on cap for terminal identification.
5. Falls within MIL STD 1835 GDIP1-T8

EXAMPLE BOARD LAYOUT

JG0008A

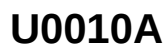
CDIP - 5.08 mm max height

CERAMIC DUAL IN-LINE PACKAGE



LAND PATTERN EXAMPLE
NON SOLDER MASK DEFINED
SCALE: 9X

4230036/A 09/2023



CFP - 2.03 mm max height

CERAMIC FLATPACK



1. All linear dimensions are in inches. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

2. This drawing is subject to change without notice.

GENERIC PACKAGE VIEW

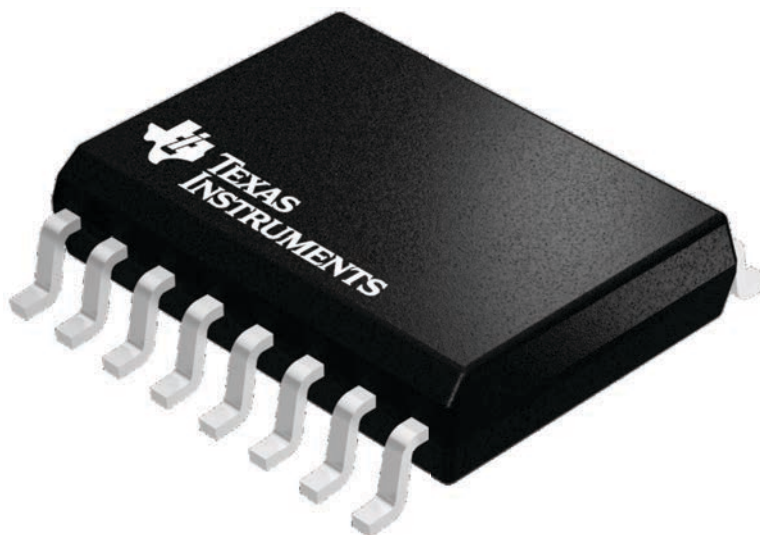
DW 16

SOIC - 2.65 mm max height

7.5 x 10.3, 1.27 mm pitch

SMALL OUTLINE INTEGRATED CIRCUIT

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



4224780/A



SOIC - 2.65 mm max height

SOIC



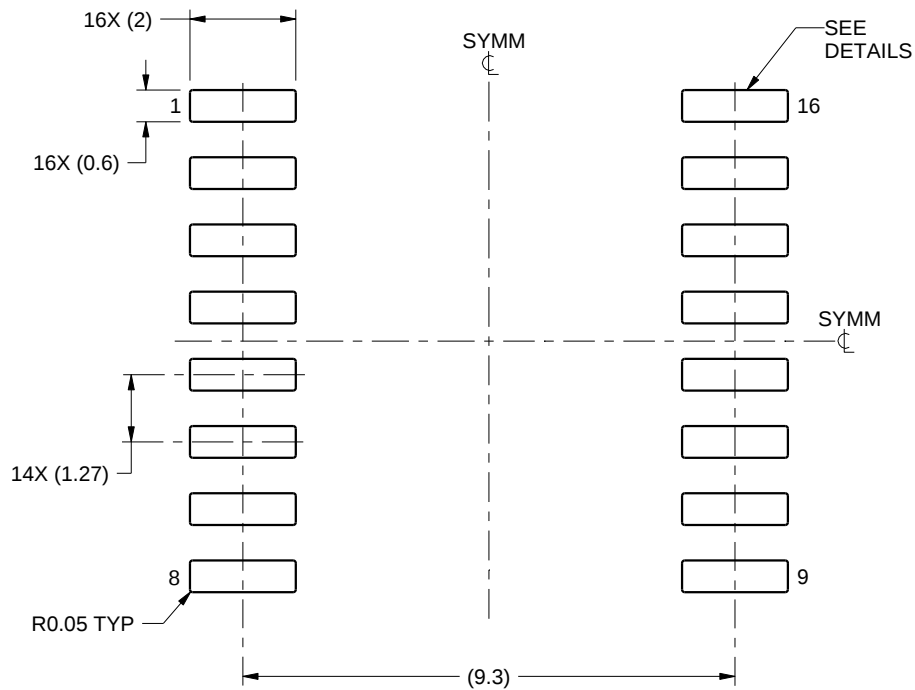
1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.
5. Reference JEDEC registration MS-013.

EXAMPLE BOARD LAYOUT

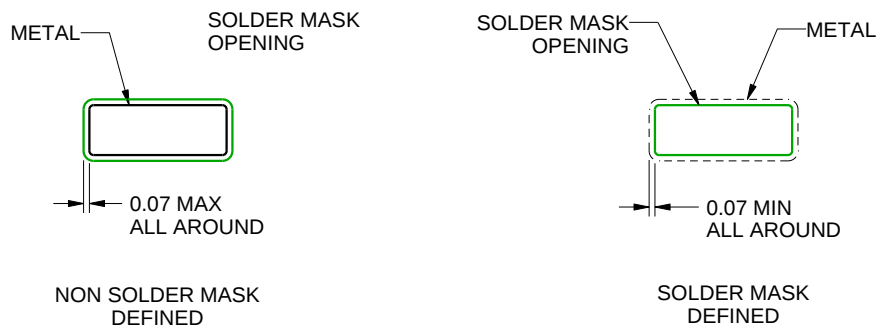
DW0016A

SOIC - 2.65 mm max height

SOIC



LAND PATTERN EXAMPLE
SCALE:7X



SOLDER MASK DETAILS

4220721/A 07/2016

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

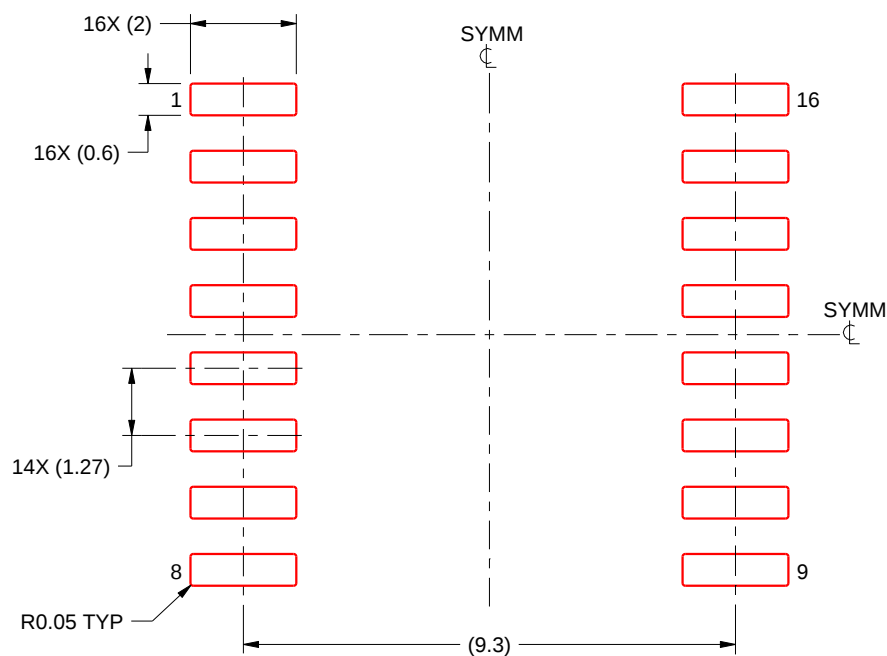
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DW0016A

SOIC - 2.65 mm max height

SOIC



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:7X

4220721/A 07/2016

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

GENERIC PACKAGE VIEW

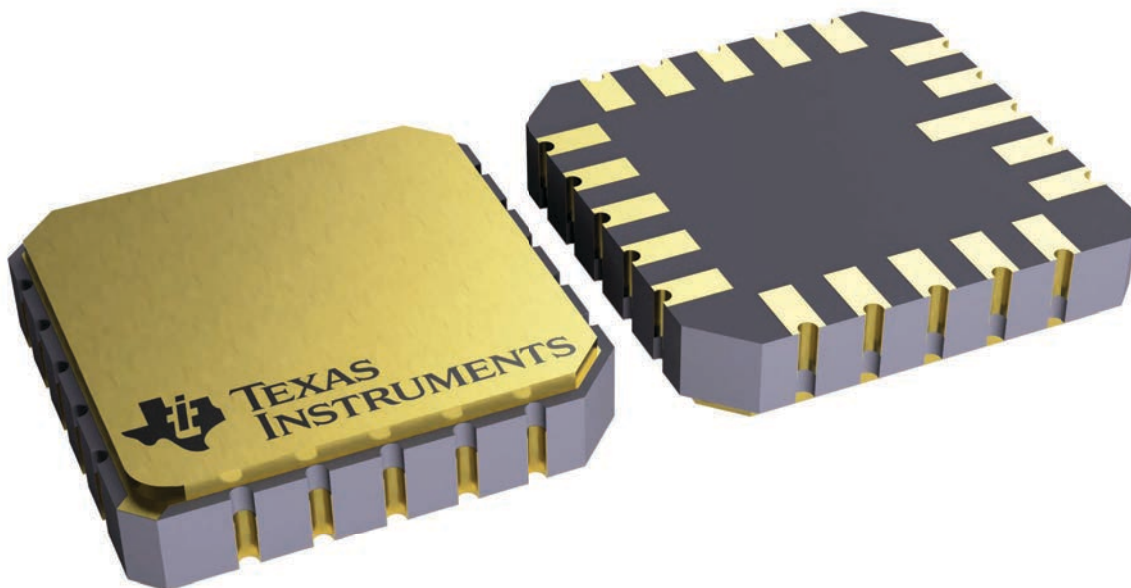
FK 20

LCCC - 2.03 mm max height

8.89 x 8.89, 1.27 mm pitch

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



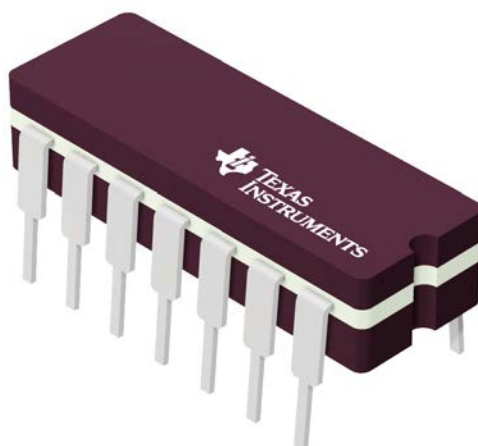
4229370VA\

J 14

GENERIC PACKAGE VIEW

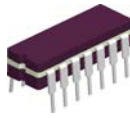
CDIP - 5.08 mm max height

CERAMIC DUAL IN LINE PACKAGE

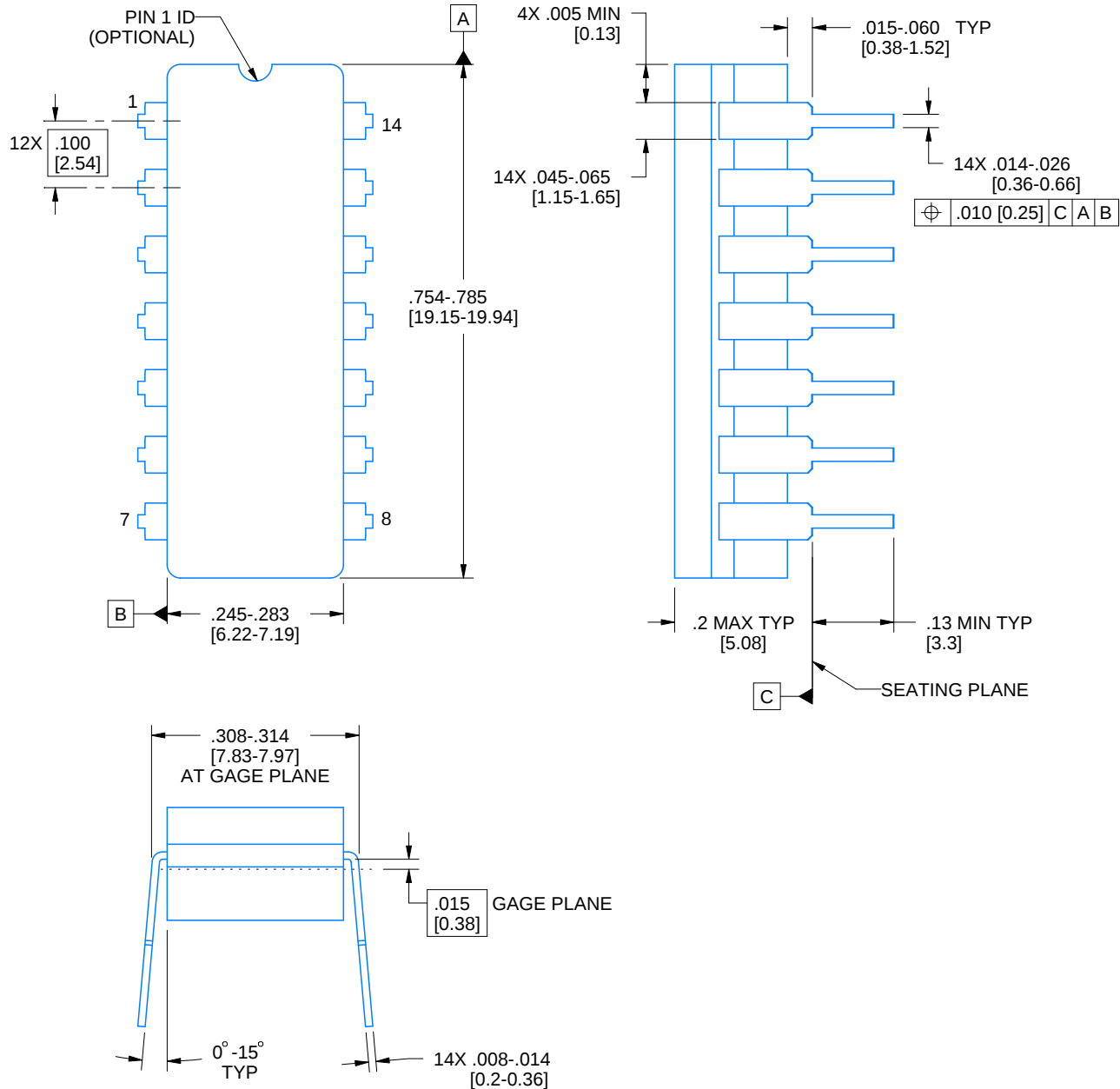


Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

4040083-5/G

J0014A**PACKAGE OUTLINE****CDIP - 5.08 mm max height**

CERAMIC DUAL IN LINE PACKAGE



4214771/A 05/2017

NOTES:

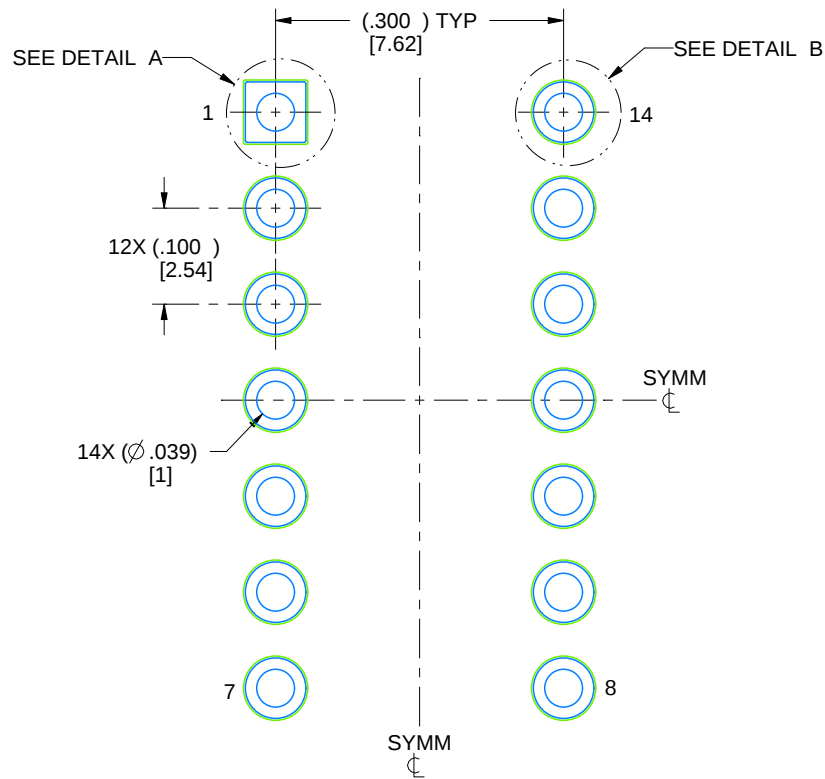
1. All controlling linear dimensions are in inches. Dimensions in brackets are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This package is hermetically sealed with a ceramic lid using glass frit.
4. Index point is provided on cap for terminal identification only and on press ceramic glass frit seal only.
5. Falls within MIL-STD-1835 and GDIP1-T14.

EXAMPLE BOARD LAYOUT

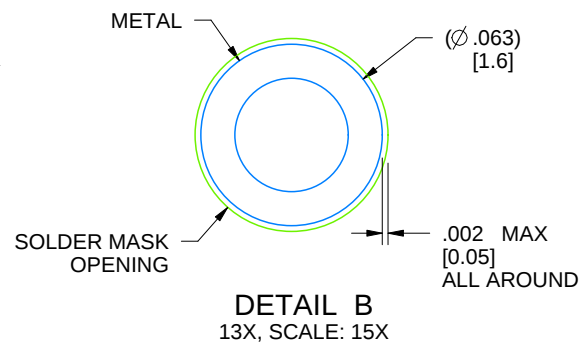
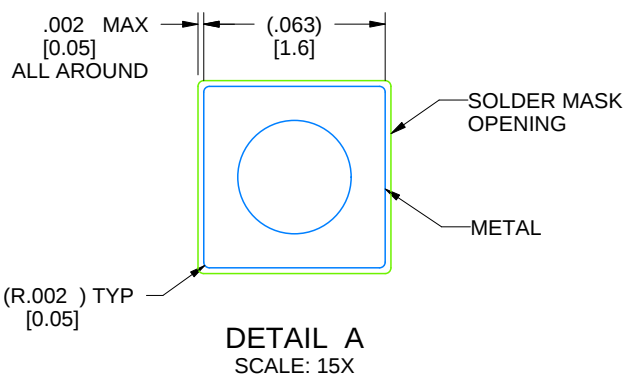
J0014A

CDIP - 5.08 mm max height

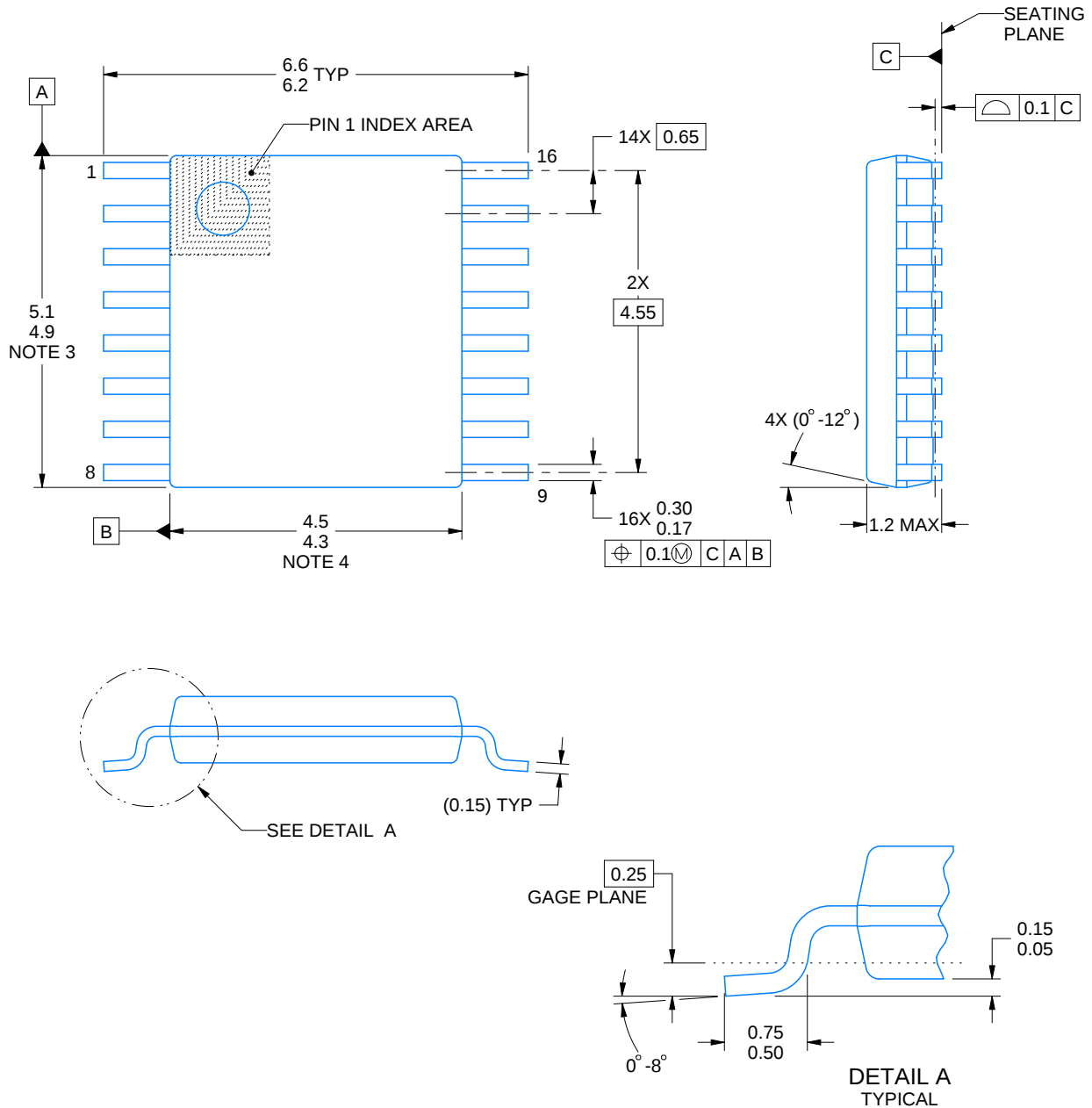
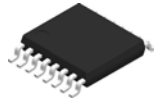
CERAMIC DUAL IN LINE PACKAGE



LAND PATTERN EXAMPLE
NON-SOLDER MASK DEFINED
SCALE: 5X



4214771/A 05/2017



4220204/B 12/2023

NOTES:

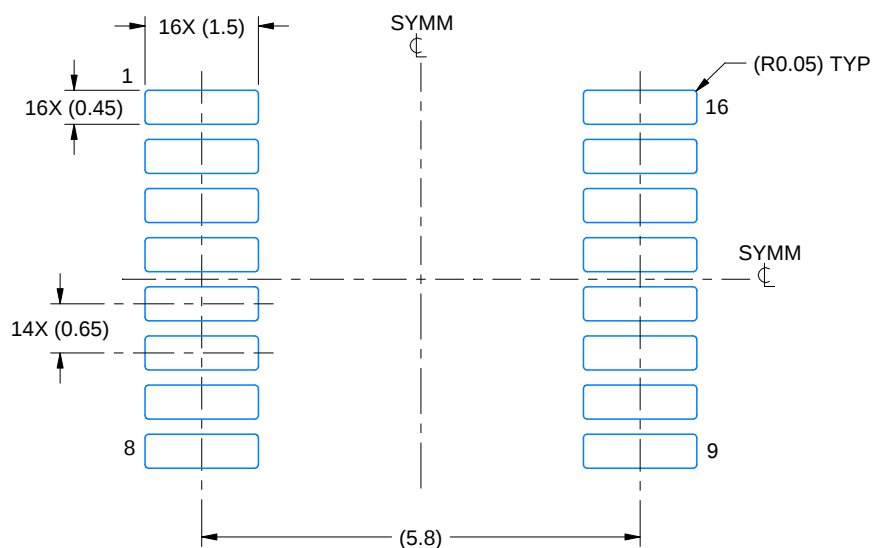
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.

EXAMPLE BOARD LAYOUT

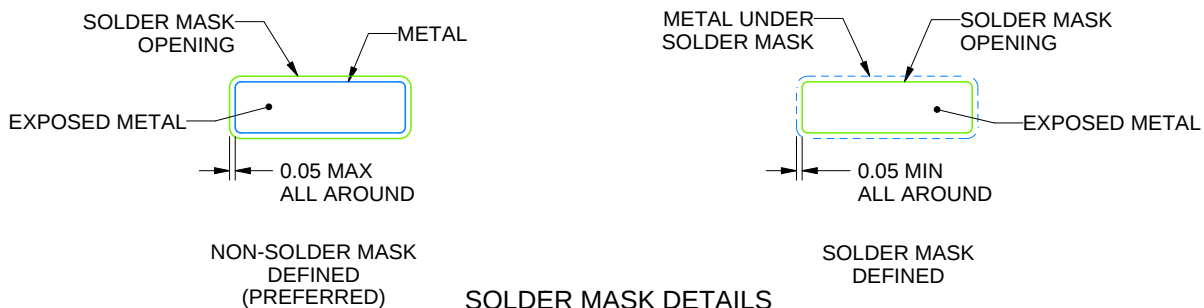
PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X



4220204/B 12/2023

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

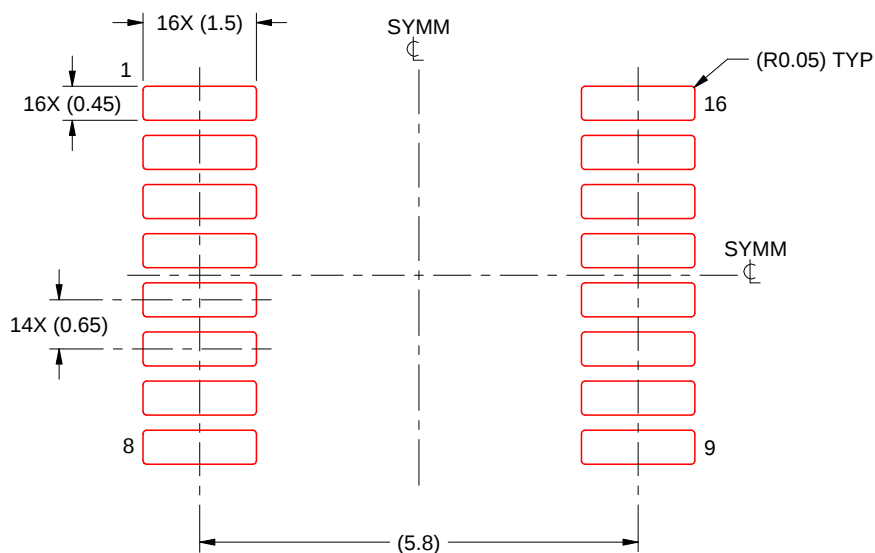
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

4220204/B 12/2023

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.



PACKAGE OUTLINE

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



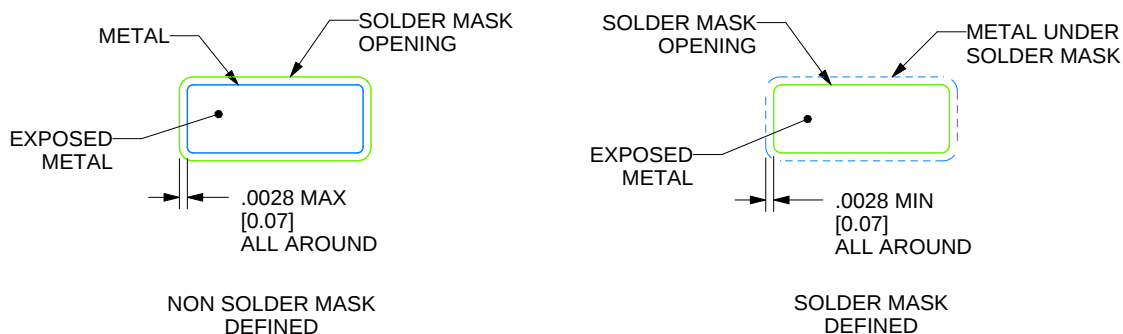
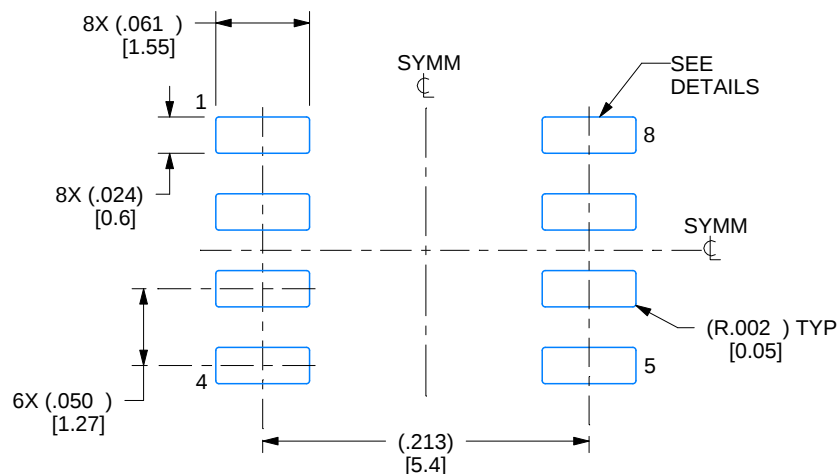
1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MS-012, variation AA.

EXAMPLE BOARD LAYOUT

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



4214825/C 02/2019

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

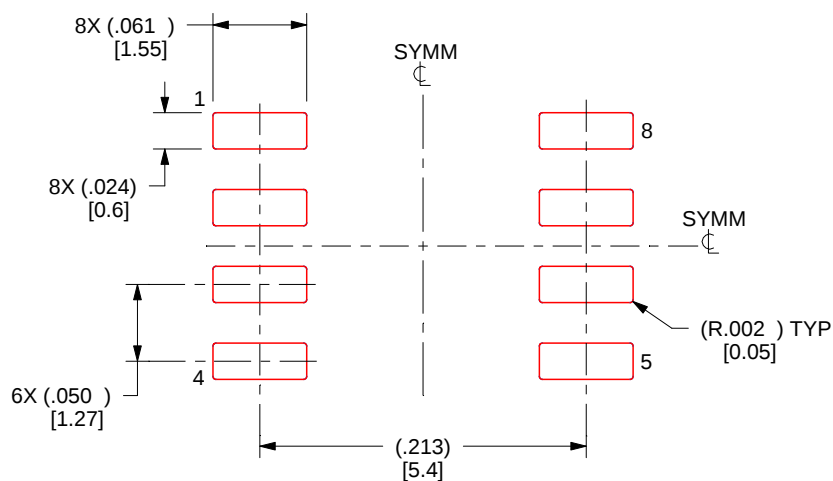
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE
BASED ON .005 INCH [0.125 MM] THICK STENCIL
SCALE:8X

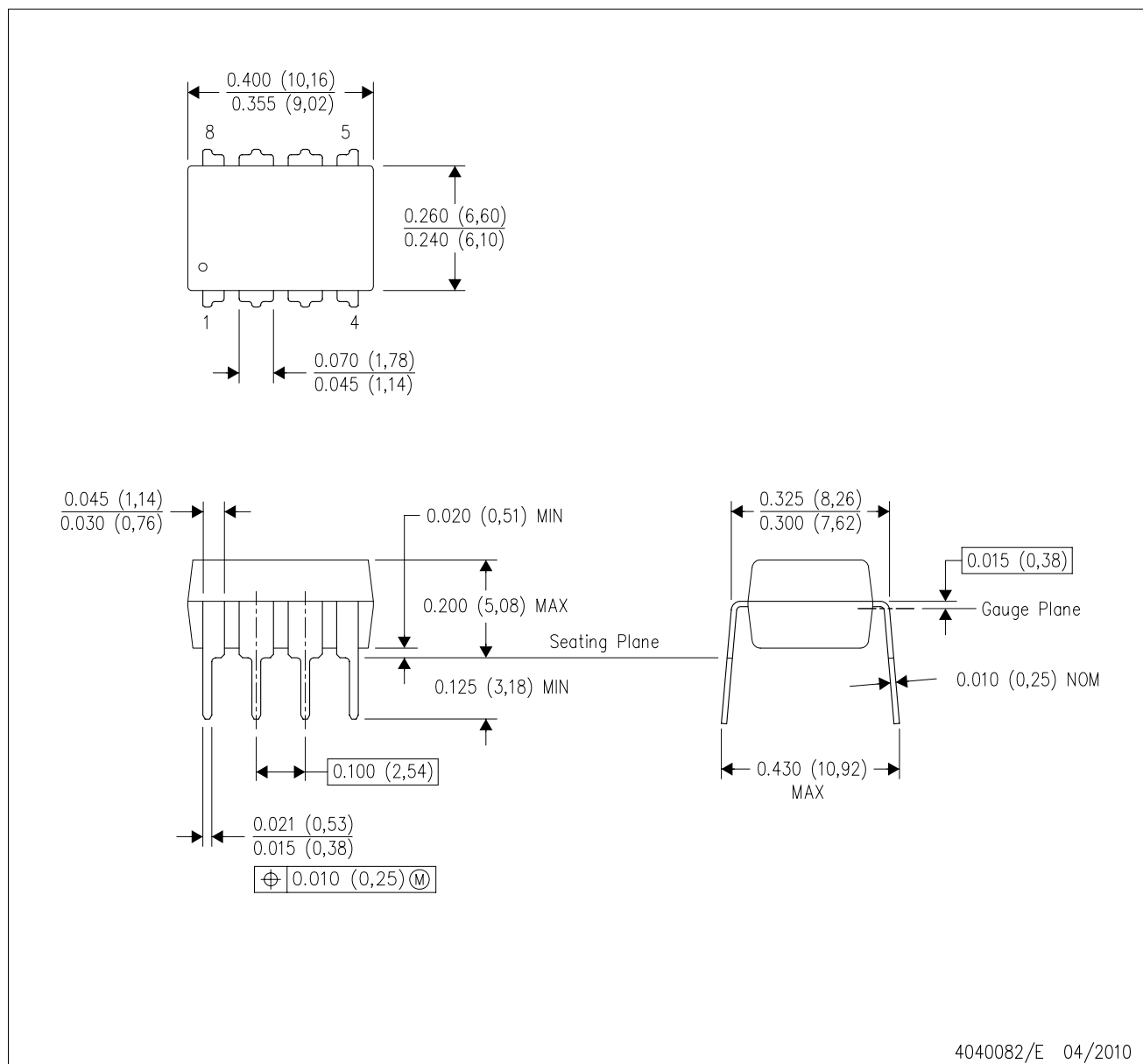
4214825/C 02/2019

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

P (R-PDIP-T8)

PLASTIC DUAL-IN-LINE PACKAGE

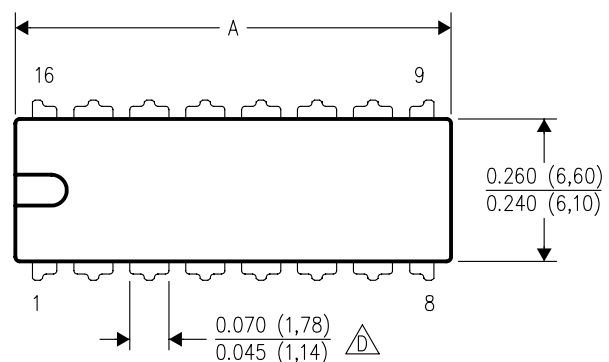


- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. Falls within JEDEC MS-001 variation BA.

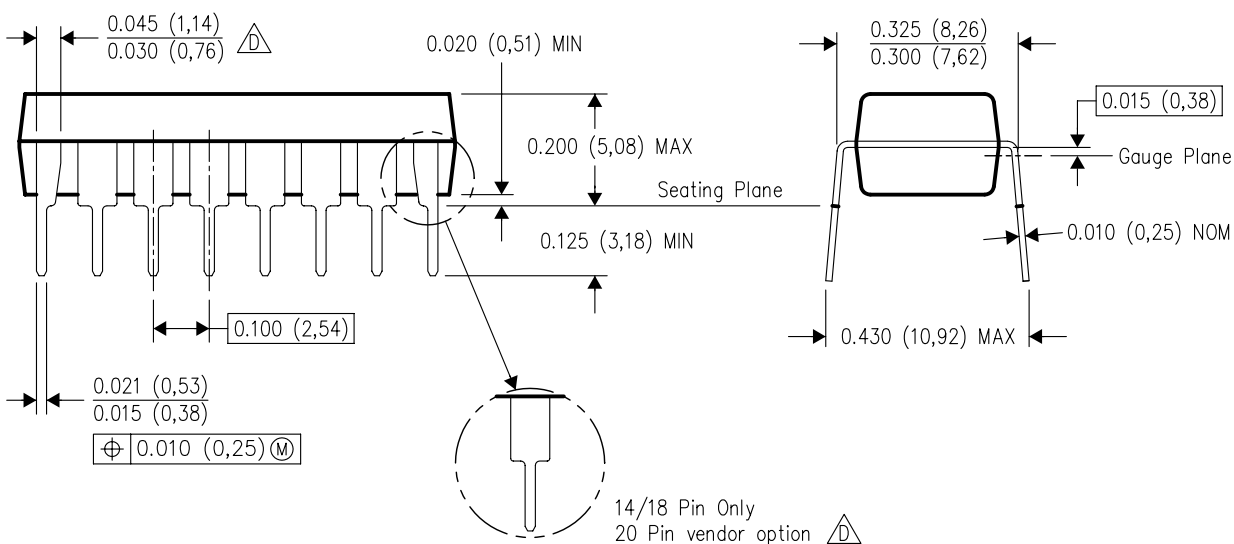
N (R-PDIP-T**)

16 PINS SHOWN

PLASTIC DUAL-IN-LINE PACKAGE



PINS ** DIM	14	16	18	20
A MAX	0.775 (19,69)	0.775 (19,69)	0.920 (23,37)	1.060 (26,92)
A MIN	0.745 (18,92)	0.745 (18,92)	0.850 (21,59)	0.940 (23,88)
MS-001 VARIATION	AA	BB	AC	AD



4040049/E 12/2002

NOTES:

- A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
-  Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
 The 20 pin end lead shoulder width is a vendor option, either half or full width.

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